2139-22

School on Synchrotron and Free-Electron-Laser Sources and their Multidisciplinary Applications

26 April - 7 May, 2010

Surface, Interface, and Materials Studies Using Photoelectron Spectroscopy, Diffraction, and Holography

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Fuggle-Fonda School on Synchrotron Radiation and Applications

LECTURES FOR 30 APRIL AND 3 MAY, 2010

SURFACE, INTERFACE, AND MATERIALS STUDIES USING PHOTOELECTRON SPECTROSCOPY, DIFFRACTION, AND HOLOGRAPHY

Lecturers:

Chuck Fadley, Department of Physics, University of California, Davis &
Materials Sciences Division, Lawrence Berkeley National Laboratory, Berkeley, USA
Introduction to surface and interface science, vuv/soft x-ray spectroscopies, photoelectron spectroscopy/diffraction/holography, hard x-ray photoemission

Andrea Goldoni, Elettra, Trieste, Italy
Valence bands, dispersion, and Fermi surface mapping by photoemission, angle-resolved photoemission, many-body effects, complex materials, spin-resolved studies

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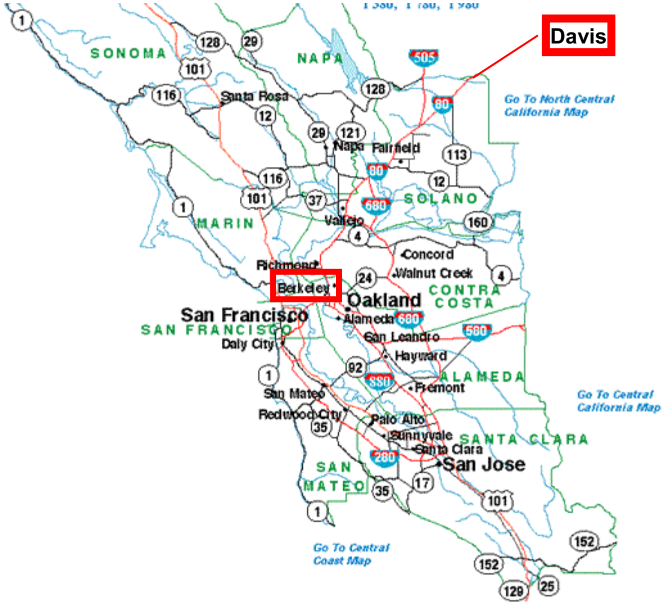

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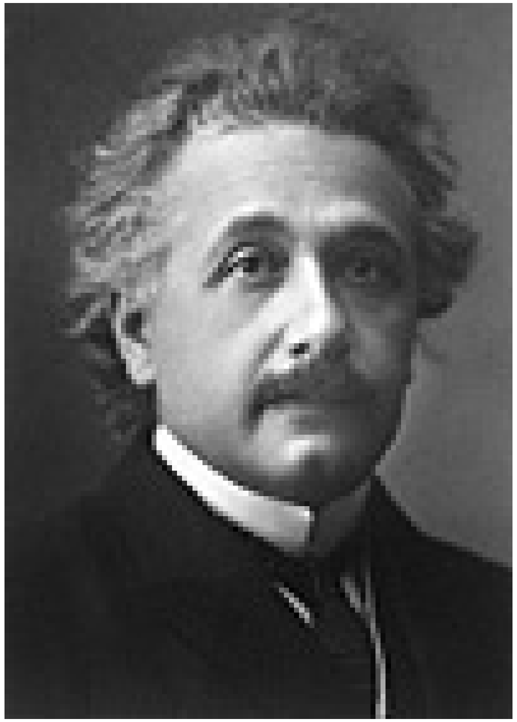
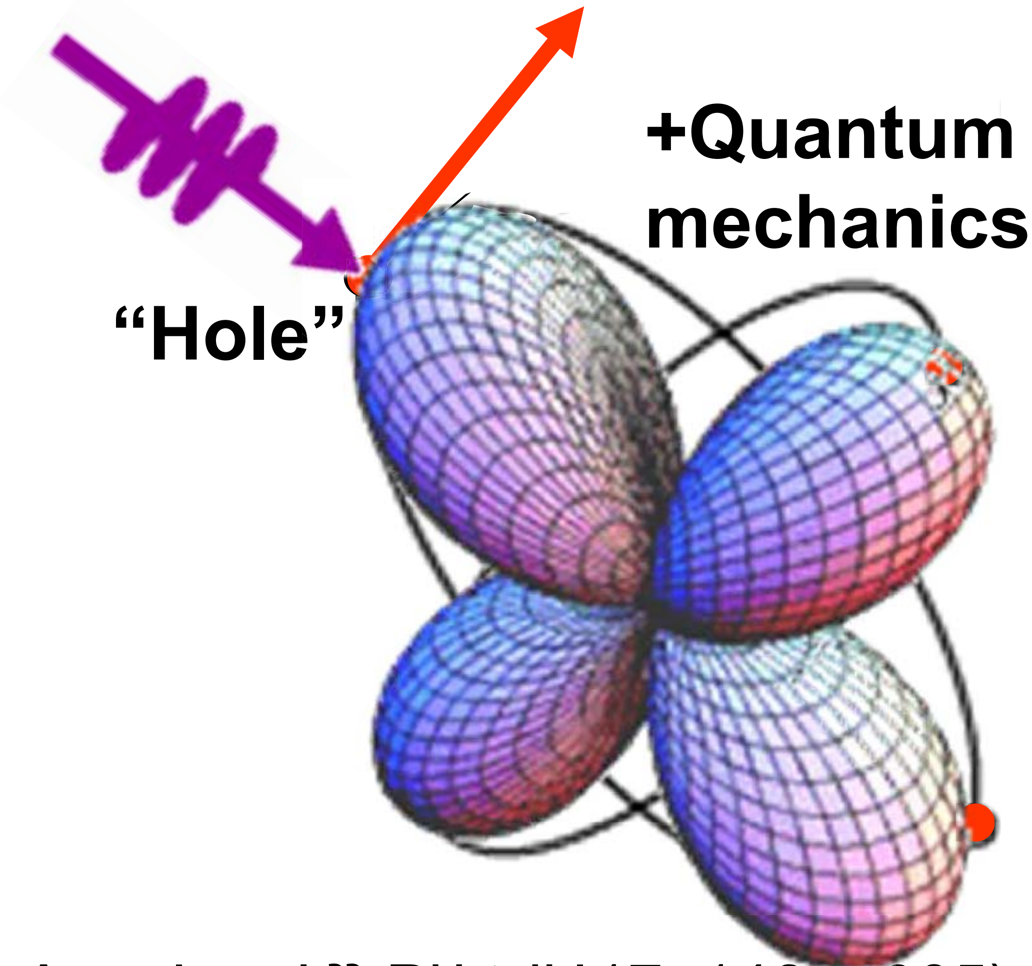
International Center for Theoretical Physics
April-May, 2010

With acknowledgments to:





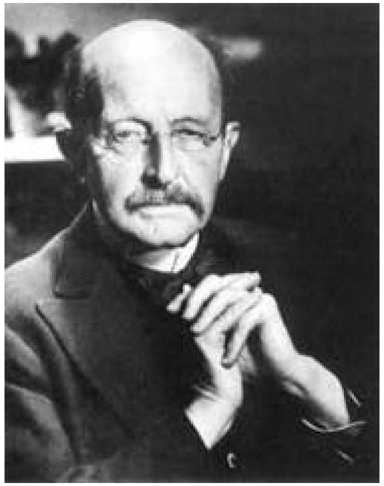
The photoelectric effect: Annalen der Physik 17, 146 (1905)

$$h\nu = E_{initial} - E_{final} = E_{binding} + E_{kinetic}$$

(Nobel Prize for it in1921– But no mention of it in his Nobel lecture)

"I would like to tell you how pleased I am that you have given up your light-quantum theory"

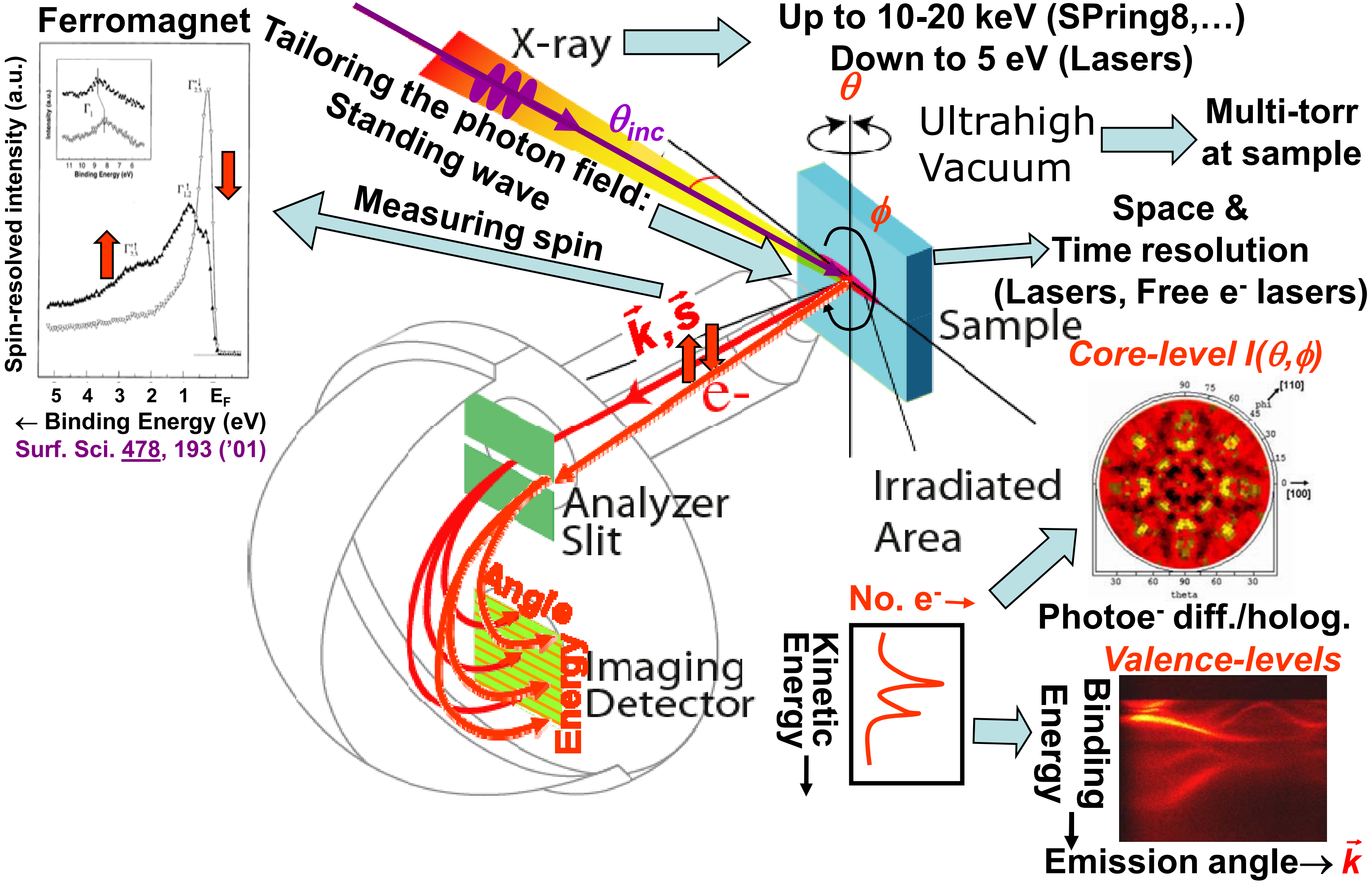
von Laue to Einstein, 1907 letter



In his 1913 letter nominating Einstein for the membership of Prussian Academy of Science, Max Planck et al. wrote:

- *"In sum, one can say there is hardly one among the great problems in which modern physics is so rich to which Einstein has not made a remarkable contribution. That he may sometimes has missed the target in his speculations, as, for example, in his hypothesis of light quanta, cannot really be held too much against him, for it is not possible to introduce really new ideas even in the most exact sciences without sometimes taking a risk."*

Typical experimental geometry for energy- and angle-resolved photoemission measurements



Surf. Sci. 478, 193 ('01)

Up to 10-20 keV (SPring8,…)
Down to 5 eV (Lasers)

Multi-torr at sample

Space & Time resolution (Lasers, Free e^- lasers)

Outline

Surface, interface, and nanoscience—short introduction

Some surface concepts and techniques→photoemission

Synchrotron radiation: experimental aspects

Electronic structure—a brief review

The basic synchrotron radiation techniques: more experimental and theoretical details

Valence-level photoemission

Core-level photoemission

Photoemission with high ambient pressure around the sample

SURFACE, INTERFACE, AND MATERIALS STUDIES USING PHOTOELECTRON SPECTROSCOPY, DIFFRACTION, HOLOGRAPHY, AND MICROSCOPY; (X-RAY FLUORESCENCE HOLOGRAPHY)

Chuck Fadley
Department of Physics, University of California-Davis, Davis, CA, &
Materials Sciences Division, Lawrence Berkeley National Laboratory, Berkeley, CA

---OUTLINE OF FADLEY LECTURES FOR 16 APRIL THROUGH 18 APRIL, 2008---

(With complementary coverage of related/additional material by Andrea Goldoni, Elettra)

References below are to papers handed out as in format: Paper [No.], section no. or page nos, or to other lectures in this School as appropriate. See also original literature references referred to directly on many slides.

• INTRODUCTION:

- **--Surface and interface phenomena*: ("Modern Techniques of Surface Science", D.P. Woodruff and T.A. Delchar, (Cambridge Univ. Press, 1994), 2nd Edition,; "Surface Physics", A. Zangwill (Cambridge Univ. Press, 1990))***
  - **What are they? Why study them?**
  - **Applications in technology: semiconductor ICs, spintronics, et al.**
  - **Nanoscience/nanotechnology**
  - **Ultrahigh vacuum**
  - **Some basic concepts and characterization techniques: TEM, LEED and STM**
  - **Electron escape and surface sensitivity**
  - **Typical experimental systems**
- **--Synchrotron radiation experiments: *(Other lectures in this School)***
  - **Basic considerations—brief review**
  - **X-ray emission and nomenclature**
  - **Synchrotron radiation**
  - **X-ray interactions with matter and basic techniques**
  - **Photoelectron spectroscopy = photoemission(PS, PES)**
  - **X-ray absorption spectroscopy (XAS, NEXAFS(=XANES) + EXAFS = XAFS *(Other lectures in this School)***
  - **X-ray emission/x-ray fluorescence spectroscopy (XES, XFS) and resonant inelastic x-ray scattering (RIXS)**
  - **X-ray scattering and diffraction (XRD, *other lectures in this School*)**
  - **X-ray optical measurements (refraction, reflection and penetration depth, Standing waves,…)**

• *ELECTRONIC STRUCTURE: (Zangwill book, Paper [1], Chap.III):*

Basics of electronic structure and bonding
Hartree Fock Method, Koopmans Theorem and corrections to it
The exchange interaction and magnetism
Atomic orbitals, spin-orbit splitting
Molecular orbitals
Electrons in solids, bands

• *THE BASIC SR SPECTROSCOPIES—MORE EXPERIMENTAL AND THEORETICAL DETAILS: (Paper [1], Chaps.I and III, Paper [15])*

Photoelectron spectroscopy (PES, PS, XPS)
Auger electron spectroscopy (AES)
X-ray absorption spectroscopy (XAS, NEXAFS, XANES)
X-ray emission and resonant inelastic scattering (XES, RIXS)
Instrumentation for PES
Spectrometers and detectors
Electron spin detection
Measuring electron kinetic and binding energies:
  Work function, inner potential
  Sample charging

•*CORE-LEVEL SPECTROSCOPY (PART 1):*

- --Core intensities (the 3-step model) and quantitative surface analysis:
  (Papers [1], Chap. VI, Paper [2],1-4, Papers [15] and [16])
  - Quantitative formulas for surface analysis
  - Surface sensitivity enhancement at grazing emission
- --Differential photoelectric cross sections and selection rules
  - Basic forms and tabulations
  - Cooper minima
  - Resonant photoemission:
    - Intraatomic single atom resonant photoemission (RPE, SARPE)--
      Well known
    - Interatomic multi-atom resonant photoemission (MARPE)--
      a new effect in molecules, solids *(Paper [8])*
  - Non-dipole effects at higher energies
- --Inelastic attenuation length tabulations and estimates
- --Elastic scattering effects in surface analysis
- --Electron refraction in escape from surface

• *PHOTOELECTRON DIFFRACTION (CORE LEVELS):*

(Papers [1], D; [2], 5; [3]-[5], [15], [16])

- --Basic diffraction and measurement process: scanned-angle and scanned-energy
- --Energy dependence of scattering:
  - Forward-dominated at high energies
  - Back and forward at low energies
- --Basic theory:
  - Scattering factors: plane-wave and spherical-wave
  - Vibrational effects and Debye-Waller factors
- --Determination of structures from:
  - Forward scattering peaks—adsorbed molecules
  - More complex diffraction patterns
    - (incl. full-solid -angle data and R-factor analysis)
  - Analysis via single-scattering and multiple scattering theory--review of theoretical approaches and computer exercises for those interested *(Paper [9] plus program EDAC discussed in lecture and exercises)*
- --Fingerprint diffraction patterns
- --Some example applications: adsorbates, clean surface core-level shifts, epitaxial overlayers, Moiré structures, time-dependent surface reactions
- --Fourier transforms of scanned-energy data: path-length differences

• *PHOTOELECTRON HOLOGRAPHY:*

(Papers [3], 5.4; [4], 5.3; [5]; [6]; [7];[11]; [15])

- --Basic process of hologram formation and image reconstruction:
  - ~a Fourier-like transform of several types
- --Applications in single-energy and multiple-energy form to adsorbates and multilayer substrates
- --Comparison of methods, including new approaches

- ***VALENCE-LEVEL SPECTROSCOPY: (Paper [15], and Goldoni lectures)***
    - **--The low-energy (UPS) limit: *(Goldoni lectures)***
        - **Selection rules on wave vector**
        - **Band-structure mapping**
        - **Fermi-surface mapping**
    - **--Vibrational/phonon effects: UPS⇔XPS limits *(Paper [2], [6], [14], [15], [16])***
    - **--The high-energy (XPS) limit*: (Papers [2], [6], [15], [16])***
        - **Density-of-states measurements**
    - **--Hard x-ray photoemission in the 5-15 keV range: a new direction *(Papers [14], [16])***

- ***CORE-LEVEL SPECTROSCOPY (PART 2):***
    - **--X-ray optical effects: resonant and non-resonant, standing waves *(Papers [12], [13], [15],***
    - **--Probing buried interfaces with soft x-ray standing waves *(Paper [12])***
    - **--Chemical shifts in core binding energies *(Paper [1], Chap. IV)***
        - ***Potential model***
        - **Equivalent-core approx. and relationship to thermochemical energies**
    - **--Multiplet splittings & spin-polarized spectra *(Paper [1], Chap. V, A-D)***
        - **Spin-polarized photoelectron diffraction and holography**
    - **--Spin polarization via spin-orbit-split levels excited with circular polarized Radiation—the Fano effect**
    - **--Magnetic circular dichroism in core photoemission**
    - **--Non-magnetic circular dichroism in core photoemission (circular dichroism in angular distributions--CDAD)**
    - **--Shake-up/shake-off and Sudden Approx. sum rules**
    - **--Final-state screening and relaxation effects, satellites *(Paper [1], Chap. V, A-D)***
    - **--Vibrational effects in spectra *(Paper [1], Chap. V, E)***

- ***PHOTOEMISSION WITH A HIGH AMBIENT PRESSURE AT THE SAMPLE::***

General references on various aspects of photoelectron spectroscopy, diffraction, holography (available at School website):

Paper [1] "Basic Concepts of X-ray Photoelectron Spectroscopy", C.S.F, in Electron Spectroscopy, Theory, Techniques, and Applications, Brundle and Baker, Eds. (Pergamon Press, 1978) Vol. II, Ch. 1.

Paper [2] "Angle-Resolved X-ray Photoelectron Spectroscopy", C.S.F., Progress in Surface Science 16, 275 (1984).

Paper [3] "The Study of Surface Structures by Photoelectron Diffraction and Auger Electron Diffraction", C.S.F., in Synchrotron Radiation Research: Advances in Surface and Interface Science, Bachrach, Ed. (Plenum,1992)

Paper [4] “Photoelectron Diffraction: New Dimensions in Space, Time, and Spin”, C.S. Fadley, M.A. Van Hove, Z. Hussain, and A.P. Kaduwela, J. Electron Spectrosc. 75, 273, (1995).

Paper [5] "Diffraction and Holography with Photoelectrons and Fluorescent X-Rays", C. S. Fadley et al., Progress in Surface Science 54, 341 (1997).

Paper [6] "Atomic Holography with Electrons and X-rays", P.M. Len, C.S. Fadley, and G. Materlik, invited paper appearing in X-ray and Inner-Shell Processes: 17th International Conference, R.L. Johnson, H. Schmidt-Böcking, and B.F. Sonntag, Eds., American Institute of Physics Conference Proceedings, No. 389 (AIP, New York, 1997) pp. 295-319.

Paper [7] “Theoretical Aspects of Electron Emission Holography”, L. Fonda, Phys. Stat. Sol. (b) 188, 599 (1995). (Theoretical study by founder of this school.)

Paper [8] "Multi-Atom Resonant Photoemission", A.W. Kay, F.J. Garcia de Abajo, S.-H. Yang, E. Arenholz, B.S. Mun, N. Mannella, Z. Hussain, M.A. Van Hove, and C.S. Fadley, Physical Review B 63, 115119 (2001).

Paper [9] "Multiple Scattering of Electrons in Solids and Molecules: a Novel Cluster-Model Approach", F. J. Garcia de Abajo, C.S. Fadley, and M.A. Van Hove, Physical Review B63, 075404 (2001). (Paper describing the new "EDAC" multiple scattering program available for online usage at http://maxwell.optica.csic.es/software/edac/a.html in course tutorials and for anyone wishing to try it at home. See also downloadable "MSCD" program at http://electron.lbl.gov/~mscd/.)

Paper [10] "Fermi Surface Mapping by Angle-Resolved Photoemission", J. Osterwalder, Surface Review and Letters 4, 391 (1997). (Covered in greater detail in Osterwalder lectures.)

Paper [11] "Photoelectron and X-ray Holography by Contrast: Enhancing Image Quality and Dimensionality", C.S. Fadley, M.A. Van Hove, A. Kaduwela, S. Omori, L. Zhao, and S. Marchesini, J. Phys. Cond. Mat. 13, 10517 (2001).

Paper [12] “Probing Multilayer Spintronic Structures with Photoelectron and X-Ray Emission Spectroscopies Excited by X-Ray Standing Waves”, S.-H. Yang, B.C. Sell, and C. S. Fadley, J. Appl. Phys. 103, 07C519 (2008)

Paper [13] "X-ray Optics, Standing Waves, and Interatomic Effects in Photoemission and X-ray Emission", C. S. Fadley, S.-H. Yang, B. S. Mun, J. Garcia de Abajo, invited Chapter in the book "Solid-State Photoemission and Related Methods: Theory and Experiment", W. Schattke and M.A. Van Hove, Editors, (Wiley-VCH Verlag, Berlin GmbH, 2003), ISBN: 3527403345, 38 pp., 17 figs.

Paper [14] “X-Ray Photoelectron Spectroscopy and Diffraction in The Hard X-Ray Regime: Fundamental Considerations and Future Possibilities”, C. S. Fadley, Nuclear Instruments and Methods A 547, 24-41 (2005), special issue edited by J. Zegenhagen and C. Kunz.

Paper [15] “Atomic-Level Characterization of Materials with Core- and Valence-Level Photoemission: Basic Phenomena and Future Directions”, C.S. Fadley, Surf. Interface Anal. 2008, 40, 1579–1605.

Paper [16] “X-ray photoelectron spectroscopy: Progress and perspectives”
C.S. Fadley, Journal of Electron Spectroscopy and Related Phenomena 178–179 (2010) 2–32

Key Reference [17] “X-ray Data Booklet”, Center for X-Ray Optics and the Advanced Light Source, LBNL, January, 2001, available online at: http://xdb.lbl.gov/

Additional very useful websites:

X-ray optical calculations: reflectivities, penetration depths for a variety of mirror/surface geometries—
http://www-cxro.lbl.gov/optical_constants/

General properties of the elements and their compounds: http://www.webelements.com

Calculation of photoelectron diffraction with program EDAC:
http://maxwell.optica.csic.es/software/edac/a.html

[17]

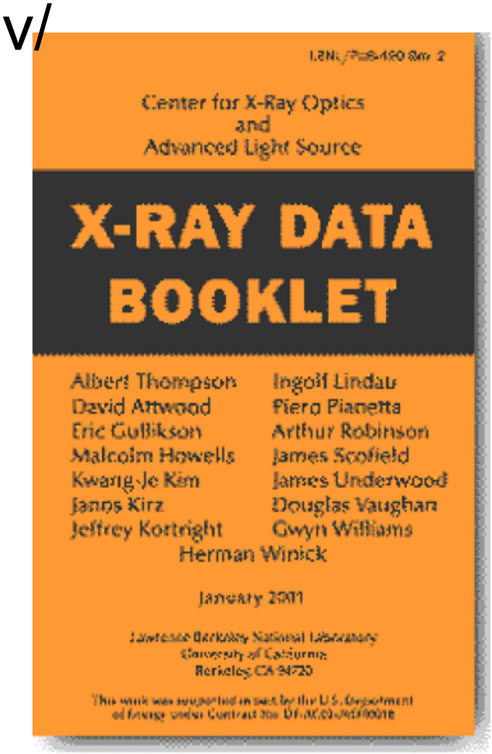
X-RAY DATA BOOKLET

Center for X-ray Optics and Advanced Light Source

Lawrence Berkeley National Laboratory

http://xdb.lbl.gov/

- Introduction
- X-Ray Properties of Elements
  - Electron Binding Energies
  - X-Ray Energy Emission Energies
  - Fluorescence Yields for K and L Shells
  - Principal Auger Electron Energies
  - Subshell Photoionization Cross-Sections
  - Mass Absorption Coefficients
  - Atomic Scattering Factors
  - Energy Levels of Few Electron Ions
  - Periodic Table of X-Ray Properties
- Synchrotron Radiation
  - Characteristics of Synchrotron Radiation
  - History of X-rays and Synchrotron Radiation
  - Synchrotron Facilities
- Scattering Processes
  - Scattering of X-rays from Electrons and Atoms
  - Low-Energy Electron Ranges in Matter
- Optics and Detectors
  - Crystal and Multilayer Elements
  - Specular Reflectivities for Grazing-Incidence Mirrors
  - Gratings and Monochromators
  - Zone Plates
  - X-Ray Detectors
- Miscellaneous
  - Physical Constants
  - Physical Properties of the Elements
  - Electromagnetic Relations
  - Radioactivity and Radiation Protection
  - Useful Formulas



Center for X-Ray Optics
and
Advanced Light Source

X-RAY DATA
BOOKLET

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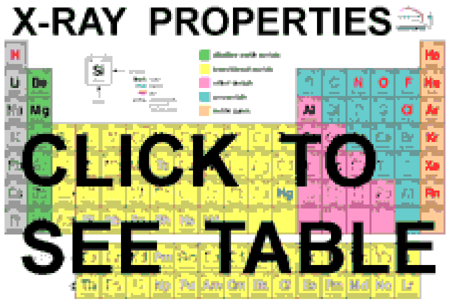


Periodic Table, with the Outer Electron Configurations of Neutral Atoms in Their Ground States

The notation used to describe the electronic configuration of atoms and ions is discussed in all textbooks of introductory atomic physics. The letters *s*, *p*, *d*, . . . signify electrons having orbital angular momentum 0, 1, 2, . . . in units ħ; the number to the left of the letter denotes the principal quantum number of one orbit, and the superscript to the right denotes the number of electrons in the orbit.

H^{1} $1s$																	**He**^{2} $1s^2$
Li^{3} $2s$	**Be**^{4} $2s^2$											**B**^{5} $2s^22p$	**C**^{6} $2s^22p^2$	**N**^{7} $2s^22p^3$	**O**^{8} $2s^22p^4$	**F**^{9} $2s^22p^5$	**Ne**^{10} $2s^22p^6$
Na^{11} $3s$	**Mg**^{12} $3s^2$											**Al**^{13} $3s^23p$	**Si**^{14} $3s^23p^2$	**P**^{15} $3s^23p^3$	**S**^{16} $3s^23p^4$	**Cl**^{17} $3s^23p^5$	**Ar**^{18} $3s^23p^6$
K^{19} $4s$	**Ca**^{20} $4s^2$	**Sc**^{21} $3d$ $4s^2$	**Ti**^{22} $3d^2$ $4s^2$	**V**^{23} $3d^3$ $4s^2$	**Cr**^{24} $3d^5$ $4s$	**Mn**^{25} $3d^5$ $4s^2$	**Fe**^{26} $3d^6$ $4s^2$	**Co**^{27} $3d^7$ $4s^2$	**Ni**^{28} $3d^8$ $4s^2$	**Cu**^{29} $3d^{10}$ $4s$	**Zn**^{30} $3d^{10}$ $4s^2$	**Ga**^{31} $4s^24p$	**Ge**^{32} $4s^24p^2$	**As**^{33} $4s^24p^3$	**Se**^{34} $4s^24p^4$	**Br**^{35} $4s^24p^5$	**Kr**^{36} $4s^24p^6$
Rb^{37} $5s$	**Sr**^{38} $5s^2$	**Y**^{39} $4d$ $5s^2$	**Zr**^{40} $4d^2$ $5s^2$	**Nb**^{41} $4d^4$ $5s$	**Mo**^{42} $4d^5$ $5s$	**Tc**^{43} $4d^6$ $5s$	**Ru**^{44} $4d^7$ $5s$	**Rh**^{45} $4d^8$ $5s$	**Pd**^{46} $4d^{10}$ –	**Ag**^{47} $4d^{10}$ $5s$	**Cd**^{48} $4d^{10}$ $5s^2$	**In**^{49} $5s^25p$	**Sn**^{50} $5s^25p^2$	**Sb**^{51} $5s^25p^3$	**Te**^{52} $5s^25p^4$	**I**^{53} $5s^25p^5$	**Xe**^{54} $5s^25p^6$
Cs^{55} $6s$	**Ba**^{56} $6s^2$	**La**^{57} $5d$ $6s^2$	**Hf**^{72} $4f^{14}$ $5d^2$ $6s^2$	**Ta**^{73} $5d^3$ $6s^2$	**W**^{74} $5d^4$ $6s^2$	**Re**^{75} $5d^5$ $6s^2$	**Os**^{76} $5d^6$ $6s^2$	**Ir**^{77} $5d^9$ –	**Pt**^{78} $5d^9$ $6s$	**Au**^{79} $5d^{10}$ $6s$	**Hg**^{80} $5d^{10}$ $6s^2$	**Tl**^{81} $6s^26p$	**Pb**^{82} $6s^26p^2$	**Bi**^{83} $6s^26p^3$	**Po**^{84} $6s^26p^4$	**At**^{85} $6s^26p^5$	**Rn**^{86} $6s^26p^6$
Fr^{87} $7s$	**Ra**^{88} $7s^2$	**Ac**^{89} $6d$ $7s^2$															
			Ce^{58} $4f^2$ $6s^2$	**Pr**^{59} $4f^3$ $6s^2$	**Nd**^{60} $4f^4$ $6s^2$	**Pm**^{61} $4f^5$ $6s^2$	**Sm**^{62} $4f^6$ $6s^2$	**Eu**^{63} $4f^7$ $6s^2$	**Gd**^{64} $4f^7$ $5d$ $6s^2$	**Tb**^{65} $4f^8$ $5d$ $6s^2$	**Dy**^{66} $4f^{10}$ $6s^2$	**Ho**^{67} $4f^{11}$ $6s^2$	**Er**^{68} $4f^{12}$ $6s^2$	**Tm**^{69} $4f^{13}$ $6s^2$	**Yb**^{70} $4f^{14}$ $6s^2$	**Lu**^{71} $4f^{14}$ $5d$ $6s^2$	
			Th^{90} – $6d^2$ $7s^2$	**Pa**^{91} $5f^2$ $6d$ $7s^2$	**U**^{92} $5f^3$ $6d$ $7s^2$	**Np**^{93} $5f^5$ $7s^2$	**Pu**^{94} $5f^6$ $7s^2$	**Am**^{95} $5f^7$ $7s^2$	**Cm**^{96} $5f^7$ $6d$ $7s^2$	**Bk**^{97}	**Cf**^{98}	**Es**^{99}	**Fm**^{100}	**Md**^{101}	**No**^{102}	**Lr**^{103}	

Table 3 Crystal structures of the elements

The data given are at room temperature for the most common form, or at the stated temperature in deg K. For further descriptions of the elements see Wyckoff, Vol. 1, Chap. 2. Structures labeled complex are described there.

← Crystal structure →
← *a* lattice parameter, in Å →
← *c* lattice parameter, in Å →

H^1 4K hcp 3.75 6.12																	**He^4** 2K hcp 3.57 5.83
Li 78K bcc 3.491	**Be** hcp 2.27 3.59											**B** rhomb.	**C** diamond 3.567	**N** 20K cubic 5.66 (N_2)	**O** complex (O_2)	**F**	**Ne** 4K fcc 4.46
Na 5K bcc 4.225	**Mg** hcp 3.21 5.21											**Al** fcc 4.05	**Si** diamond 5.430	**P** complex	**S** complex	**Cl** complex (Cl_2)	**Ar** 4K fcc 5.31
K 5K bcc 5.225	**Ca** fcc 5.58	**Sc** hcp 3.31 5.27	**Ti** hcp 2.95 4.68	**V** bcc 3.03	**Cr** bcc 2.88	**Mn** cubic complex	**Fe** bcc 2.87	**Co** hcp 2.51 4.07	**Ni** fcc 3.52	**Cu** fcc 3.61	**Zn** hcp 2.66 4.95	**Ga** complex	**Ge** diamond 5.658	**As** rhomb.	**Se** hex. chains	**Br** complex (Br_2)	**Kr** 4K fcc 5.64
Rb 5K bcc 5.585	**Sr** fcc 6.08	**Y** hcp 3.65 5.73	**Zr** hcp 3.23 5.15	**Nb** bcc 3.30	**Mo** bcc 3.15	**Tc** hcp 2.74 4.40	**Ru** hcp 2.71 4.28	**Rh** fcc 3.80	**Pd** fcc 3.89	**Ag** fcc 4.09	**Cd** hcp 2.98 5.62	**In** tetr. 3.25 4.95	**Sn** (α) diamond 6.49	**Sb** rhomb.	**Te** hex. chains	**I** complex (I_2)	**Xe** 4K fcc 6.13
Cs 5K bcc 6.045	**Ba** bcc 5.02	**La** hex. 3.77 *ABAC*	**Hf** hcp 3.19 5.05	**Ta** bcc 3.30	**W** bcc 3.16	**Re** hcp 2.76 4.46	**Os** hcp 2.74 4.32	**Ir** fcc 3.84	**Pt** fcc 3.92	**Au** fcc 4.08	**Hg** rhomb.	**Tl** hcp 3.46 5.52	**Pb** fcc 4.95	**Bi** rhomb.	**Po** sc 3.34	**At** —	**Rn** —
Fr —	**Ra** —	**Ac** fcc 5.31															

Ce fcc 5.16	**Pr** hex. 3.67 *ABAC*	**Nd** hex. 3.66	**Pm** —	**Sm** complex	**Eu** bcc 4.58	**Gd** hcp 3.63 5.78	**Tb** hcp 3.60 5.70	**Dy** hcp 3.59 5.65	**Ho** hcp 3.58 5.62	**Er** hcp 3.56 5.59	**Tm** hcp 3.54 5.56	**Yb** fcc 5.48	**Lu** hcp 3.50 5.55
Th fcc 5.08	**Pa** tetr. 3.92 3.24	**U** complex	**Np** complex	**Pu** complex	**Am** hex. 3.64 *ABAC*	**Cm** —	**Bk** —	**Cf** —	**Es** —	**Fm** —	**Md** —	**No** —	**Lr** —

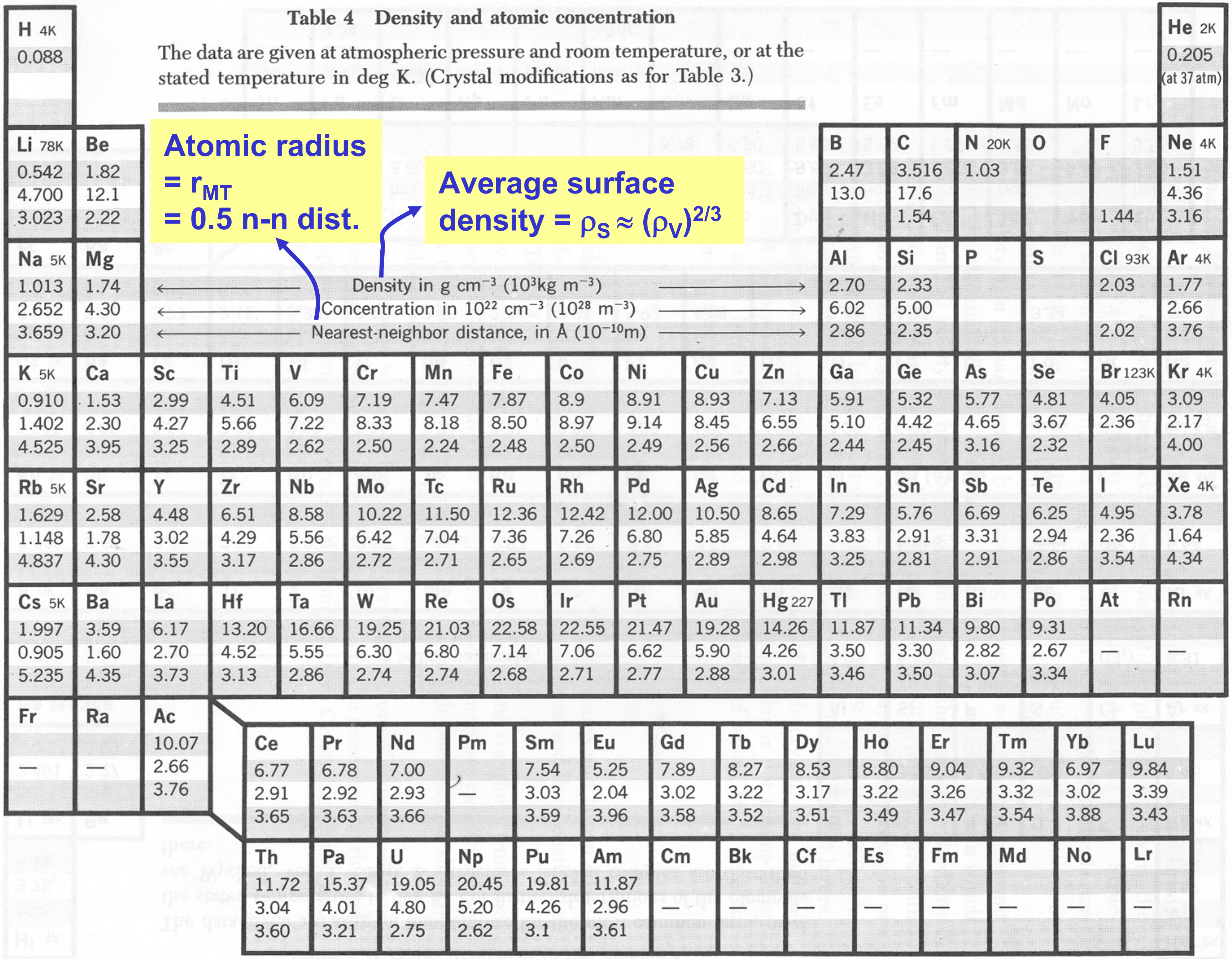


Table 4 Density and atomic concentration

The data are given at atmospheric pressure and room temperature, or at the stated temperature in deg K. (Crystal modifications as for Table 3.)

Atomic radius
= r_{MT}
= 0.5 n-n dist.

Average surface density = $\rho_S \approx (\rho_V)^{2/3}$

← Density in g cm^{-3} (10^3kg m^{-3}) →
← Concentration in 10^{22} cm^{-3} (10^{28} m^{-3}) →
← Nearest-neighbor distance, in Å (10^{-10}m) →

H 4K 0.088																	**He** 2K 0.205 (at 37 atm)
Li 78K 0.542 4.700 3.023	**Be** 1.82 12.1 2.22											**B** 2.47 13.0	**C** 3.516 17.6 1.54	**N** 20K 1.03	**O**	**F** 1.44	**Ne** 4K 1.51 4.36 3.16
Na 5K 1.013 2.652 3.659	**Mg** 1.74 4.30 3.20											**Al** 2.70 6.02 2.86	**Si** 2.33 5.00 2.35	**P**	**S**	**Cl** 93K 2.03 2.02	**Ar** 4K 1.77 2.66 3.76
K 5K 0.910 1.402 4.525	**Ca** 1.53 2.30 3.95	**Sc** 2.99 4.27 3.25	**Ti** 4.51 5.66 2.89	**V** 6.09 7.22 2.62	**Cr** 7.19 8.33 2.50	**Mn** 7.47 8.18 2.24	**Fe** 7.87 8.50 2.48	**Co** 8.9 8.97 2.50	**Ni** 8.91 9.14 2.49	**Cu** 8.93 8.45 2.56	**Zn** 7.13 6.55 2.66	**Ga** 5.91 5.10 2.44	**Ge** 5.32 4.42 2.45	**As** 5.77 4.65 3.16	**Se** 4.81 3.67 2.32	**Br** 123K 4.05 2.36	**Kr** 4K 3.09 2.17 4.00
Rb 5K 1.629 1.148 4.837	**Sr** 2.58 1.78 4.30	**Y** 4.48 3.02 3.55	**Zr** 6.51 4.29 3.17	**Nb** 8.58 5.56 2.86	**Mo** 10.22 6.42 2.72	**Tc** 11.50 7.04 2.71	**Ru** 12.36 7.36 2.65	**Rh** 12.42 7.26 2.69	**Pd** 12.00 6.80 2.75	**Ag** 10.50 5.85 2.89	**Cd** 8.65 4.64 2.98	**In** 7.29 3.83 3.25	**Sn** 5.76 2.91 2.81	**Sb** 6.69 3.31 2.91	**Te** 6.25 2.94 2.86	**I** 4.95 2.36 3.54	**Xe** 4K 3.78 1.64 4.34
Cs 5K 1.997 0.905 5.235	**Ba** 3.59 1.60 4.35	**La** 6.17 2.70 3.73	**Hf** 13.20 4.52 3.13	**Ta** 16.66 5.55 2.86	**W** 19.25 6.30 2.74	**Re** 21.03 6.80 2.74	**Os** 22.58 7.14 2.68	**Ir** 22.55 7.06 2.71	**Pt** 21.47 6.62 2.77	**Au** 19.28 5.90 2.88	**Hg** 227 14.26 4.26 3.01	**Tl** 11.87 3.50 3.46	**Pb** 11.34 3.30 3.50	**Bi** 9.80 2.82 3.07	**Po** 9.31 2.67 3.34	**At** —	**Rn** —
Fr —	**Ra** —	**Ac** 10.07 2.66 3.76															
			Ce 6.77 2.91 3.65	**Pr** 6.78 2.92 3.63	**Nd** 7.00 2.93 3.66	**Pm** —	**Sm** 7.54 3.03 3.59	**Eu** 5.25 2.04 3.96	**Gd** 7.89 3.02 3.58	**Tb** 8.27 3.22 3.52	**Dy** 8.53 3.17 3.51	**Ho** 8.80 3.22 3.49	**Er** 9.04 3.26 3.47	**Tm** 9.32 3.32 3.54	**Yb** 6.97 3.02 3.88	**Lu** 9.84 3.39 3.43	
			Th 11.72 3.04 3.60	**Pa** 15.37 4.01 3.21	**U** 19.05 4.80 2.75	**Np** 20.45 5.20 2.62	**Pu** 19.81 4.26 3.1	**Am** 11.87 2.96 3.61	**Cm** —	**Bk** —	**Cf** —	**Es** —	**Fm** —	**Md** —	**No** —	**Lr** —	

Table 1 Debye temperature and thermal conductivity[a]

Low temperature limit of θ, in Kelvin
Thermal conductivity at 300 K, in W $\mathrm{cm^{-1}K^{-1}}$

Li 344 0.85	**Be** 1440 2.00											**B** 0.27	**C** 2230 1.29	**N**	**O**	**F**	**Ne** 75
Na 158 1.41	**Mg** 400 1.56											**Al** 428 2.37	**Si** 645 1.48	**P**	**S**	**Cl**	**Ar** 92
K 91 1.02	**Ca** 230	**Sc** 360. 0.16	**Ti** 420 0.22	**V** 380 0.31	**Cr** 630 0.94	**Mn** 410 0.08	**Fe** 470 0.80	**Co** 445 1.00	**Ni** 450 0.91	**Cu** 343 4.01	**Zn** 327 1.16	**Ga** 320 0.41	**Ge** 374 0.60	**As** 282 0.50	**Se** 90 0.02	**Br**	**Kr** 72
Rb 56 0.58	**Sr** 147	**Y** 280 0.17	**Zr** 291 0.23	**Nb** 275 0.54	**Mo** 450 1.38	**Tc** 0.51	**Ru** 600 1.17	**Rh** 480 1.50	**Pd** 274 0.72	**Ag** 225 4.29	**Cd** 209 0.97	**In** 108 0.82	**Sn** *w* 200 0.67	**Sb** 211 0.24	**Te** 153 0.02	**I**	**Xe** 64
Cs 38 0.36	**Ba** 110	**La** β 142 0.14	**Hf** 252 0.23	**Ta** 240 0.58	**W** 400 1.74	**Re** 430 0.48	**Os** 500 0.88	**Ir** 420 1.47	**Pt** 240 0.72	**Au** 165 3.17	**Hg** 71.9	**Tl** 78.5 0.46	**Pb** 105 0.35	**Bi** 119 0.08	**Po**	**At**	**Rn**
Fr	**Ra**	**Ac**															
			Ce 0.11	**Pr** 0.12	**Nd** 0.16	**Pm**	**Sm** 0.13	**Eu**	**Gd** 200 0.11	**Tb** 0.11	**Dy** 210 0.11	**Ho** 0.16	**Er** 0.14	**Tm** 0.17	**Yb** 120 0.35	**Lu** 210 0.16	
			Th 163 0.54	**Pa**	**U** 207 0.28	**Np** 0.06	**Pu** 0.07	**Am**	**Cm**	**Bk**	**Cf**	**Es**	**Fm**	**Md**	**No**	**Lr**	

---

[a] Most of the θ values were supplied by N. Pearlman; references are given the *A.I.P. Handbook*, 3rd ed; the thermal conductivity values are from R. W. Powell and Y. S. Touloukian, Science **181**, 999 (1973).

Outline

➡ Surface, interface, and nanoscience—short introduction

Some surface concepts and techniques→photoemission

Synchrotron radiation: experimental aspects

Electronic structure—a brief review

The basic synchrotron radiation techniques:
more experimental and theoretical details

Valence-level photoemission

Core-level photoemission

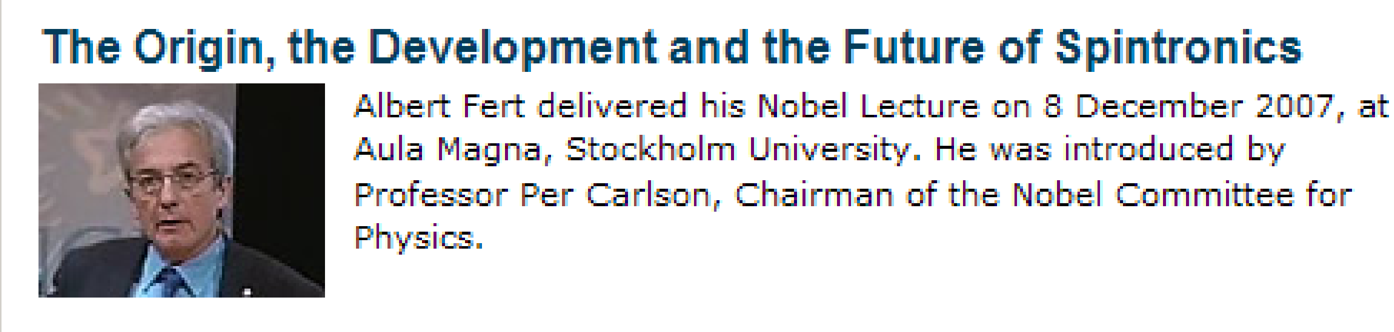
Photoemission with high ambient pressure
around the sample

- *Why surfaces, interfaces, structures at the nanometer scale?*
  1 nm = 10 Å = 0.001 micron
  Cube of 1 nm sides has 75% of its atoms on the surface
  → *Many areas of science/technology*

Nobel Prizes in Physics and Chemistry--2007

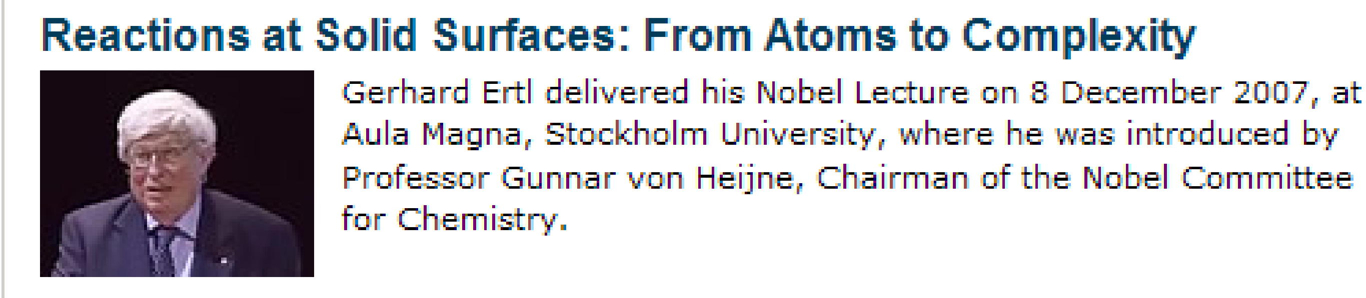
From Spinwaves to Giant Magnetoresistance (GMR) and Beyond

Peter Grünberg held his Nobel Lecture on 8 December 2007, at Aula Magna, Stockholm University. He was introduced by Professor Per Carlson, Chairman of the Nobel Committee for Physics.



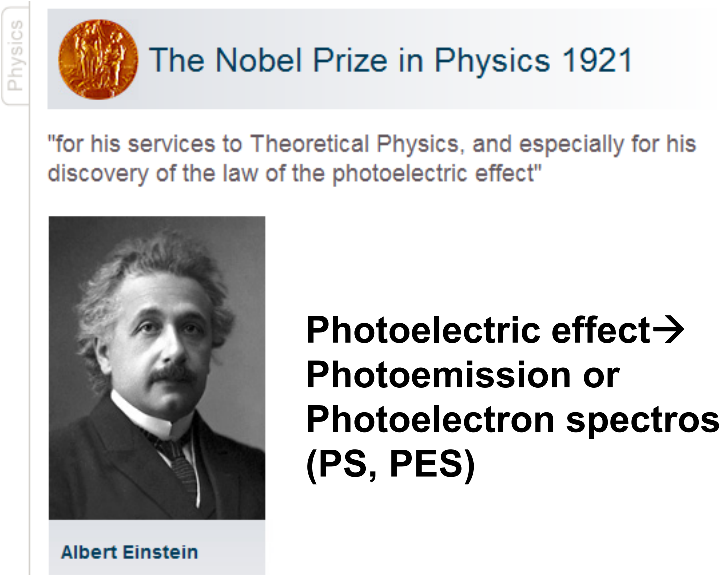
The Origin, the Development and the Future of Spintronics

Albert Fert delivered his Nobel Lecture on 8 December 2007, at Aula Magna, Stockholm University. He was introduced by Professor Per Carlson, Chairman of the Nobel Committee for Physics.



Reactions at Solid Surfaces: From Atoms to Complexity

Gerhard Ertl delivered his Nobel Lecture on 8 December 2007, at Aula Magna, Stockholm University, where he was introduced by Professor Gunnar von Heijne, Chairman of the Nobel Committee for Chemistry.

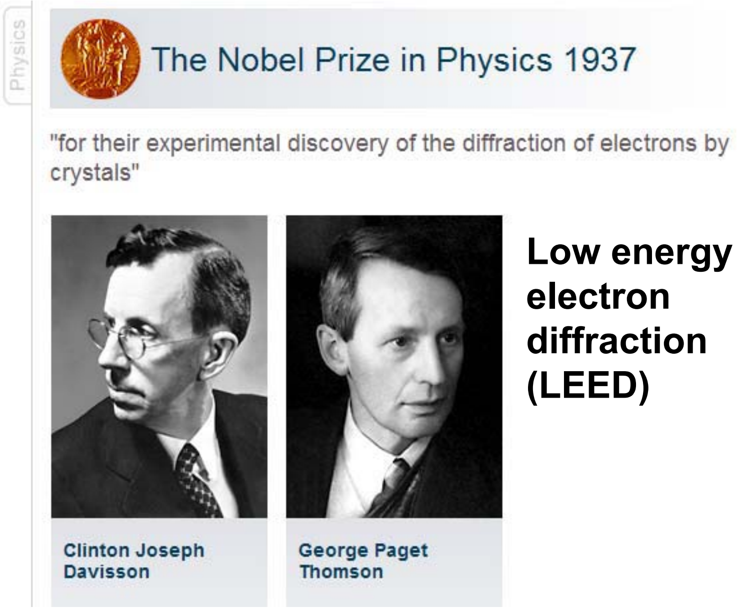


The Nobel Prize in Physics 1921

"for his services to Theoretical Physics, and especially for his discovery of the law of the photoelectric effect"

Albert Einstein

Photoelectric effect→
Photoemission or
Photoelectron spectroscopy
(PS, PES)



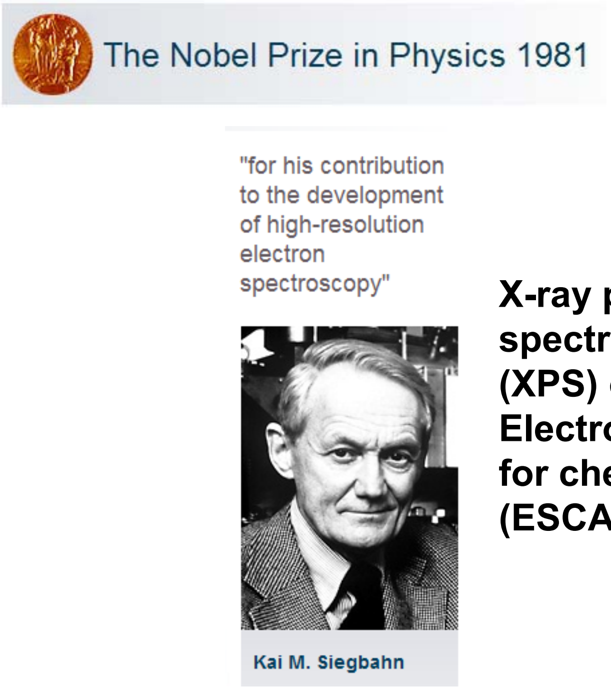
The Nobel Prize in Physics 1937

"for their experimental discovery of the diffraction of electrons by crystals"

Clinton Joseph Davisson

George Paget Thomson

Low energy
electron
diffraction
(LEED)

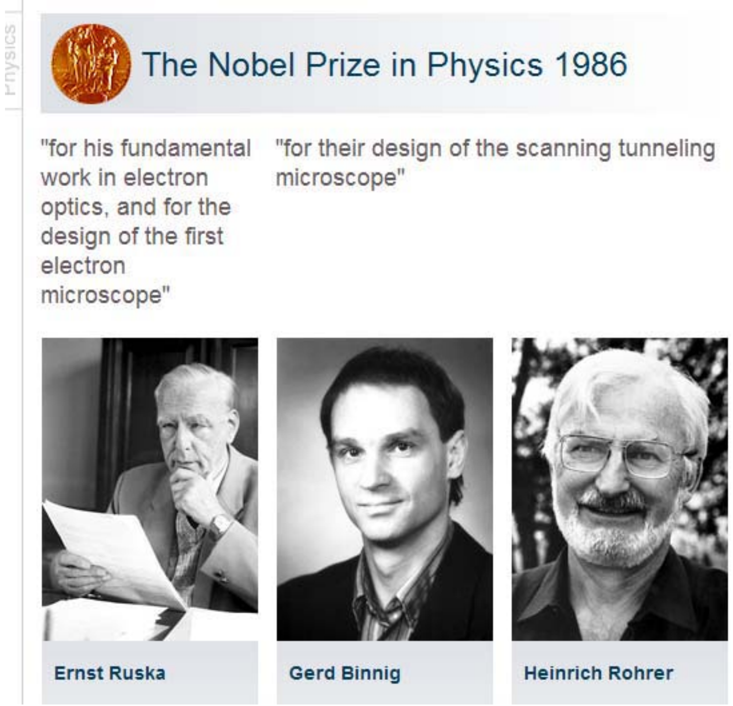


The Nobel Prize in Physics 1981

"for his contribution to the development of high-resolution electron spectroscopy"

Kai M. Siegbahn

X-ray photoelectron
spectroscopy
(XPS) or
Electron spectroscopy
for chemical analysis
(ESCA)



The Nobel Prize in Physics 1986

"for his fundamental work in electron optics, and for the design of the first electron microscope"

"for their design of the scanning tunneling microscope"

Ernst Ruska

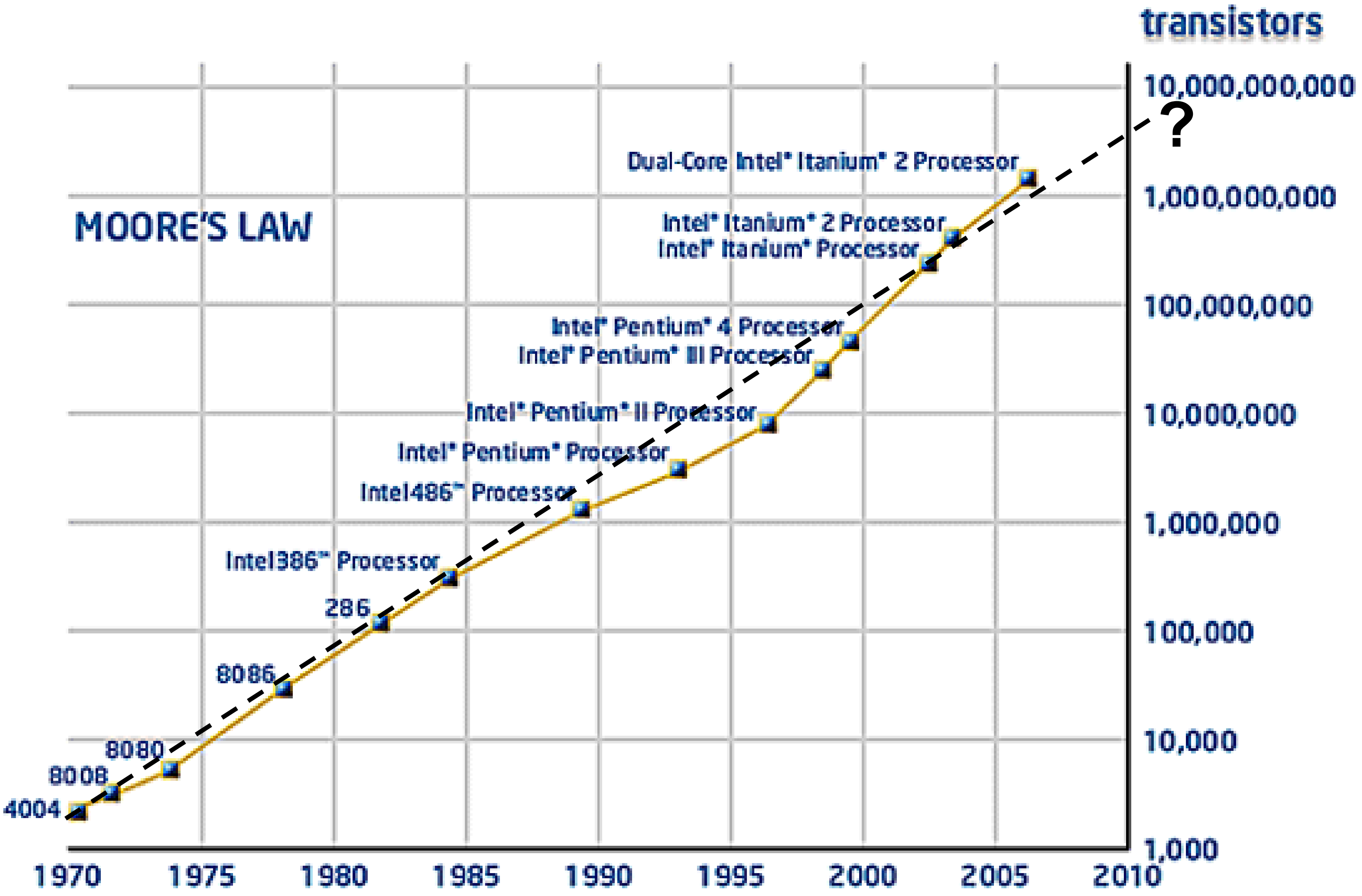
Gerd Binnig

Heinrich Rohrer

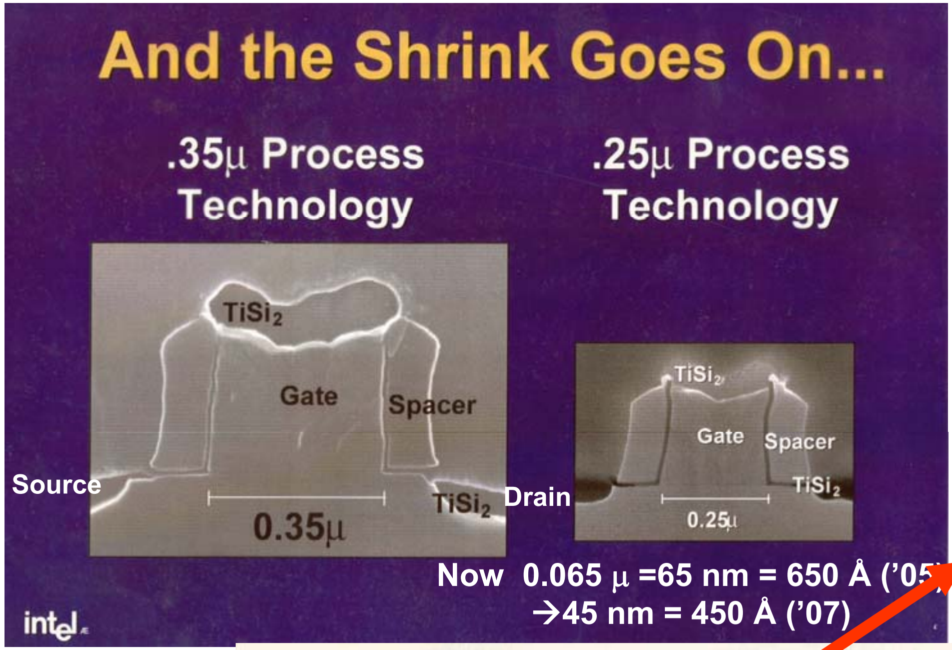
Electron and Scanning tunneling microscopy (STM)

Scientific and technological areas involving surface/interface/nano science:

➡ •**Integrated circuits—higher speed, higher density**

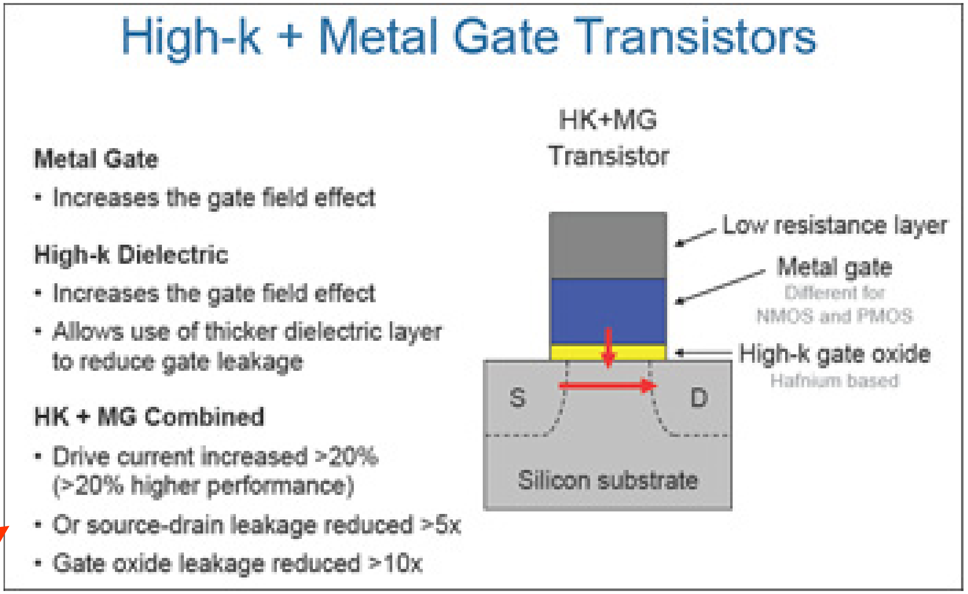


http://www.intel.com/technology/mooreslaw/index.htm



And the Shrink Goes On...

Now 0.065 µ =65 nm = 650 Å ('05)
→45 nm = 450 Å ('07)



High-k + Metal Gate Transistors

Metal Gate

- Increases the gate field effect

High-k Dielectric

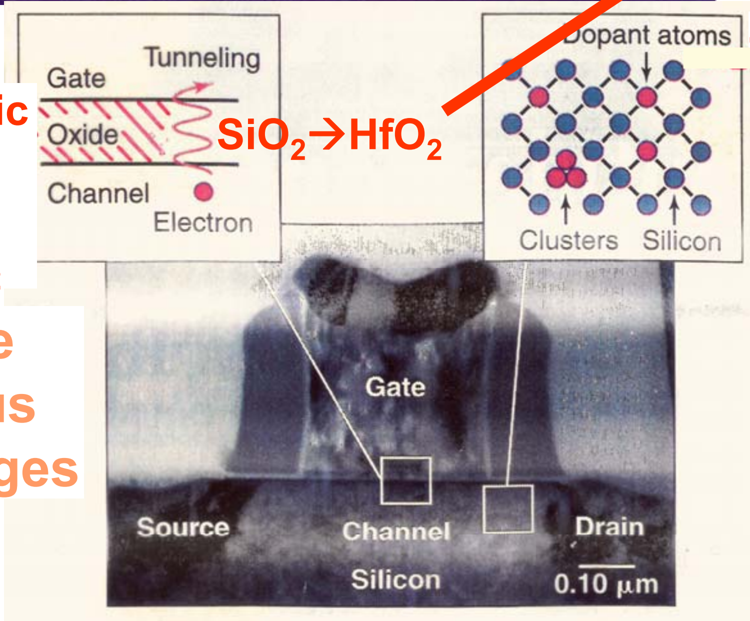
- Increases the gate field effect
- Allows use of thicker dielectric layer to reduce gate leakage

HK + MG Combined

- Drive current increased >20% (>20% higher performance)
- Or source-drain leakage reduced >5x
- Gate oxide leakage reduced >10x

~few atomic layers—currently 15 Å SiO_2

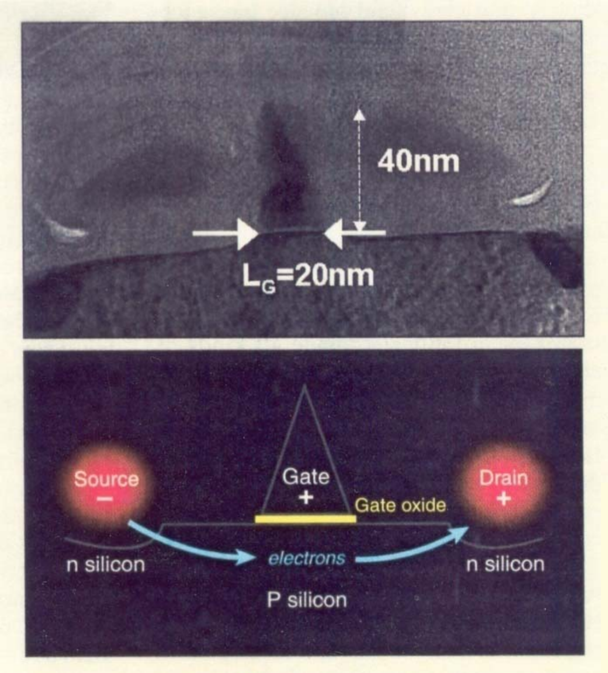
Some serious challenges



$SiO_2 \rightarrow HfO_2$

~1 %

Cross section of a MOS transistor. Electron tunneling through the gate oxide (**left inset**) and high-concentration dopant interactions (**right inset**) are posing fundamental limitations to continuing historical transistor scaling trends.



World's Smallest Transistor

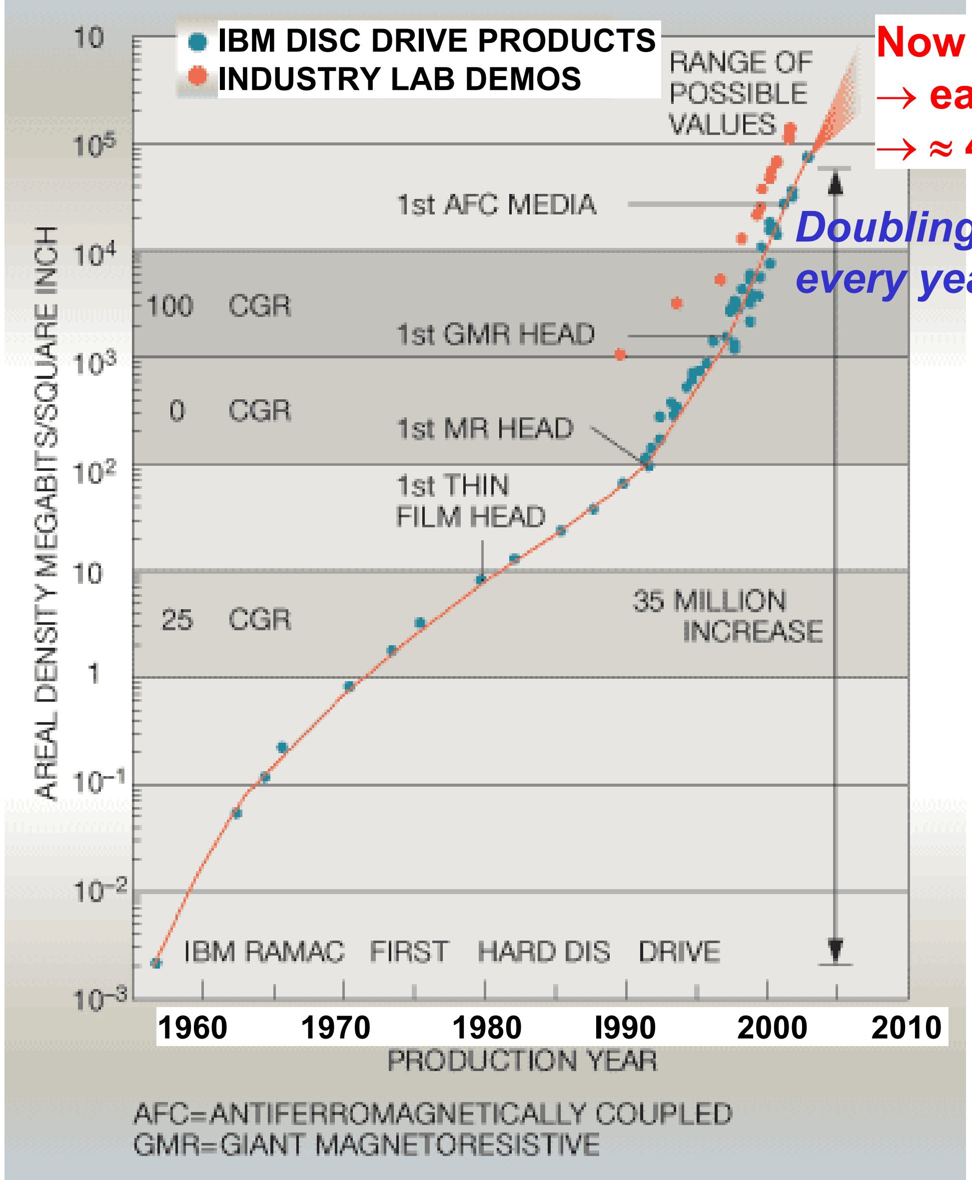
IBM Science 2001

Scientific and technological areas related to surface/interface/nano science:

- **Integrated circuits—higher speed, higher density**
- **Magnetic storage and circuits—higher density, magnetic logic**

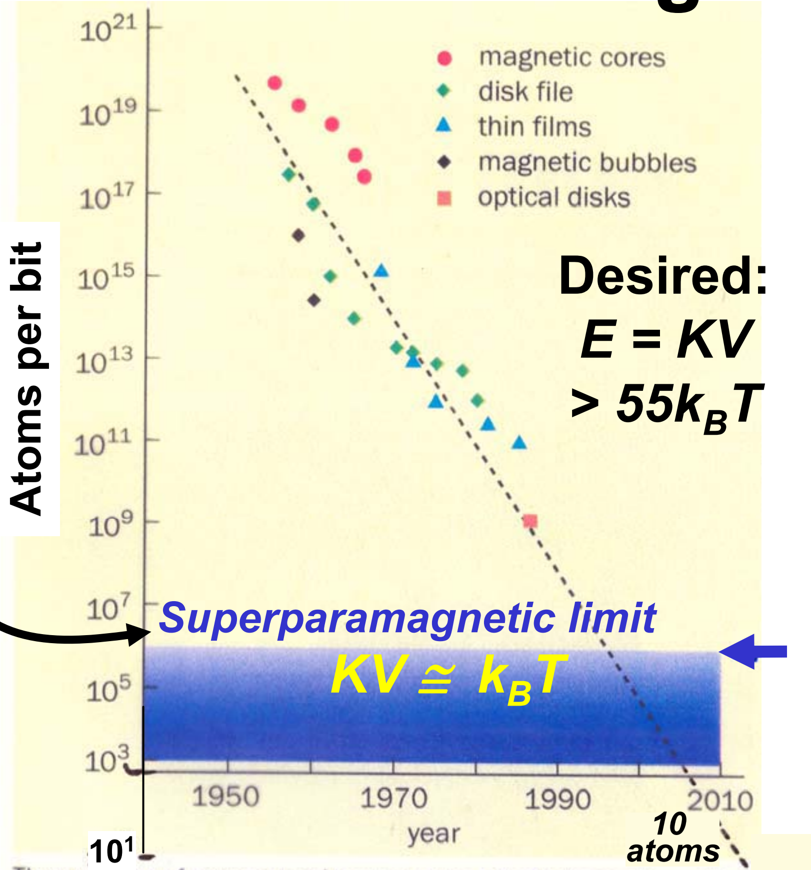
“Moore’s Law” for magnetic storage

Now 170 Gbits/in^2 = 20 Gbytes/in^2
→ each bit ~14 nm x 30 nm x 210 nm
→ ≈ 4,000,000 atoms, read at GHz rates



Doubling every year!

How for can we go?



Superparamagnetic limit

$KV \cong k_BT$

Desired:

$E = KV$

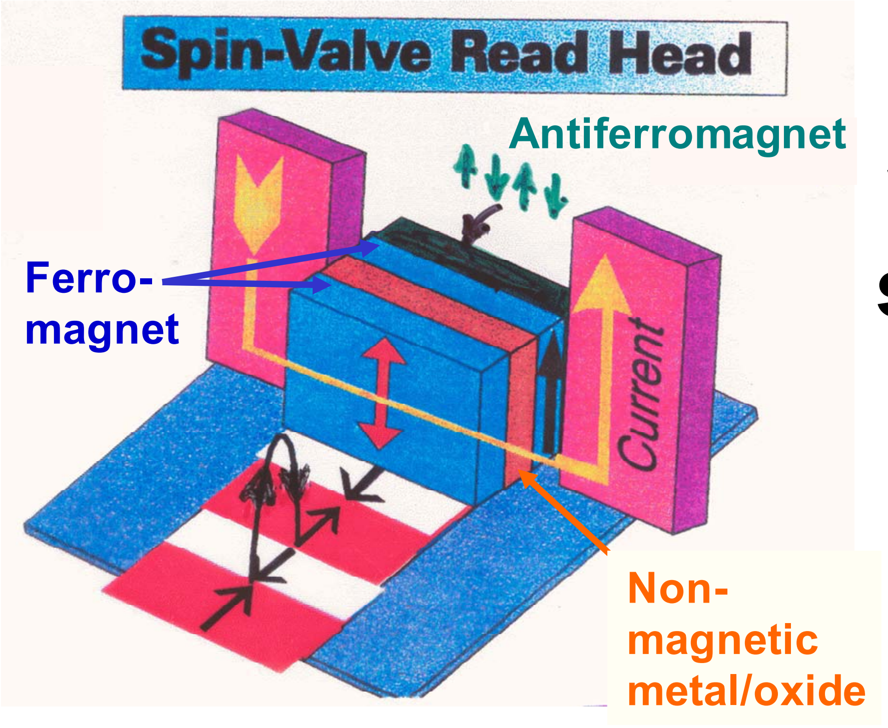
$> 55k_BT$

The number of atoms used to store one bit of information with different forms of magnetic or optical storage has reduced over the years. The blue region indicates the superparamagnetic regime, below which thermal fluctuations at room temperature could alter the orientation of magnetic bits.

http://www.research.ibm.com/journal/sj/422/grochowski.html

Harris, Awschalom Physics World, Jan. ‘99

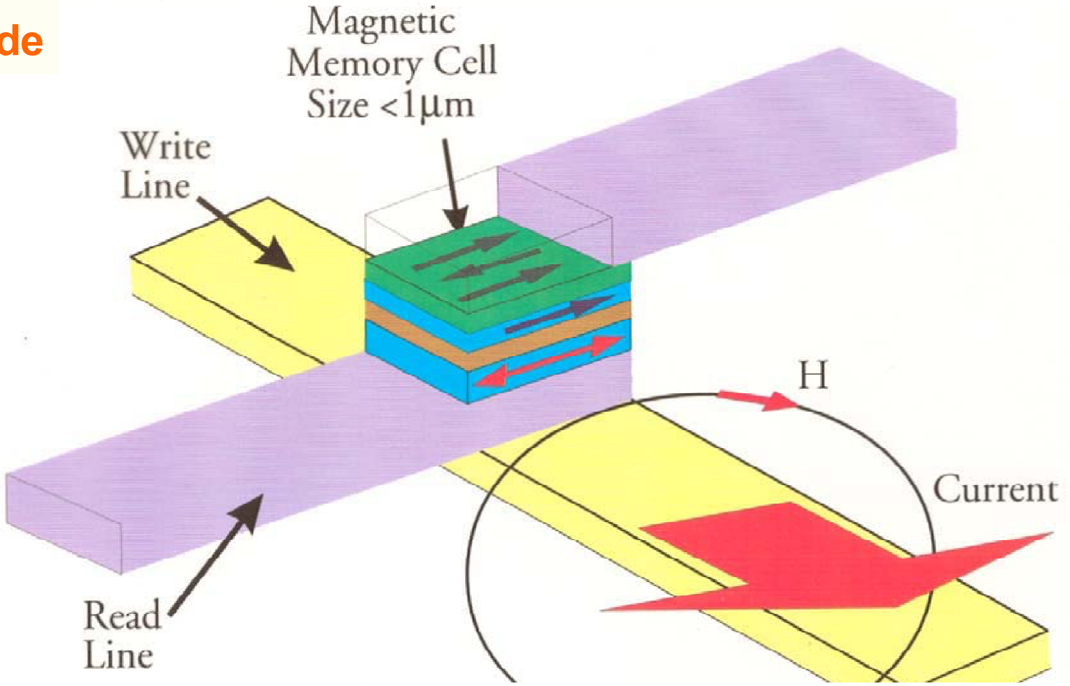
Some new directions with magnetic nanolayer structures--"spintronics"



**Uses "giant magnetoresistance (GMR)"
and "exchange bias"
--in every high-speed read head now**

Crucial surfaces & buried interfaces everywhere, as well as complex materials (e.g. colossal magnetoresistance (CMR))

Magnetic Random Access Memory (MRAM-Non Volatile)



Up to 100 Mbit devices in R&D: applications to e.g. cell phone use

Scientific and technological areas related to surface/interface/nano science:

- Integrated circuits—higher speed, higher density
- Magnetic storage—higher density, magnetic logic
- Catalysis—auto catalytic converter, petrochemical processing
- Corrosion—major annual economic cost
- Polymer surface modification—promote adhesion, fire resistance,…
- Batteries, fuel cells—the hydrogen economy?
- Lubrication (tribology)—nanometer-scale layers
- Atmospheric particulates—ice, carbonaceous,…
- Nuclear reactors and waste storage—how long-lasting?
- Environmental science—retention of contaminants in soil
- Biomaterials—compatibility through surface interactions
- Sensors—surface reactions→change in voltage, resistance

Outline

Surface, interface, and nanoscience—short introduction

➡ Some surface concepts and techniques→photoemission

Synchrotron radiation: experimental aspects

Electronic structure—a brief review

The basic synchrotron radiation techniques:
more experimental and theoretical details

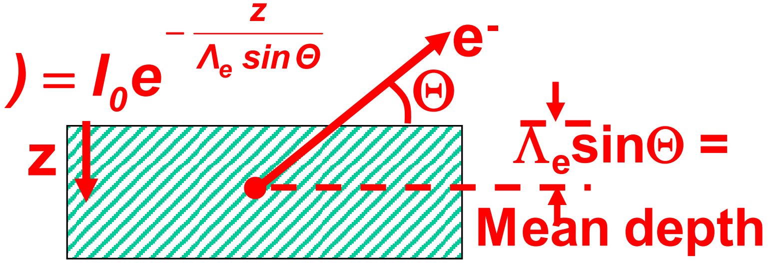
Valence-level photoemission

Core-level photoemission

Photoemission with high ambient pressure
around the sample

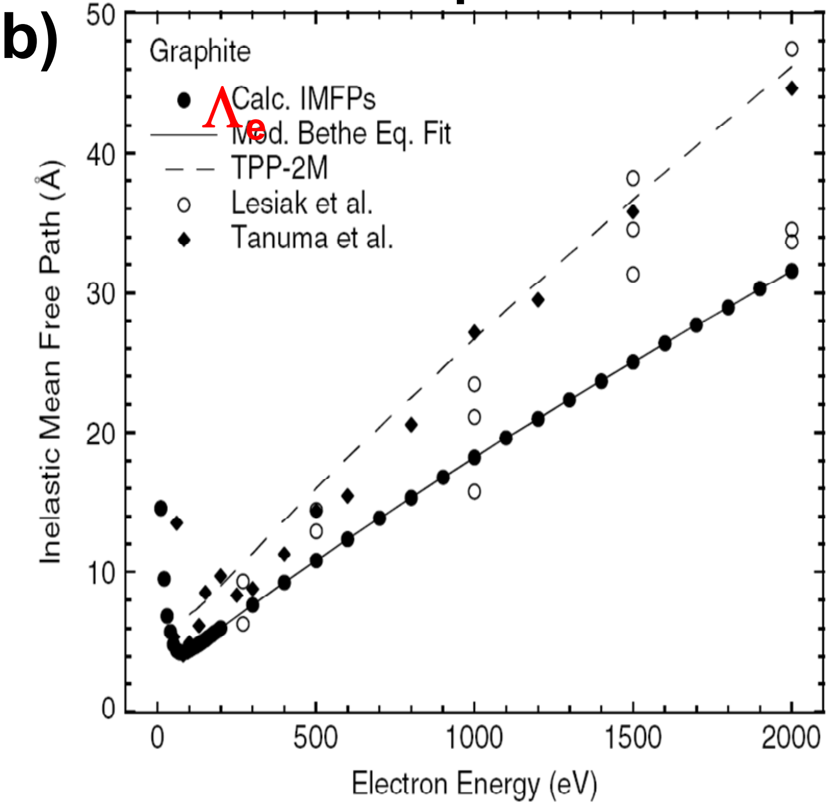
Electrons as surface probes: the electron inelastic mean free paths in solids

(a) $$I(z) = I_0 e^{-\frac{z}{\Lambda_e \sin\Theta}}$$

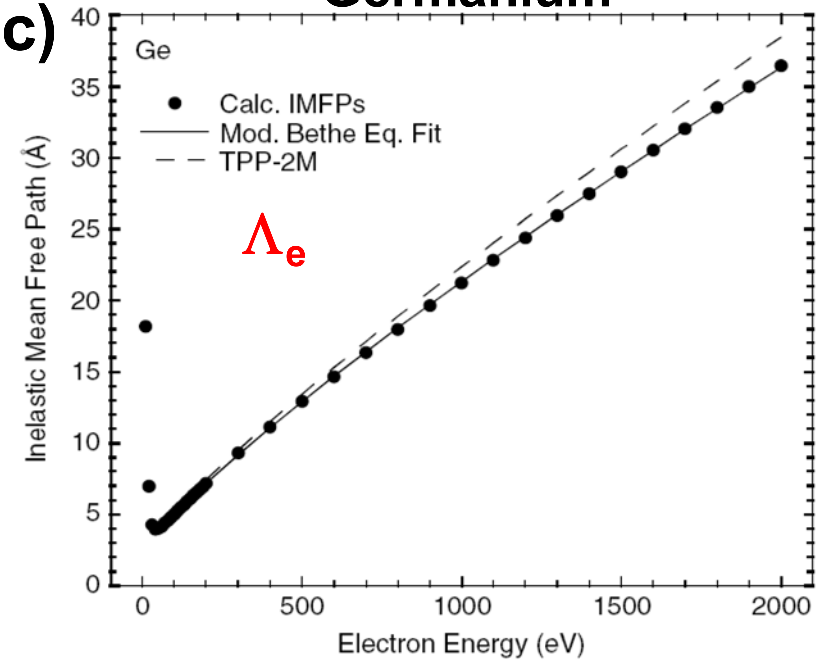


$\Lambda_e \sin\Theta$ = Mean depth

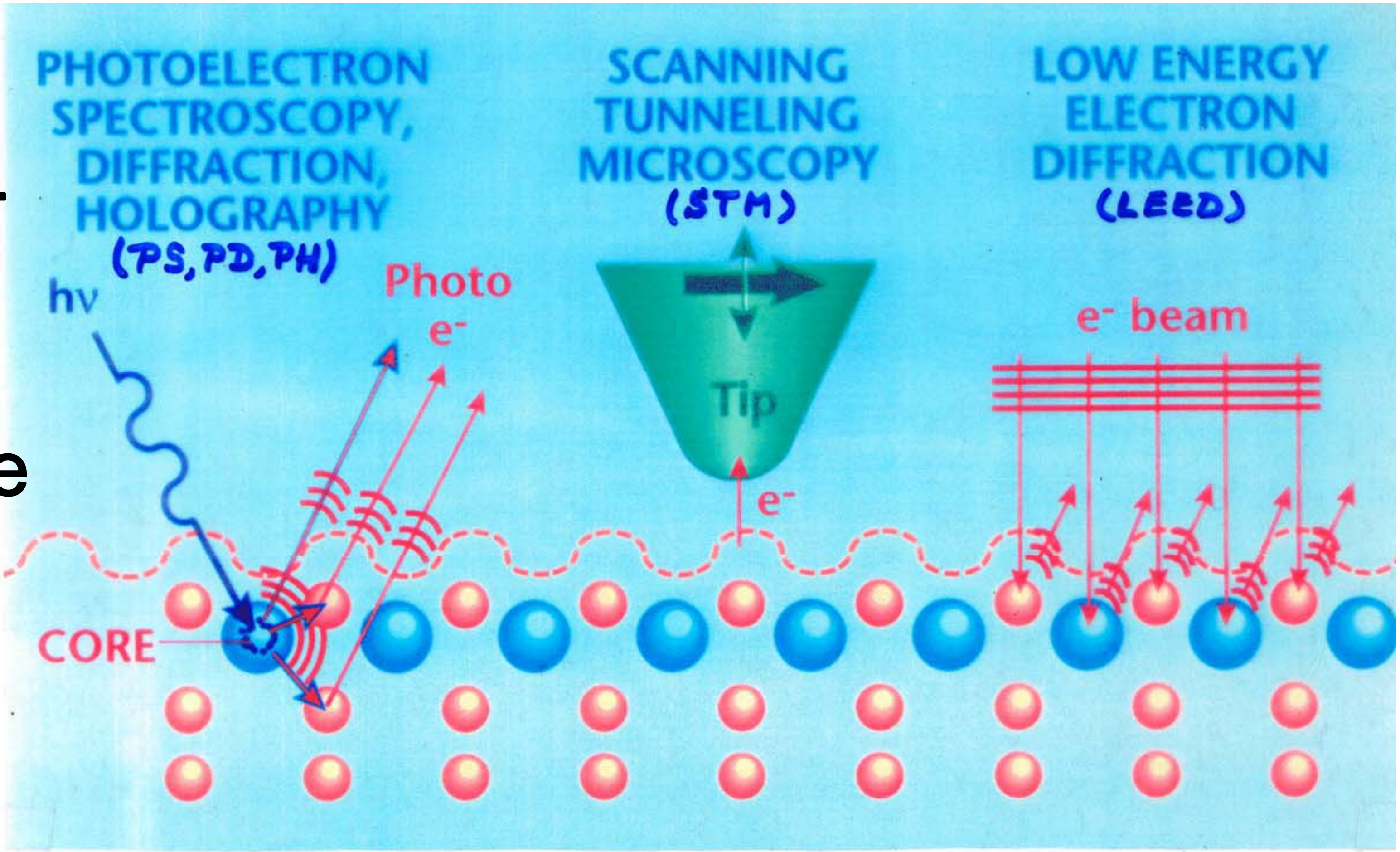
(b) **Graphite**



(c) **Germanium**

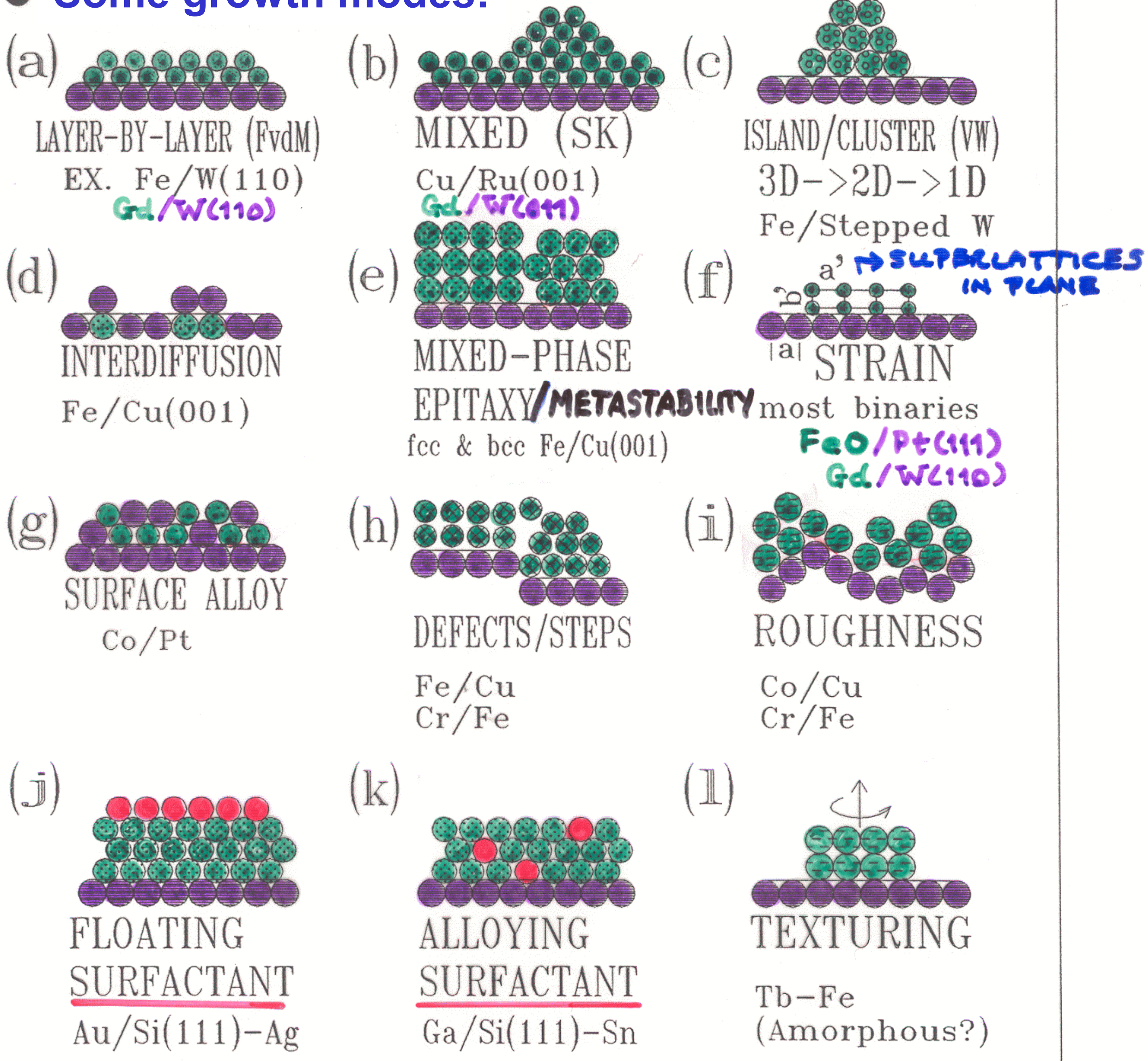


Some Comple-mentary Surface Structure Probes

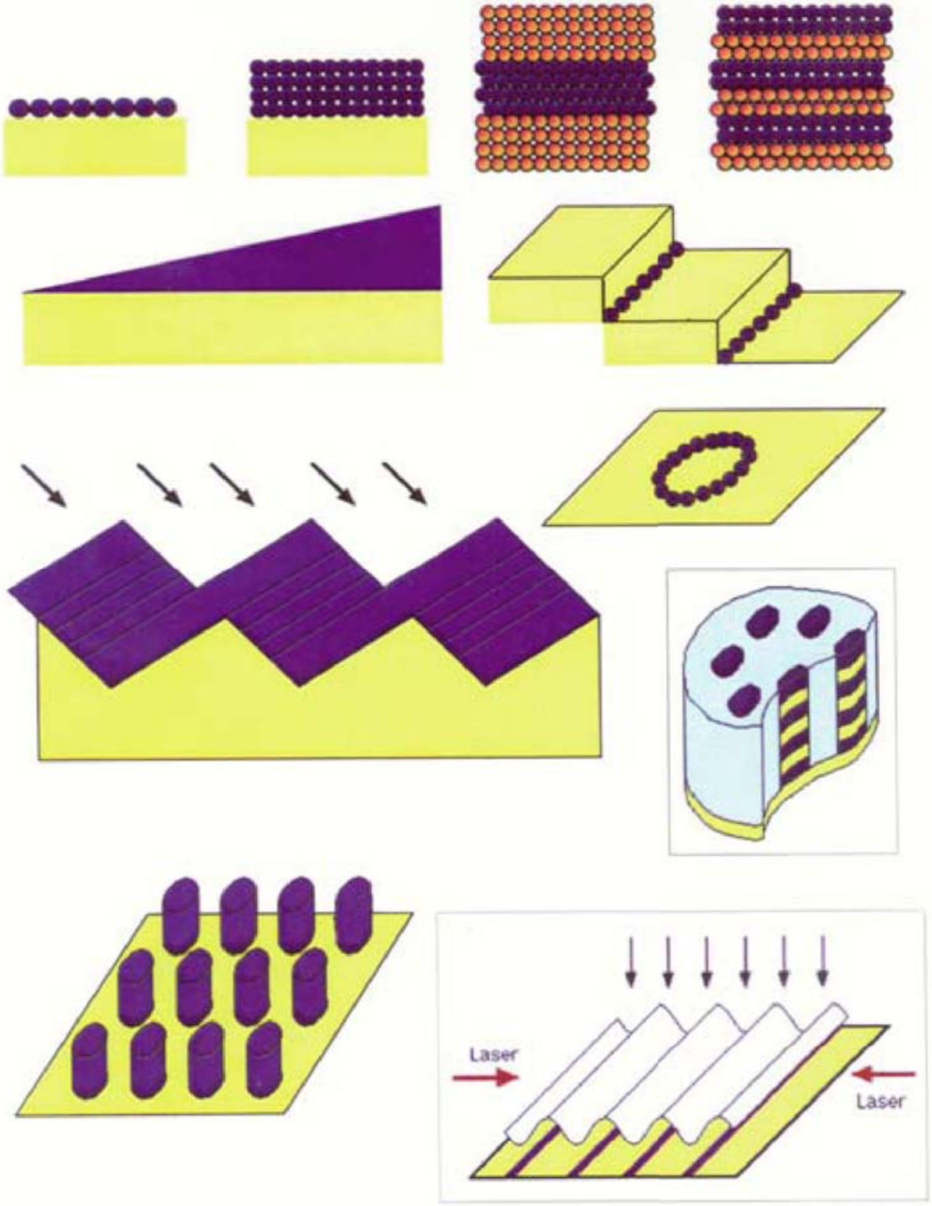


-Type of order:	Short (< 10Å)	Short, long and disorder	Long (> 100Å)
-Atom & site specific:	Yes	No	No
-Sensing depth:	5-40Å	Mostly surface D.O.S.	5-20Å
-Lateral resolution:	1 mm^2 to (300Å)^2	Single atom	1 mm^2 to 1 micron^2

- **Some growth modes:**

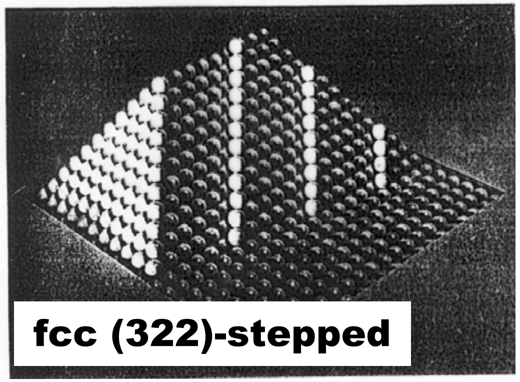


Some important structures in nanoscience/nanotechnology

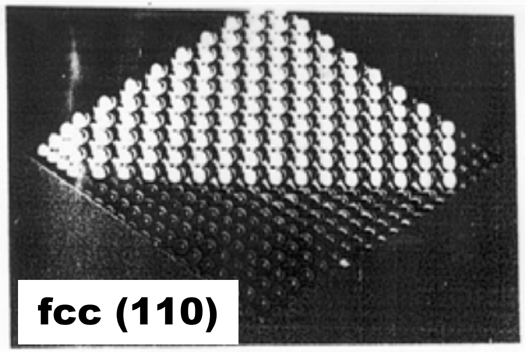


KORTRIGHT
ET AL., J.M.M.
207, 44('99')

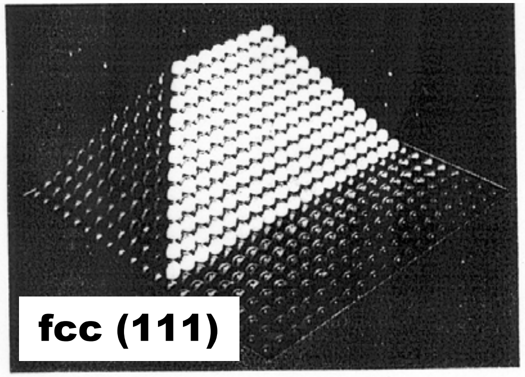
WHAT DO SURFACES LOOK LIKE?
SOME fcc AND bcc SURFACES



fcc (322)-stepped

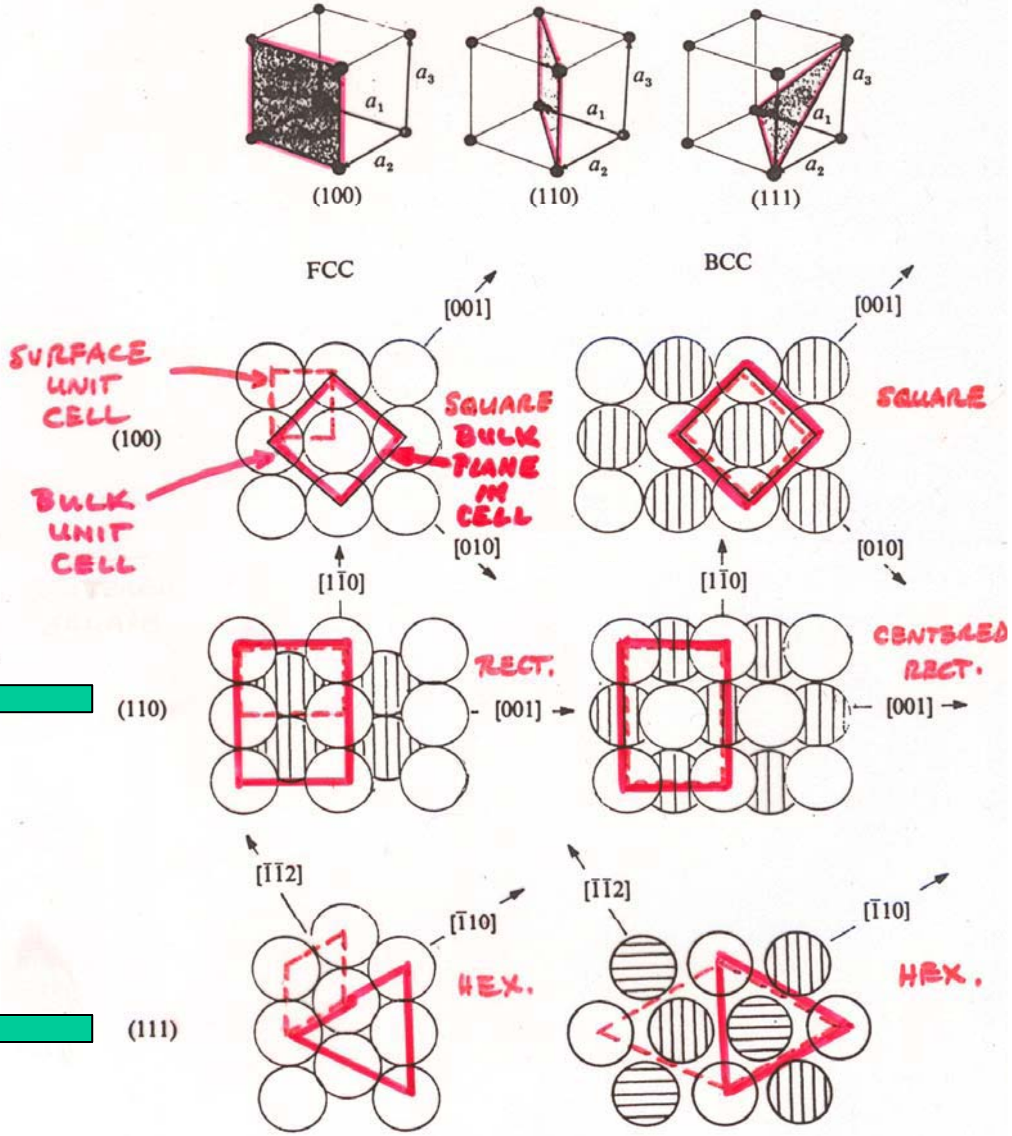


fcc (110)

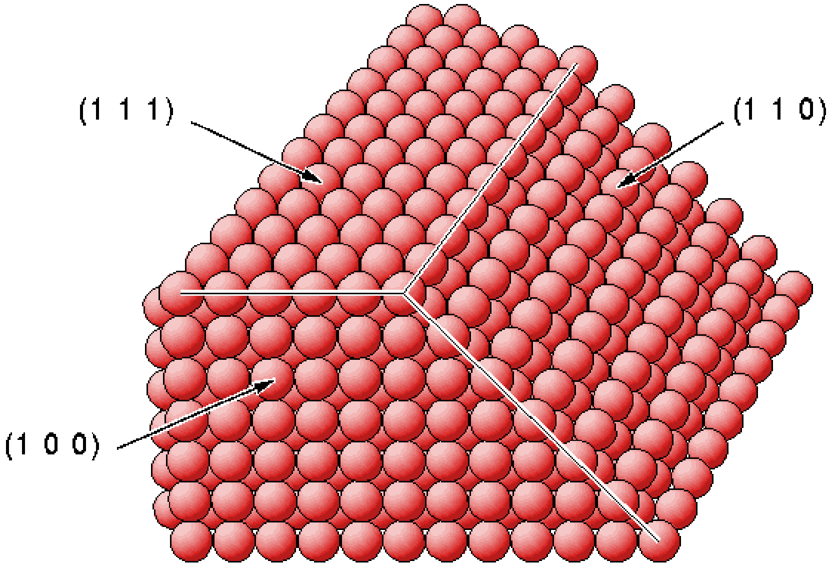


fcc (111)

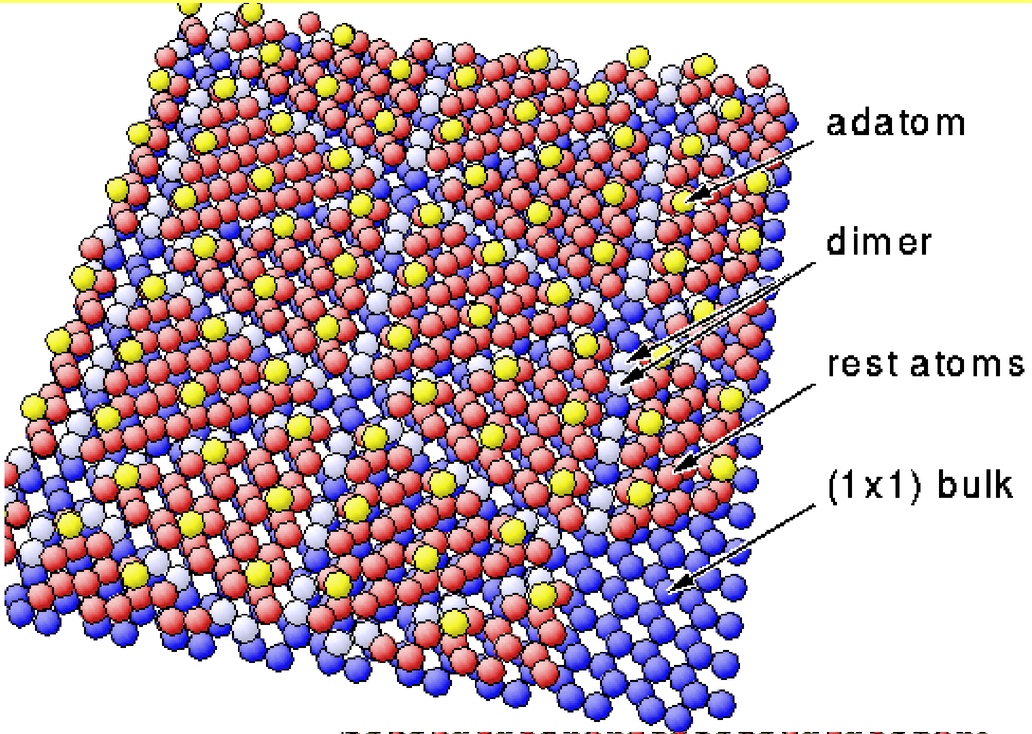
Fig. 3.2. Low-index ideal surfaces of a hard-sphere cubic crystal. Vertical and horizontal markings indicate the second and third atom layers, respectively. Cube face is indicated for (100) to set the scale (Nicholas, 1965).



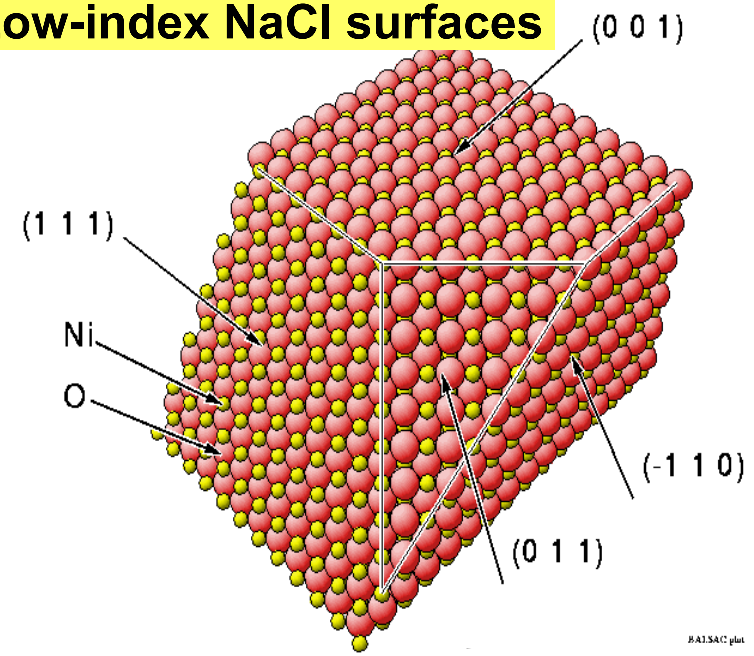
Low-index fcc metal surfaces



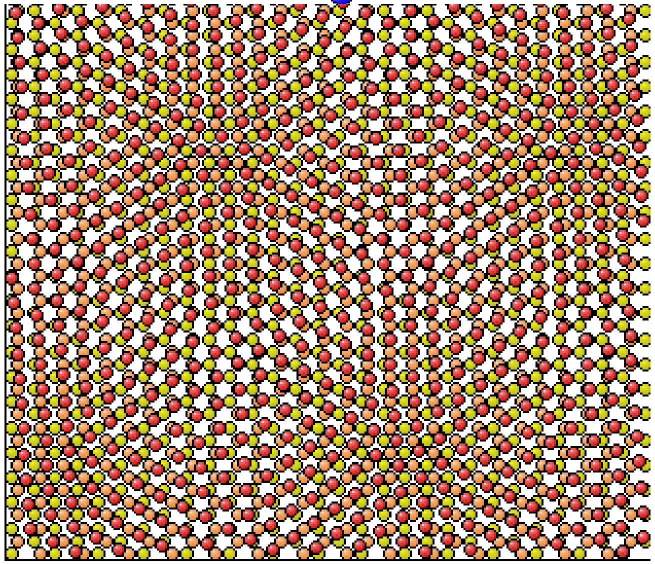
Si(111)-(7x7)—Dimer-adatom-stacking fault model



Low-index NaCl surfaces

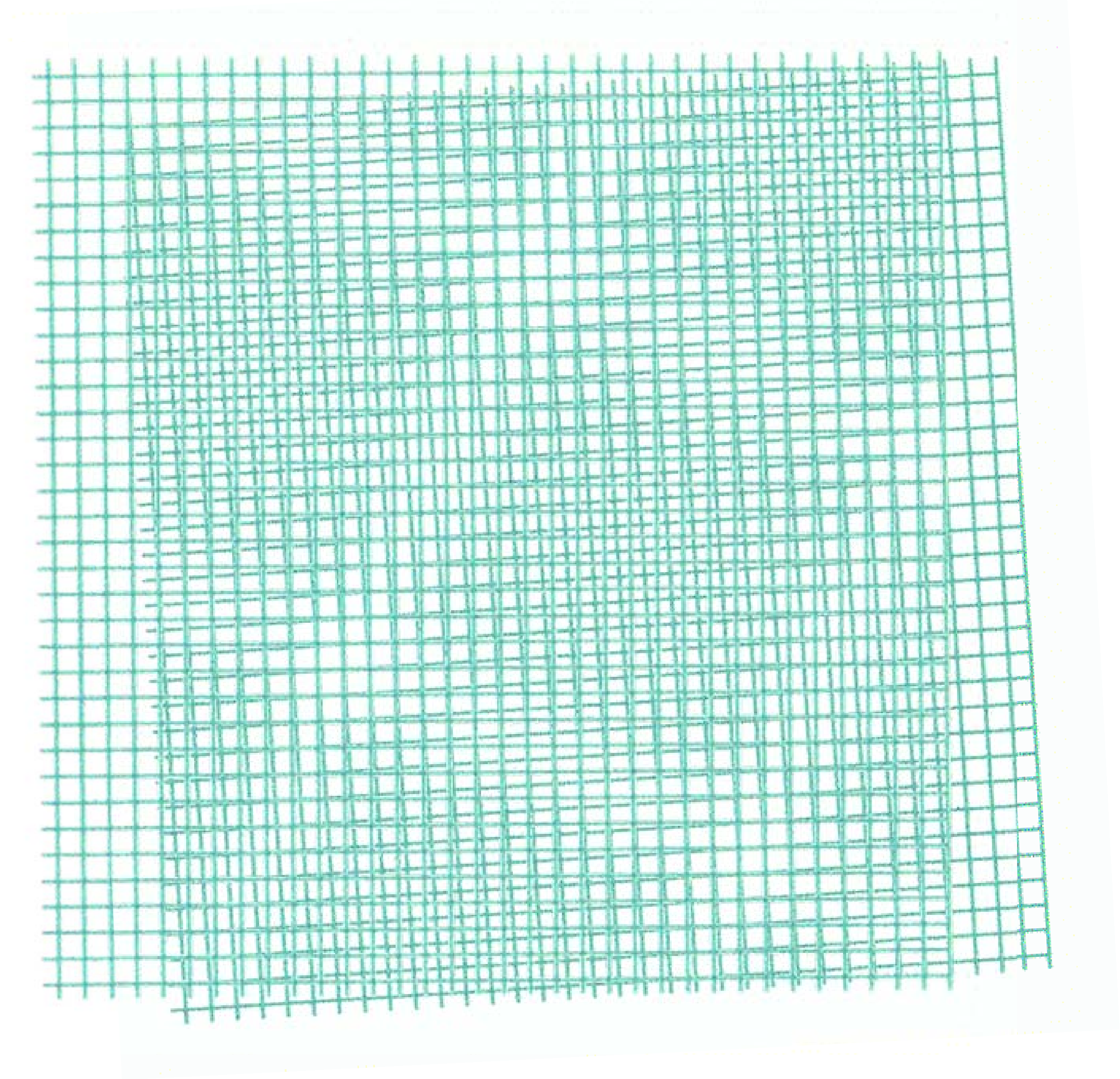


Fcc(111) superlattice = a Moiré pattern: 4 degree rot'n.

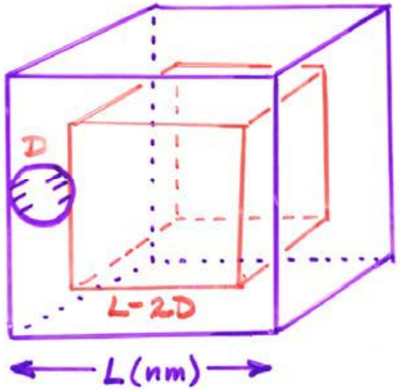


http://www.fhi-berlin.mpg.de/th/personal/hermann/pictures.html

Formation of Moire patterns—two rotated square lattices



FRACTION OF ATOMS ON THE SURFACE OF A CUBE: D = ATOMIC DIAM. ≈ 0.2 nm = 2 Å



$$\text{SURFACE FRACTION} = \frac{L^3 - (L-2D)^3}{L^3}$$

L	FRACTION
1 µm = 1000 nm	0.001 ≈ 0.1%
0.1 µm = 100 nm	0.012 ≈ 1.2%
0.01 µm = 10 nm	0.115 ≈ 11.5%
0.001 µm = 1 nm	0.784 = 78.4%

Nanoscience is surface science

SOME UNITS:

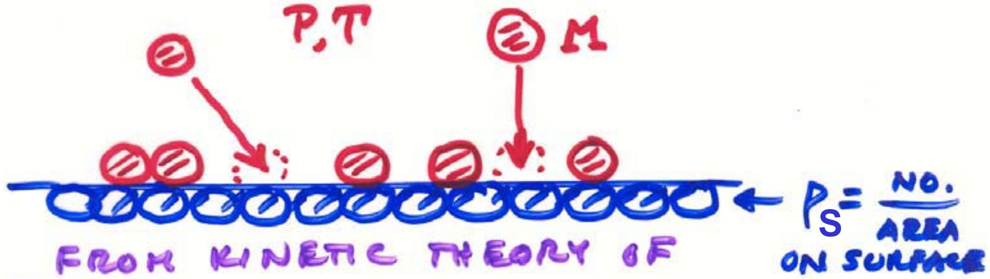
1 HAIR ≈ 50 microns

1 micron = 10^{-6} m = 1,000 nm = 10,000 Å ≈ 5,000 atoms

0.001 micron = 10^{-9} m = 1 nanometer = 1 nm = 10 Å ≈ 5 atoms

WHY IS ULTRAHIGH VACUUM IMPORTANT?

TIME TO BUILD UP A SINGLE ATOMIC/MOLECULAR LAYER = 1 MONOLAYER ≡ 1 ML IF EACH ATOM/MOLECULE FROM GAS PHASE HITTING SURFACE STICKS: τ_1



FROM KINETIC THEORY OF GASES:

$$\tau_1\ (\text{sec}) = 2.84 \times 10^{-23}[T(K)M]^{1/2}\rho_S(\text{cm}^{-2})/P(\text{torr})$$

WITH TYPICAL NOS. FOR $\overset{N_2, CO\ \downarrow\ \ O_2\ \downarrow}{M = 28, 32}$

$T = 298K$

$\rho_S = 1\text{-}2 \times 10^{15}\ \text{cm}^{-2}$

↑ METALS, SEMICOND.

	τ_1	P
	1 s	10^{-6} torr
	100 s ~2 min	10^{-8} "
	~15 min	10^{-9} "
TYPICAL	~2.8 hr	10^{-10} "
	~27.8 hr	10^{-11} "

→ **Need to work at ~10^{-10}-10^{-11} torr**

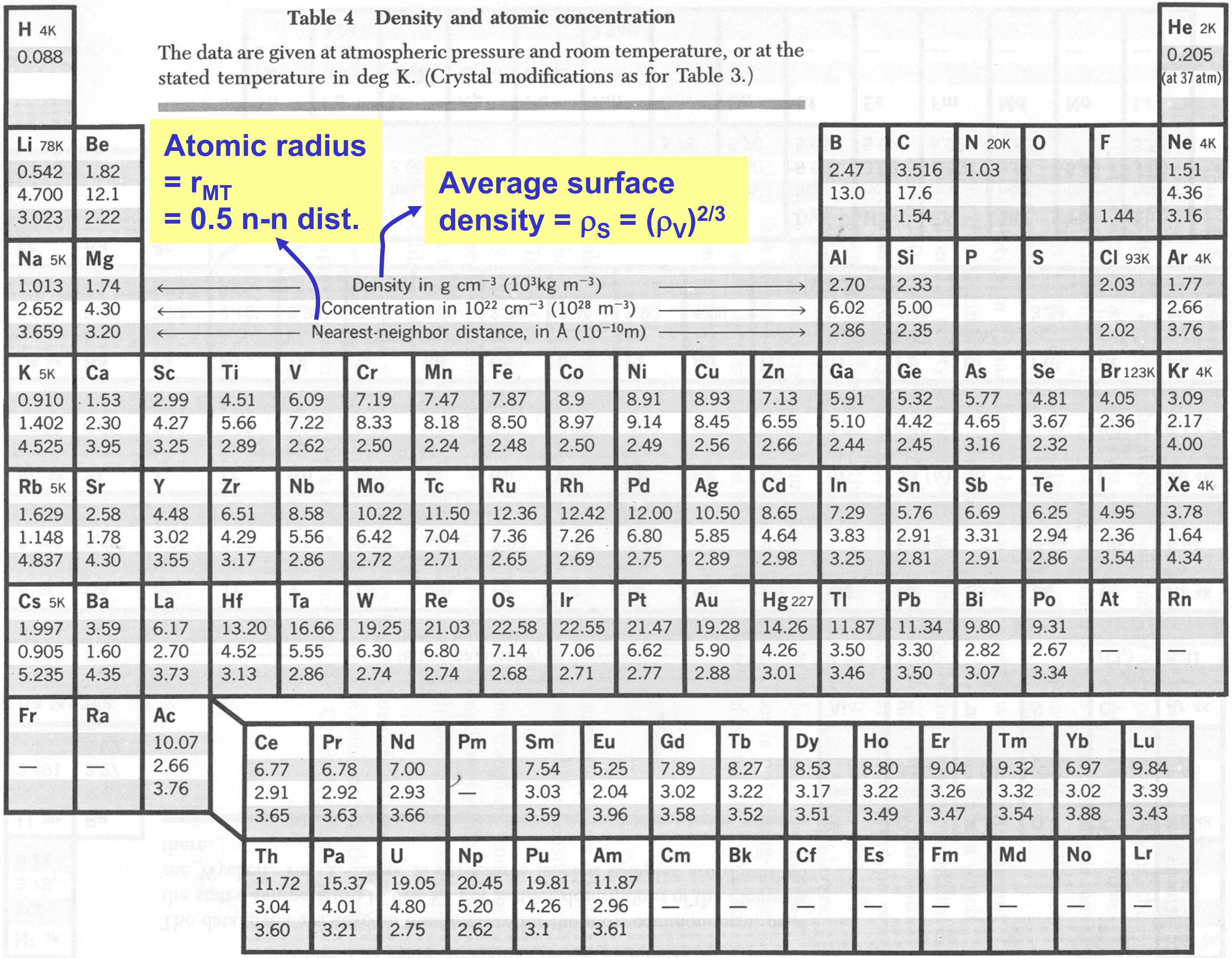


Table 4 Density and atomic concentration

The data are given at atmospheric pressure and room temperature, or at the stated temperature in deg K. (Crystal modifications as for Table 3.)

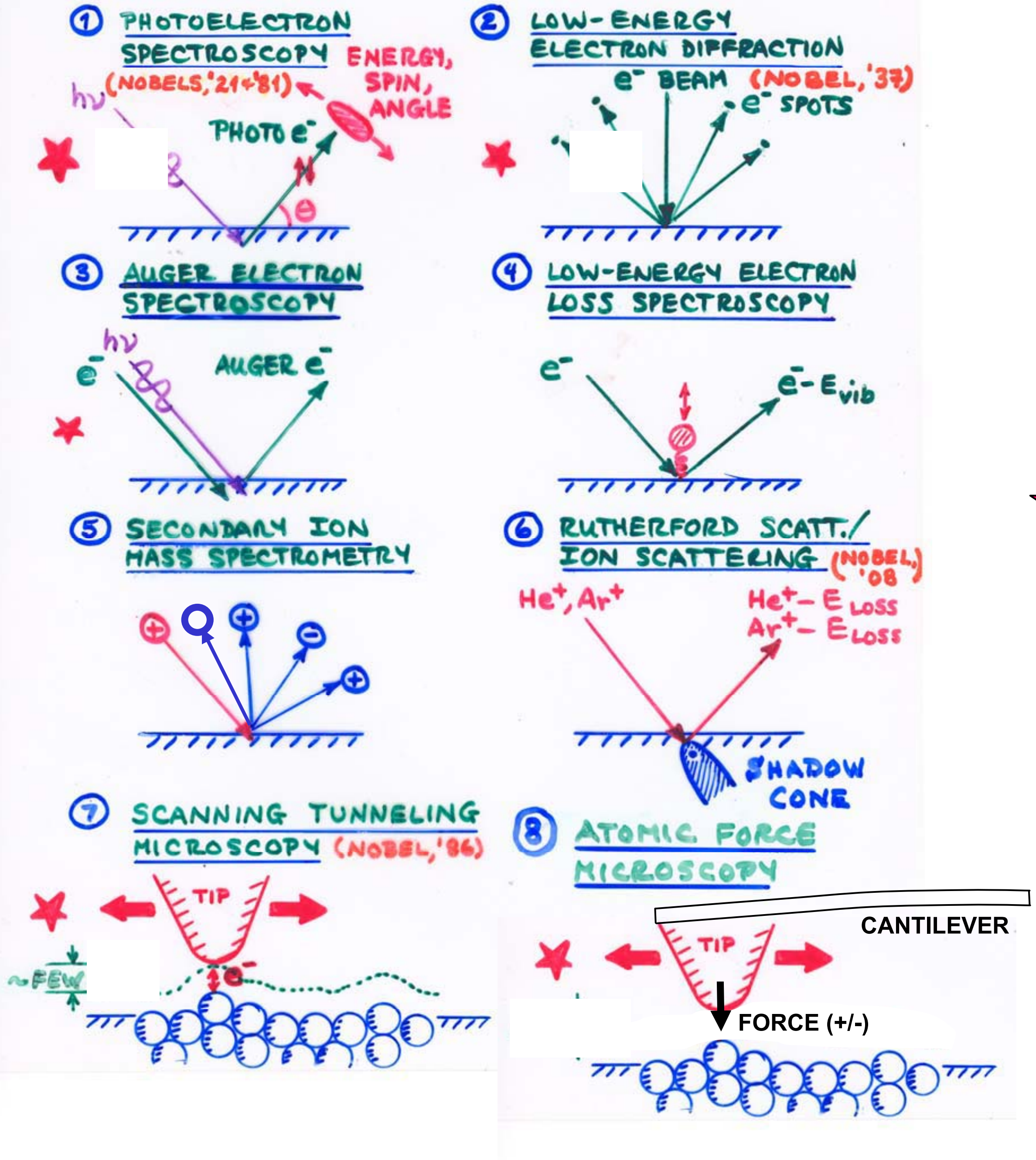
Atomic radius = r_{MT} = 0.5 n-n dist.

Average surface density = $\rho_S = (\rho_V)^{2/3}$

H 4K																	He 2K
0.088																	0.205
																	(at 37 atm)
Li 78K	Be											B	C	N 20K	O	F	Ne 4K
0.542	1.82											2.47	3.516	1.03			1.51
4.700	12.1											13.0	17.6				4.36
3.023	2.22												1.54			1.44	3.16
Na 5K	Mg											Al	Si	P	S	Cl 93K	Ar 4K
1.013	1.74	← Density in g cm^{-3} (10^{3}kg m^{-3}) →										2.70	2.33			2.03	1.77
2.652	4.30	← Concentration in 10^{22} cm^{-3} (10^{28} m^{-3}) →										6.02	5.00				2.66
3.659	3.20	← Nearest-neighbor distance, in Å (10^{-10}m) →										2.86	2.35			2.02	3.76
K 5K	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br 123K	Kr 4K
0.910	1.53	2.99	4.51	6.09	7.19	7.47	7.87	8.9	8.91	8.93	7.13	5.91	5.32	5.77	4.81	4.05	3.09
1.402	2.30	4.27	5.66	7.22	8.33	8.18	8.50	8.97	9.14	8.45	6.55	5.10	4.42	4.65	3.67	2.36	2.17
4.525	3.95	3.25	2.89	2.62	2.50	2.24	2.48	2.50	2.49	2.56	2.66	2.44	2.45	3.16	2.32		4.00
Rb 5K	Sr	Y	Zr	Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	I	Xe 4K
1.629	2.58	4.48	6.51	8.58	10.22	11.50	12.36	12.42	12.00	10.50	8.65	7.29	5.76	6.69	6.25	4.95	3.78
1.148	1.78	3.02	4.29	5.56	6.42	7.04	7.36	7.26	6.80	5.85	4.64	3.83	2.91	3.31	2.94	2.36	1.64
4.837	4.30	3.55	3.17	2.86	2.72	2.71	2.65	2.69	2.75	2.89	2.98	3.25	2.81	2.91	2.86	3.54	4.34
Cs 5K	Ba	La	Hf	Ta	W	Re	Os	Ir	Pt	Au	Hg 227	Tl	Pb	Bi	Po	At	Rn
1.997	3.59	6.17	13.20	16.66	19.25	21.03	22.58	22.55	21.47	19.28	14.26	11.87	11.34	9.80	9.31		
0.905	1.60	2.70	4.52	5.55	6.30	6.80	7.14	7.06	6.62	5.90	4.26	3.50	3.30	2.82	2.67	—	—
5.235	4.35	3.73	3.13	2.86	2.74	2.74	2.68	2.71	2.77	2.88	3.01	3.46	3.50	3.07	3.34		
Fr	Ra	Ac															
		10.07															
—	—	2.66															
		3.76															

Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu
6.77	6.78	7.00		7.54	5.25	7.89	8.27	8.53	8.80	9.04	9.32	6.97	9.84
2.91	2.92	2.93	—	3.03	2.04	3.02	3.22	3.17	3.22	3.26	3.32	3.02	3.39
3.65	3.63	3.66		3.59	3.96	3.58	3.52	3.51	3.49	3.47	3.54	3.88	3.43
Th	Pa	U	Np	Pu	Am	Cm	Bk	Cf	Es	Fm	Md	No	Lr
11.72	15.37	19.05	20.45	19.81	11.87								
3.04	4.01	4.80	5.20	4.26	2.96	—	—	—	—	—	—	—	—
3.60	3.21	2.75	2.62	3.1	3.61								

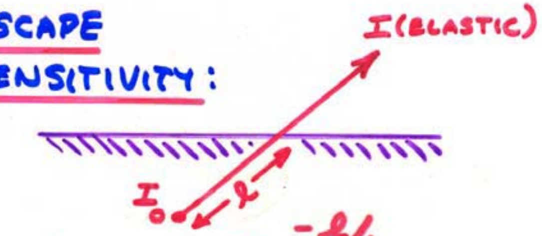
SOME SURFACE-ANALYTICAL TECHNIQUES



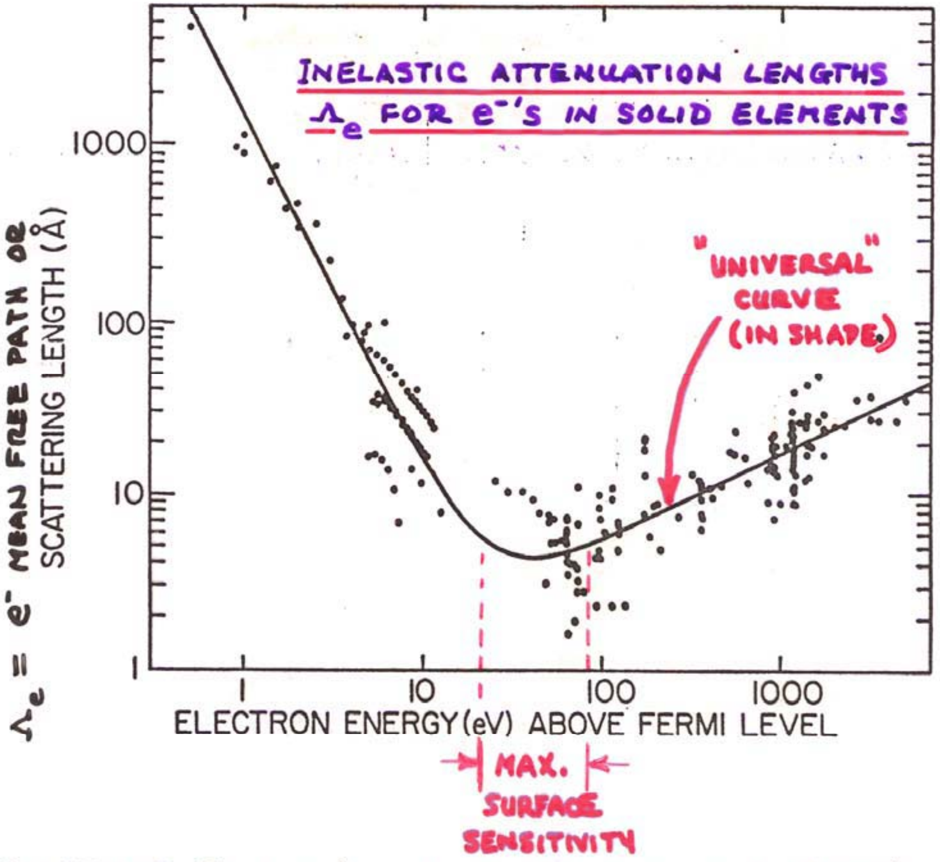
★ = AT UC DAVIS

Why are electrons so useful as probes of surfaces?

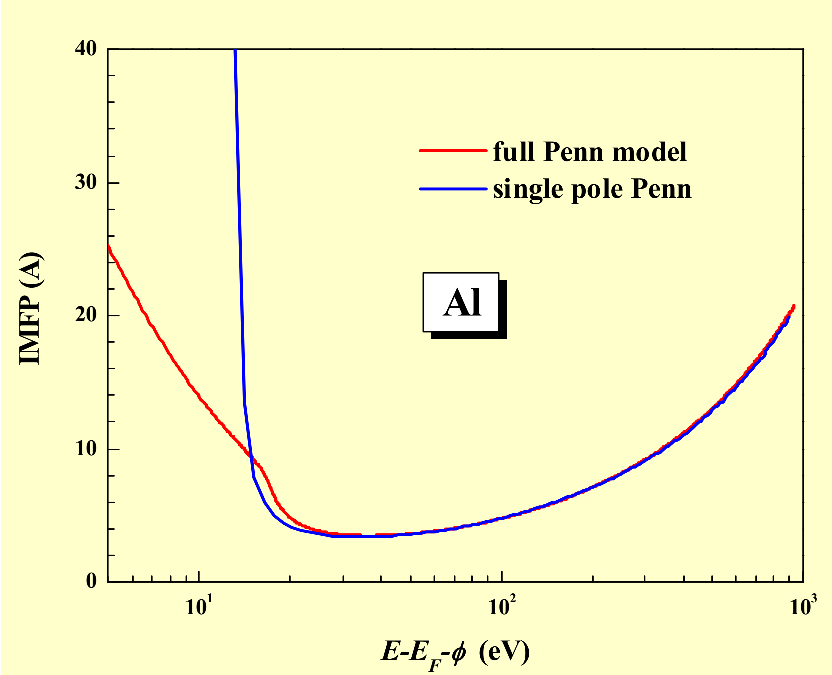
ELECTRON ESCAPE + SURFACE SENSITIVITY:

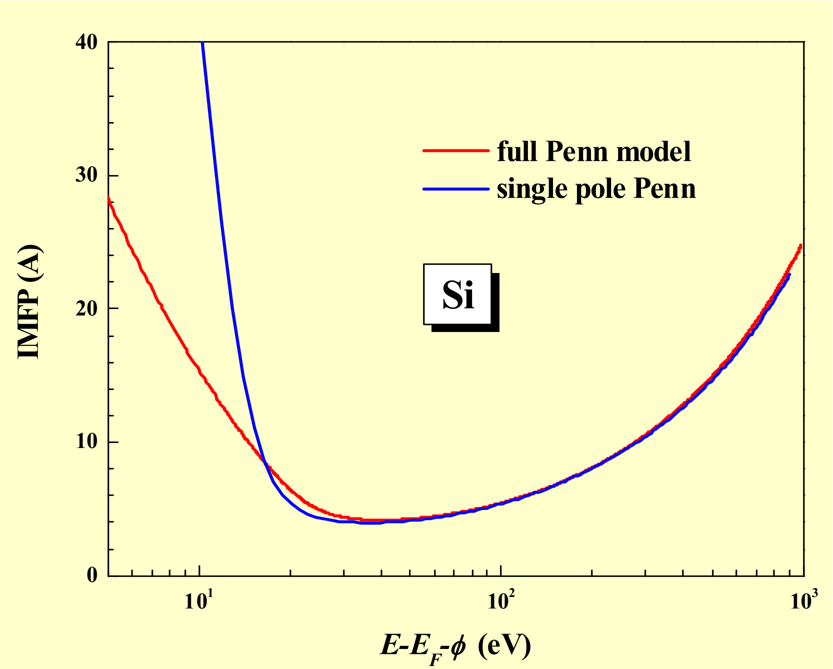


$$I(\text{ELASTIC}) = I_0 e^{-\ell/\Lambda_e}$$

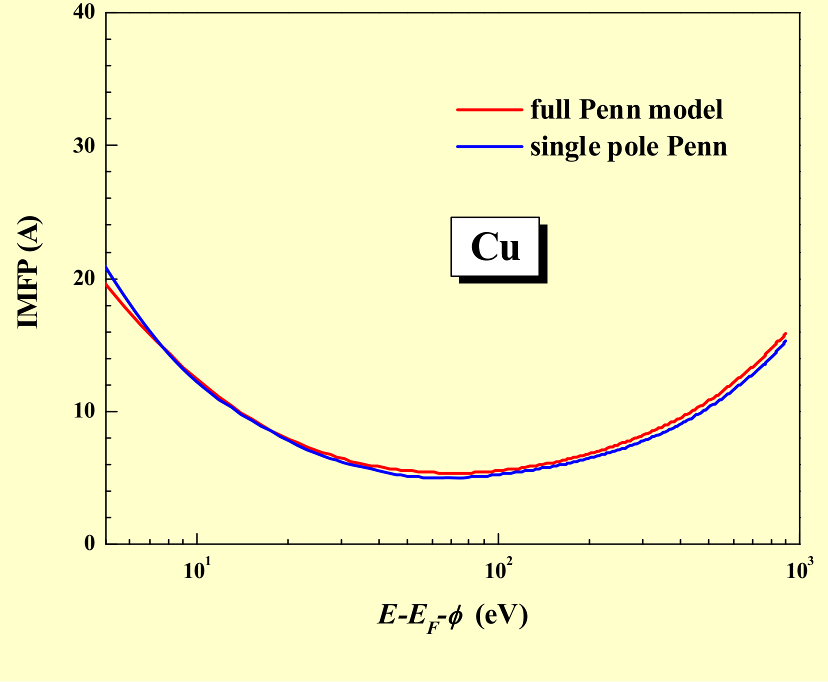


COMPILATIONS: Seah + Dench, Surf. Int. Anal. 1, 2 (1979)
Tanuma, Powell, + Penn, Surf. Int. Anal. 17, 911 + 927 (1991); 21, 165 (1994)
Powell + Jablonski, J. Phys. Chem. Ref. Data 28, 19 (1999); Surf. Int. Anal. 29, 108 (2000)





More realistic look at low-energy inelastic mean free paths--theory

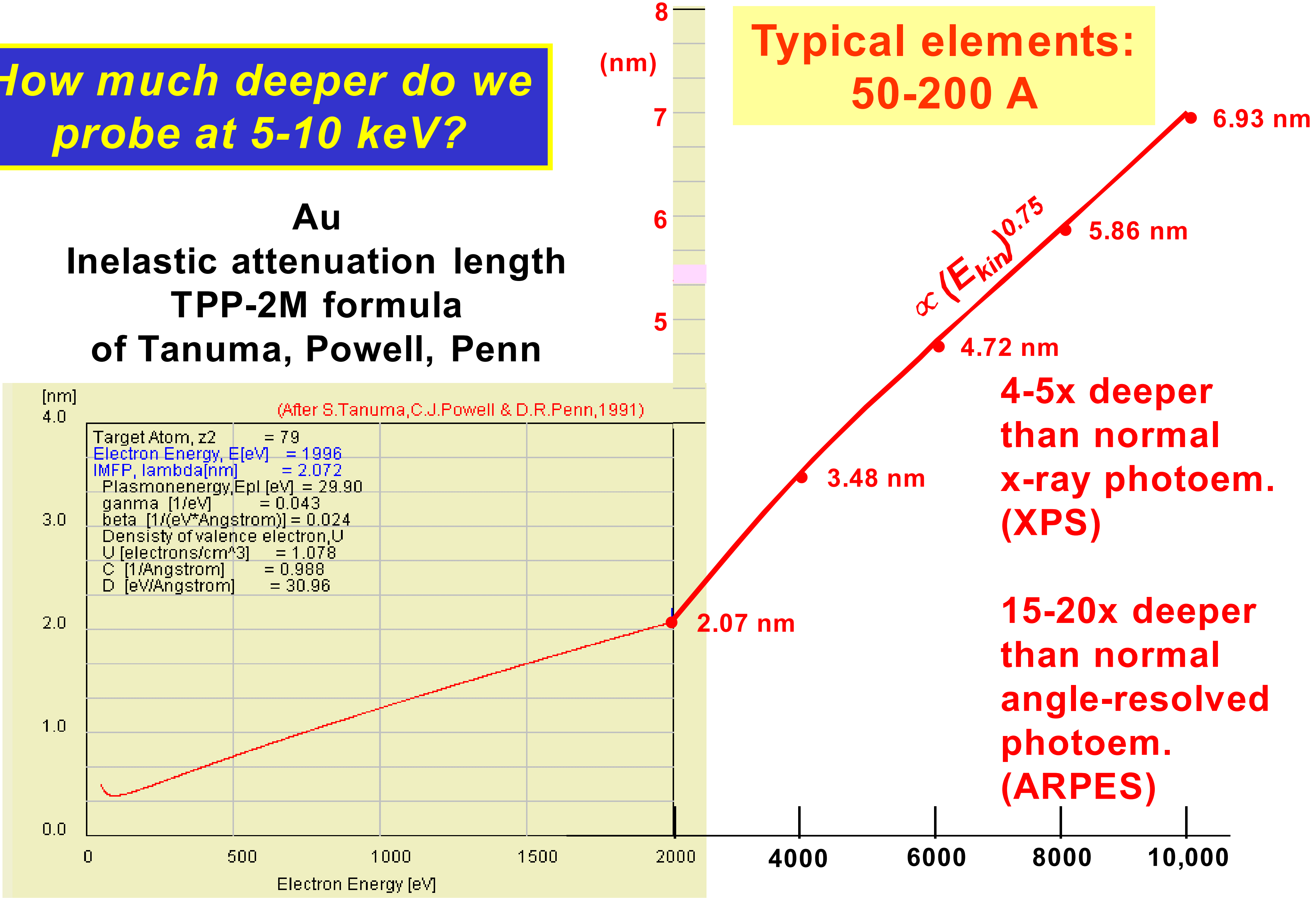


IMFPs do not necessarily go up drastically at lower energy

S.F. Mao and Z.J. Ding, Hefei (TBP)

How much deeper do we probe at 5-10 keV?

Au
Inelastic attenuation length
TPP-2M formula
of Tanuma, Powell, Penn



(After S.Tanuma,C.J.Powell & D.R.Penn,1991)

```
Target Atom, z2          = 79
Electron Energy, E[eV]    = 1996
IMFP, lambda[nm]          = 2.072
  Plasmonenergy,Epl [eV]  = 29.90
  ganma  [1/eV]           = 0.043
  beta  [1/(eV*Angstrom)] = 0.024
  Densisty of valence electron,U
  U [electrons/cm^3]      = 1.078
  C  [1/Angstrom]         = 0.988
  D  [eV/Angstrom]        = 30.96
```

Typical elements:
50-200 A

4-5x deeper
than normal
x-ray photoem.
(XPS)

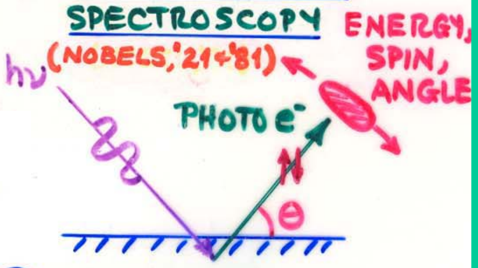
15-20x deeper
than normal
angle-resolved
photoem.
(ARPES)

http://www.ss.teen.setsunan.ac.jp/e-imfp.html

SOME SURFACE-ANALYTICAL TECHNIQUES

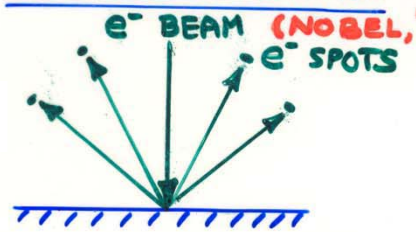
① PHOTOELECTRON SPECTROSCOPY

(NOBELS,'21+'81)

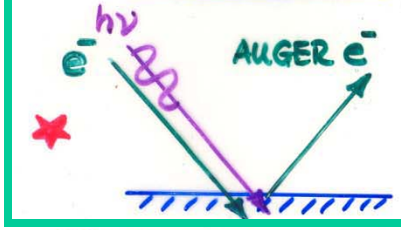


② LOW-ENERGY ELECTRON DIFFRACTION

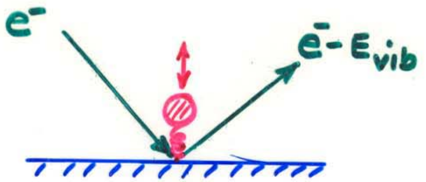
(NOBEL,'37)



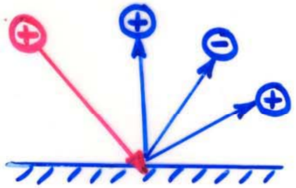
③ AUGER ELECTRON SPECTROSCOPY



④ LOW-ENERGY ELECTRON LOSS SPECTROSCOPY

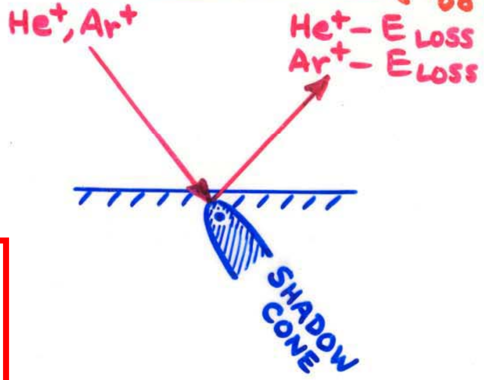


⑤ SECONDARY ION MASS SPECTROMETRY



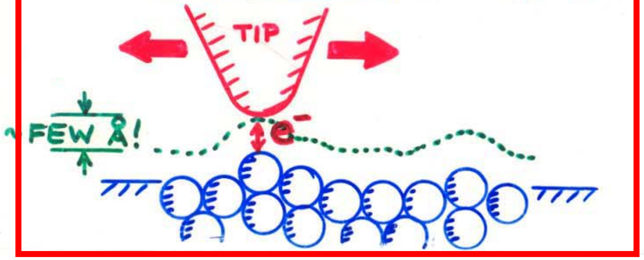
⑥ RUTHERFORD SCATT./ ION SCATTERING

(NOBEL, '08)

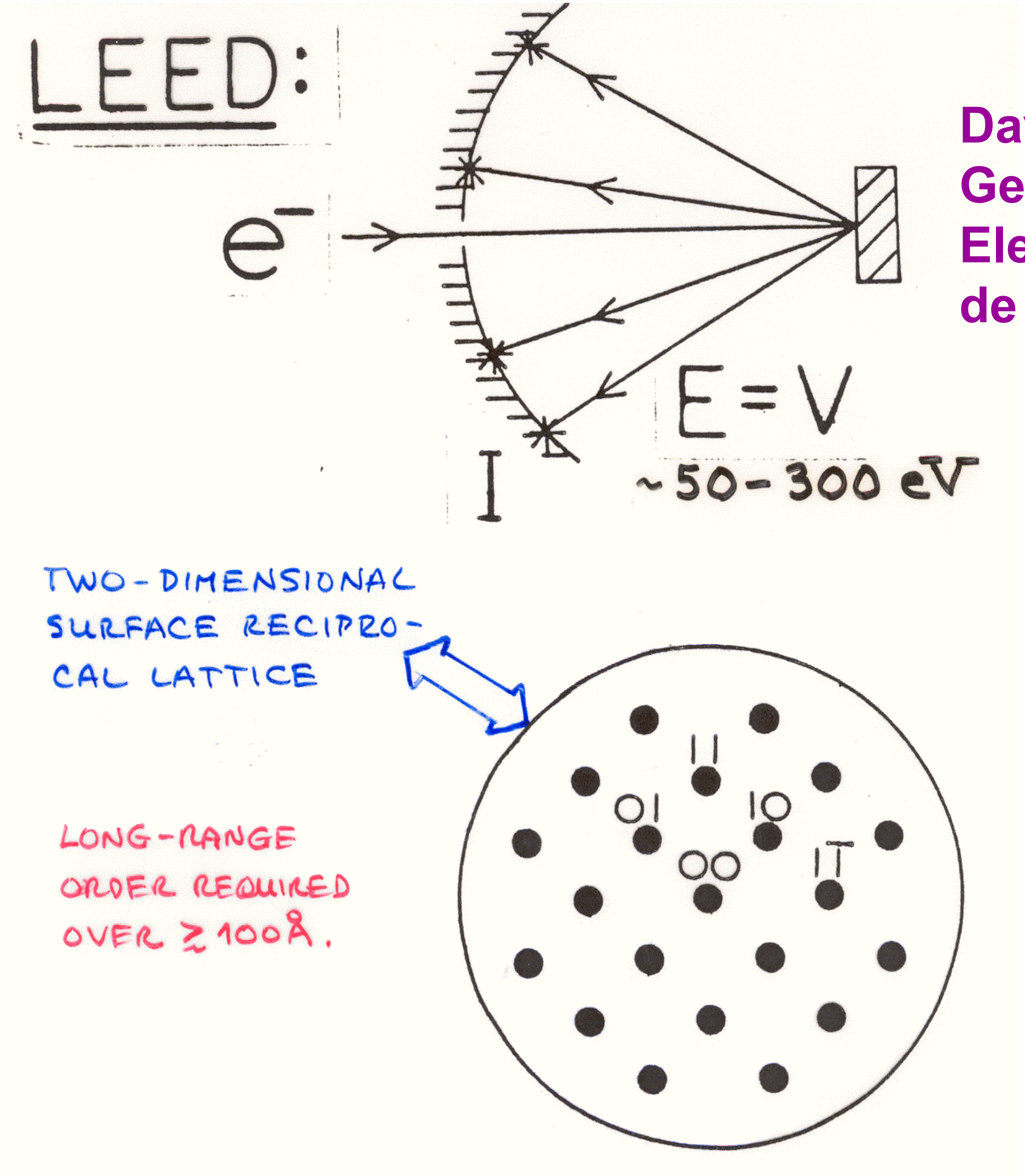


⑦ SCANNING TUNNELING MICROSCOPY

(NOBEL,'86)



LOW ENERGY ELECTRON DIFFRACTION

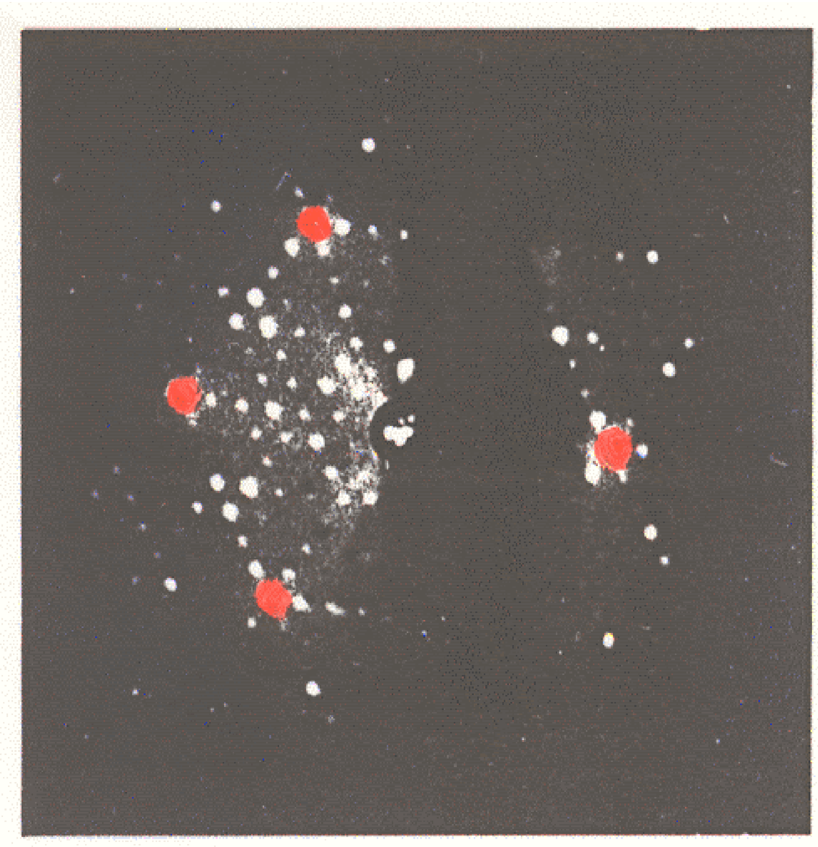


TWO-DIMENSIONAL SURFACE RECIPROCAL LATTICE

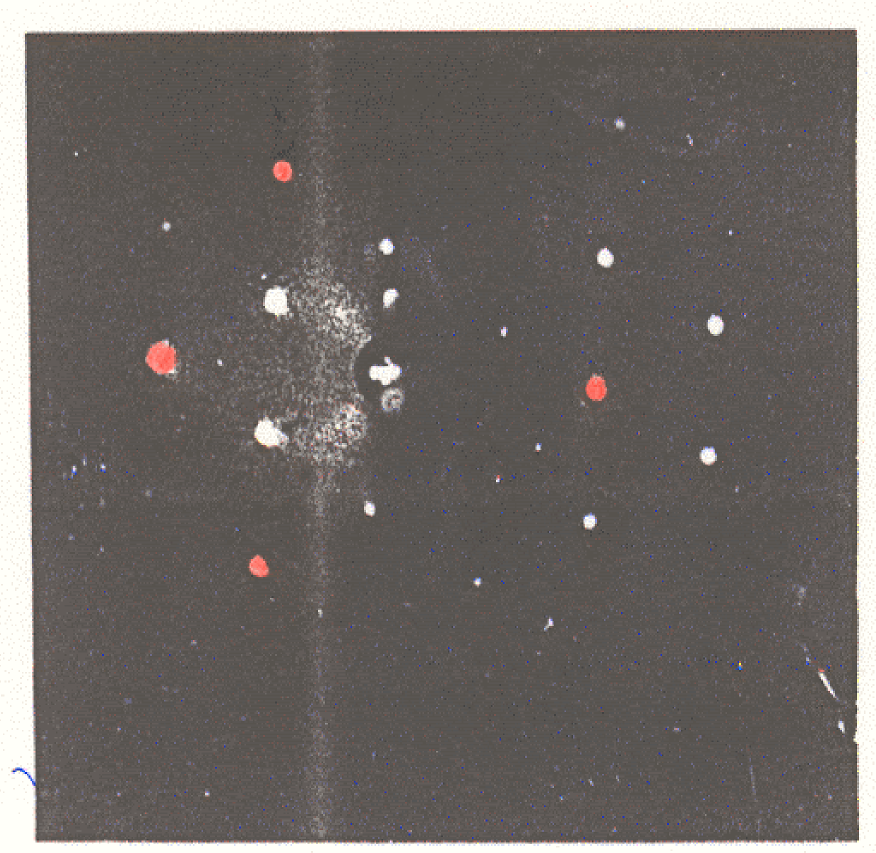
LONG-RANGE ORDER REQUIRED OVER ≳ 100Å.

Davisson & Germer (1927): Electrons are de Broglie waves

SOME TYPICAL LEED PATTERNS:



Si(111)-(7x7)



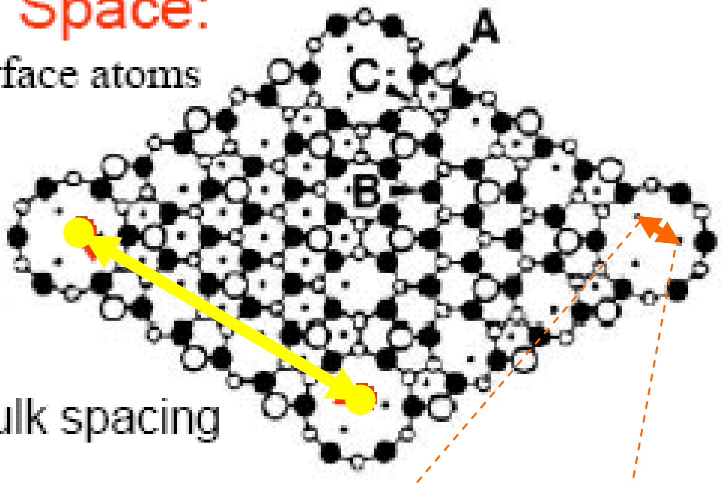
(√3 x √3)R30° Ag/Si(111)

● = spots seen without any reconstruction or adsorption of simple Si(111) surface

LEED: Si(111)7x7

Real Space:

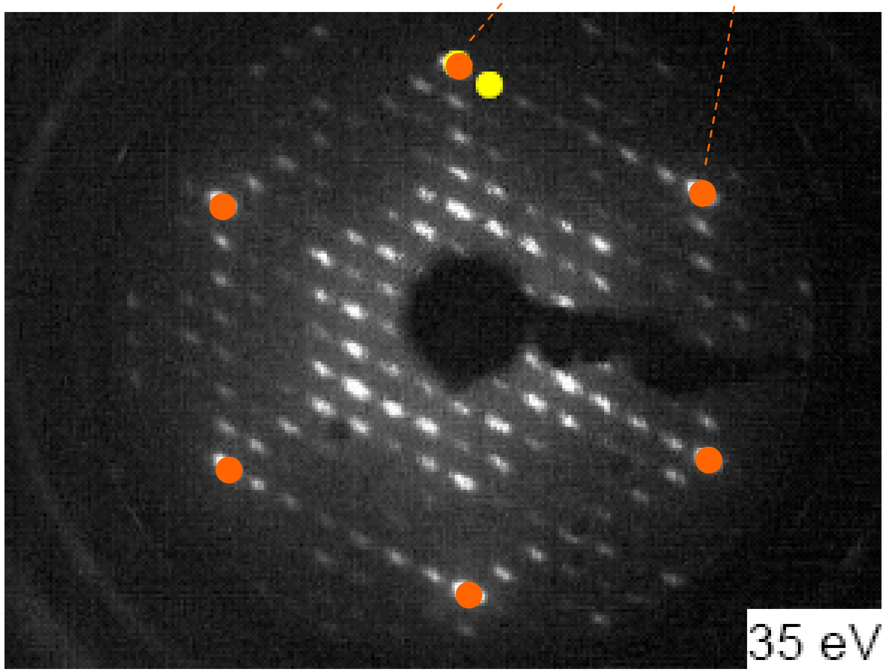
Si surface atoms

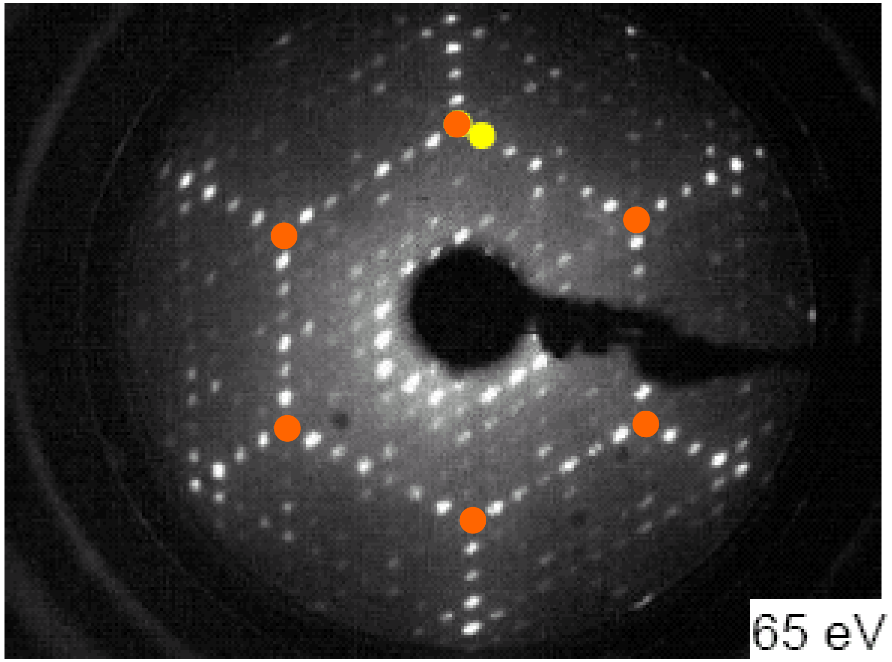


7× bulk spacing

- Longer periodicities in real space give closer spots in k-space.
- Higher energy LEED images show spots closer together.

K-Space





SCANNING TUNNELING MICROSCOPY

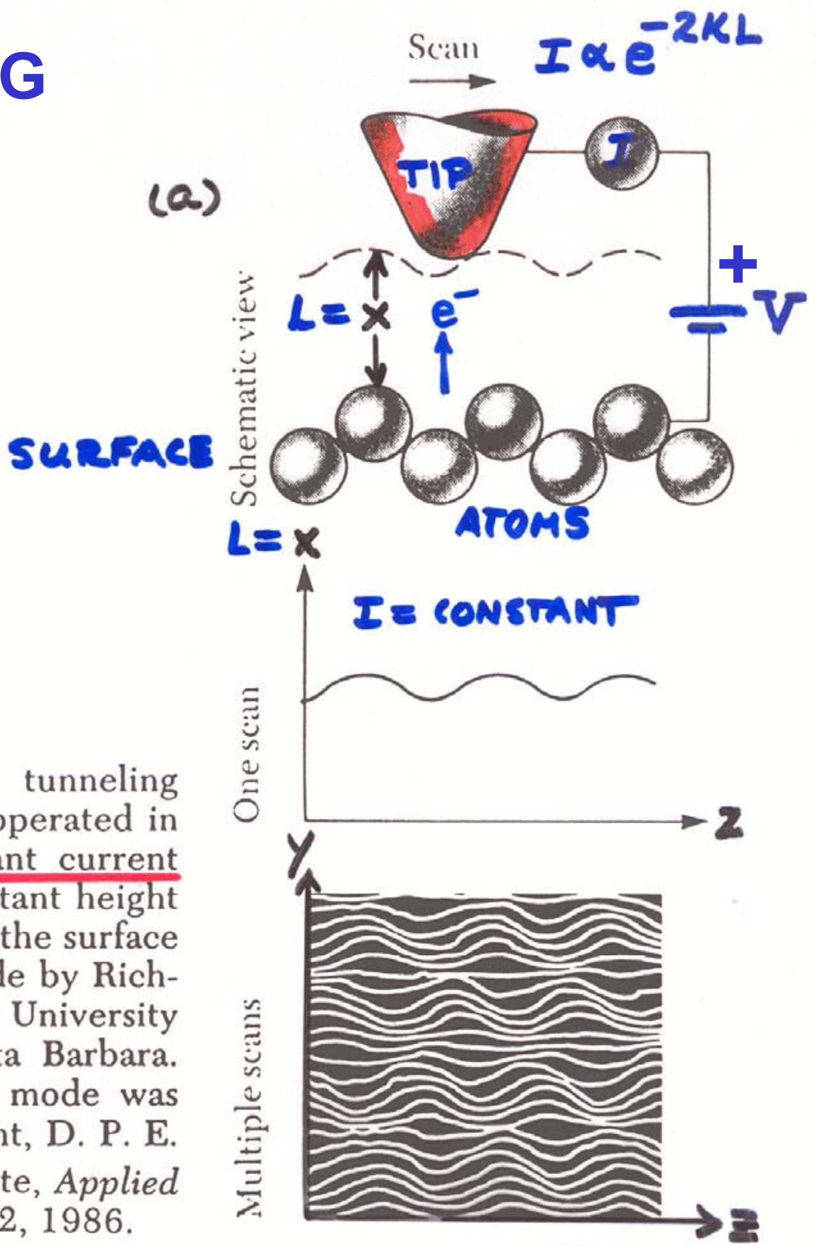
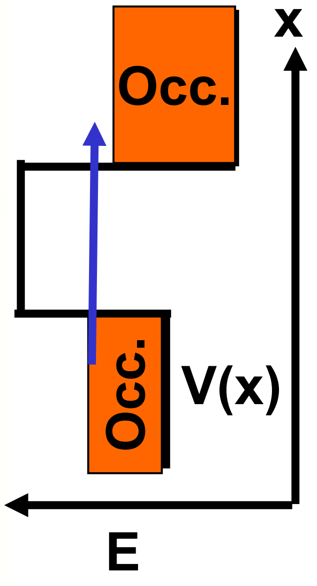


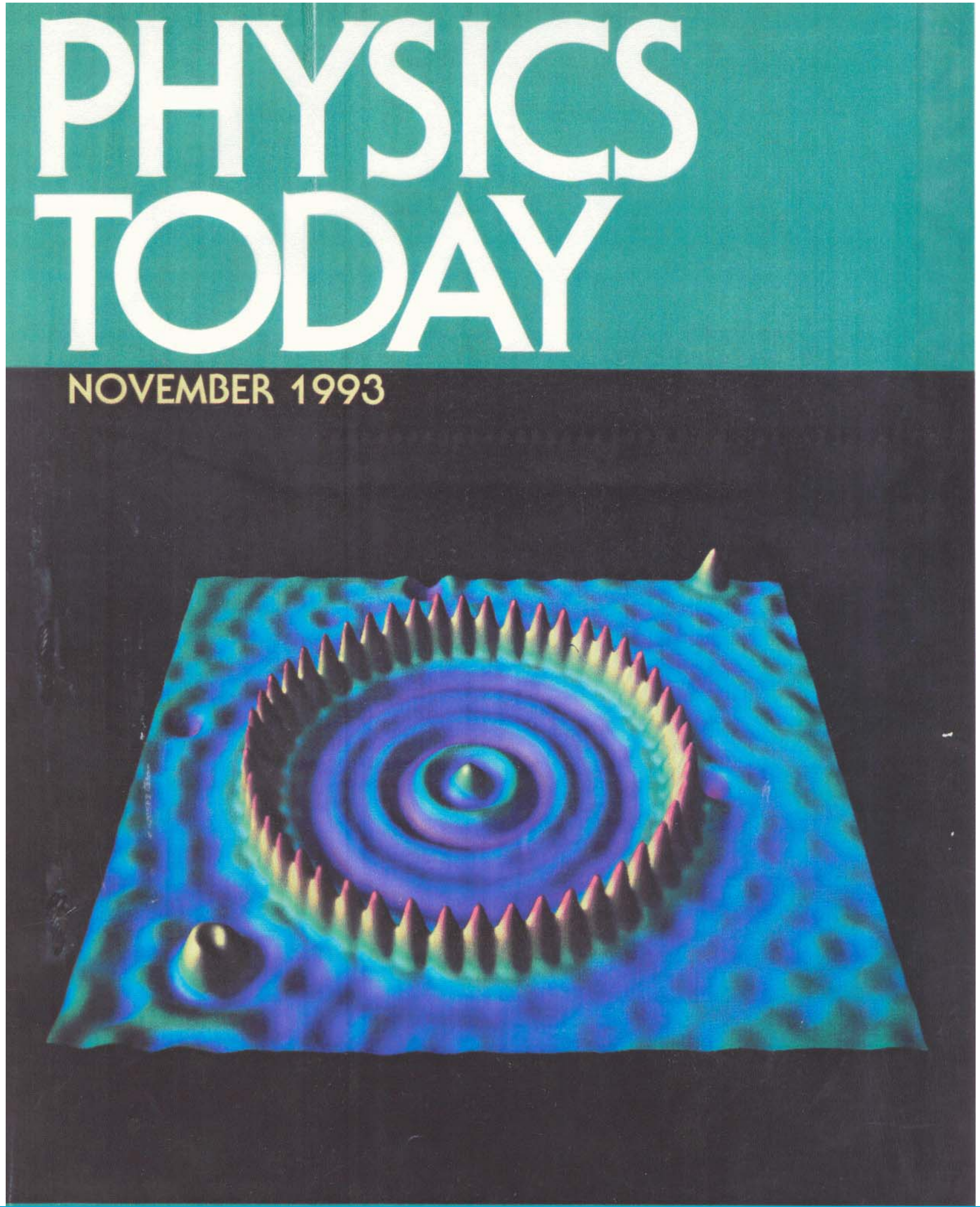
Figure 4 Scanning tunneling microscopes can be operated in either (a) the constant current mode or (b) the constant height mode. The images of the surface of graphite were made by Richard Sonnenfeld at the University of California at Santa Barbara. The constant height mode was first used by A. Bryant, D. P. E. Smith, and C. F. Quate, *Applied Physics Letters* 48: 832, 1986.

$\Delta x = \Delta L \approx 0.01\text{Å}!$

$\Delta y = \Delta z \approx 0.3\text{-}0.4\text{Å}$

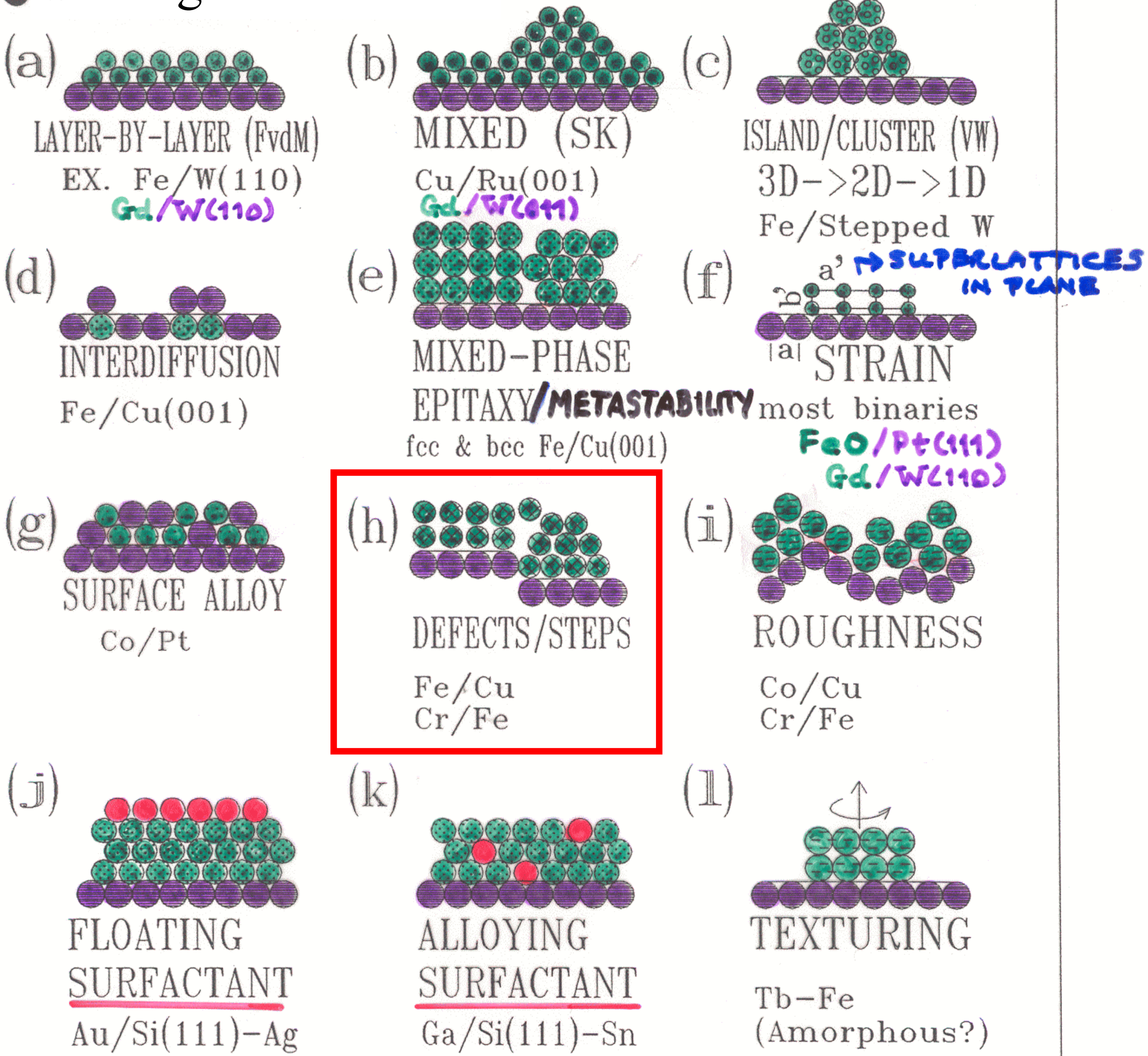


IMAGING, AND MANIPULATING, ATOMS AT SURFACES WITH THE STM



48 iron atoms on a Cu(111) surface—a “quantum corral”

- Some growth modes:



Scanning tunneling microscopy: stepped Si(111) surface

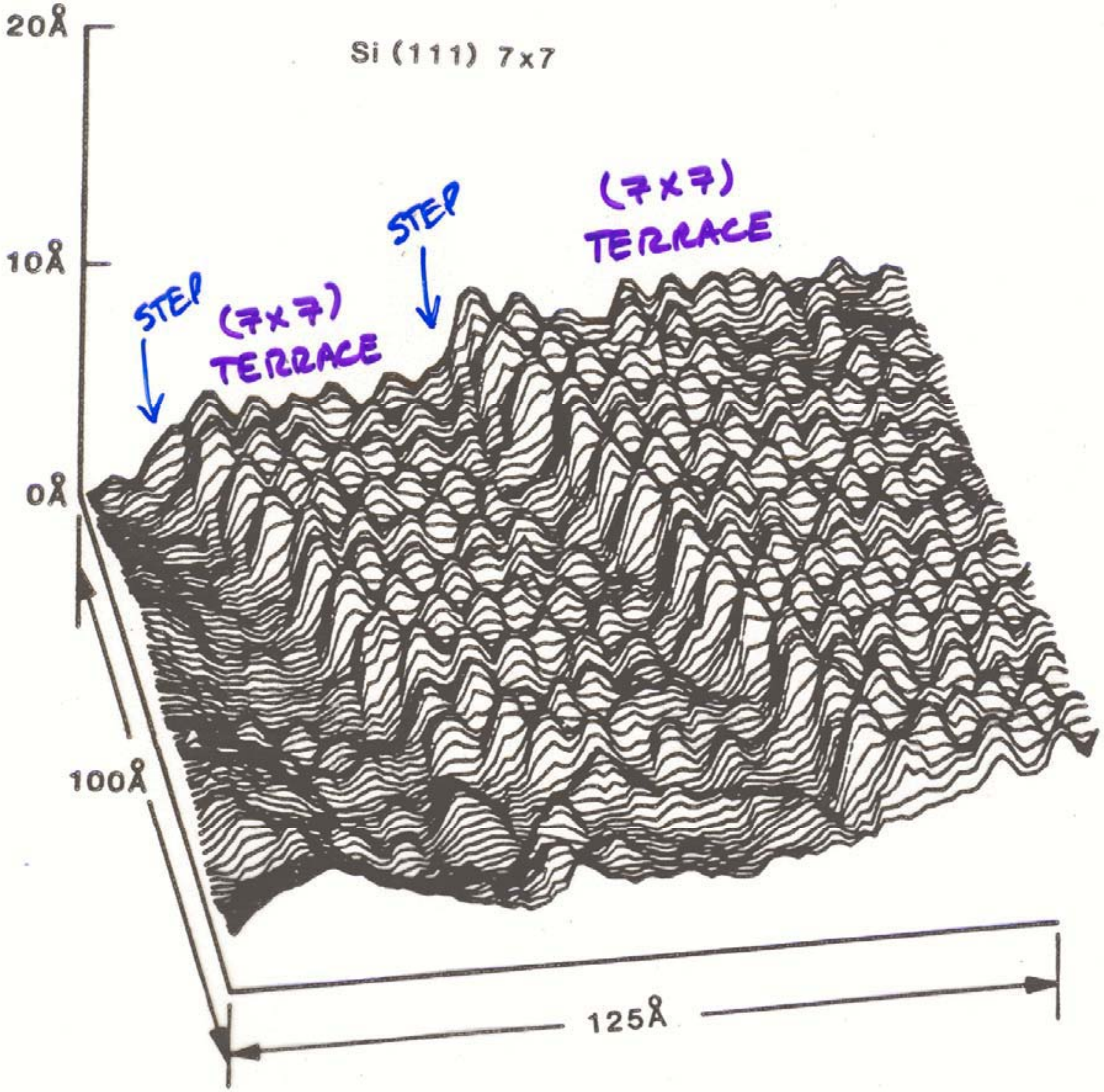
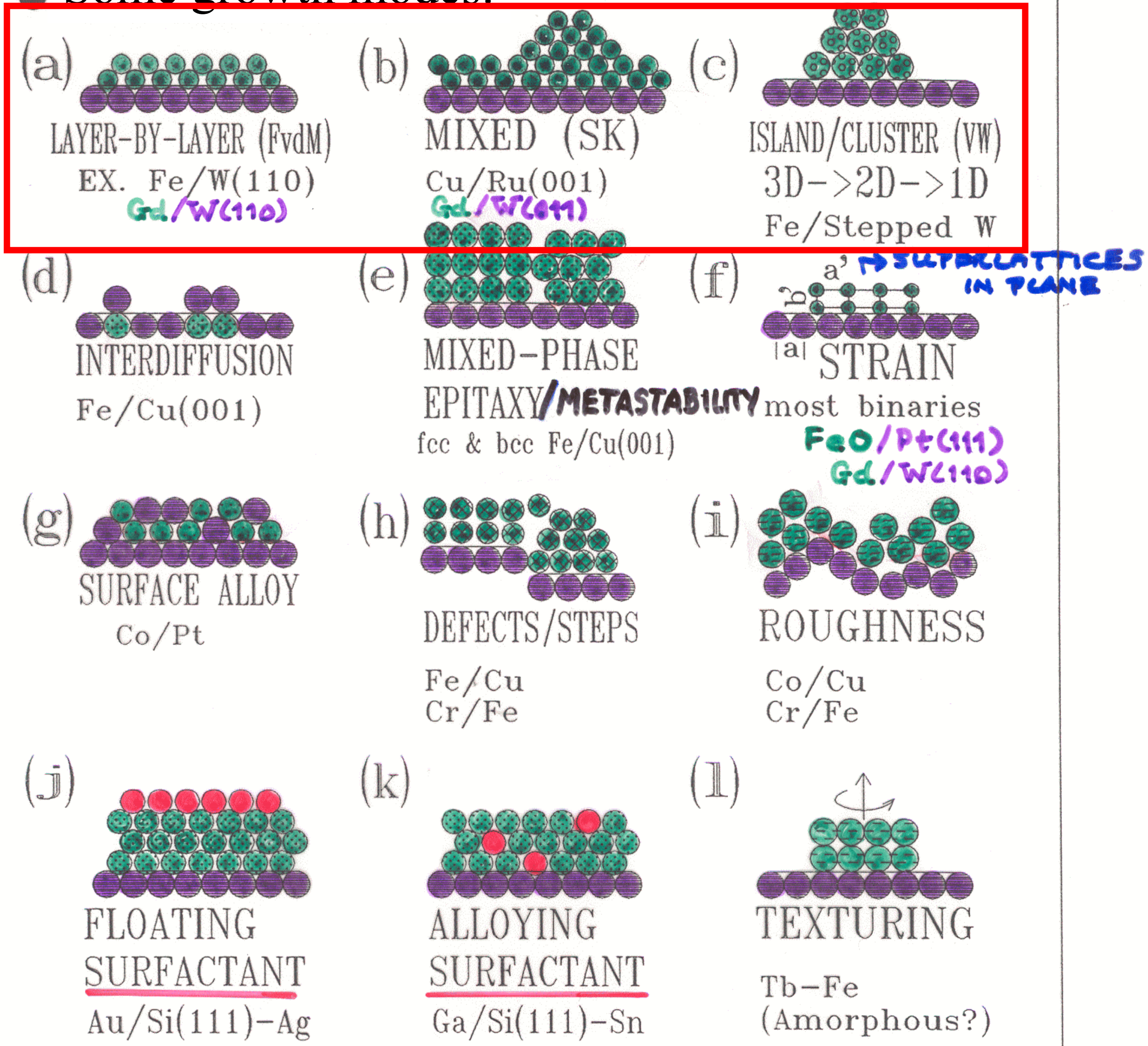
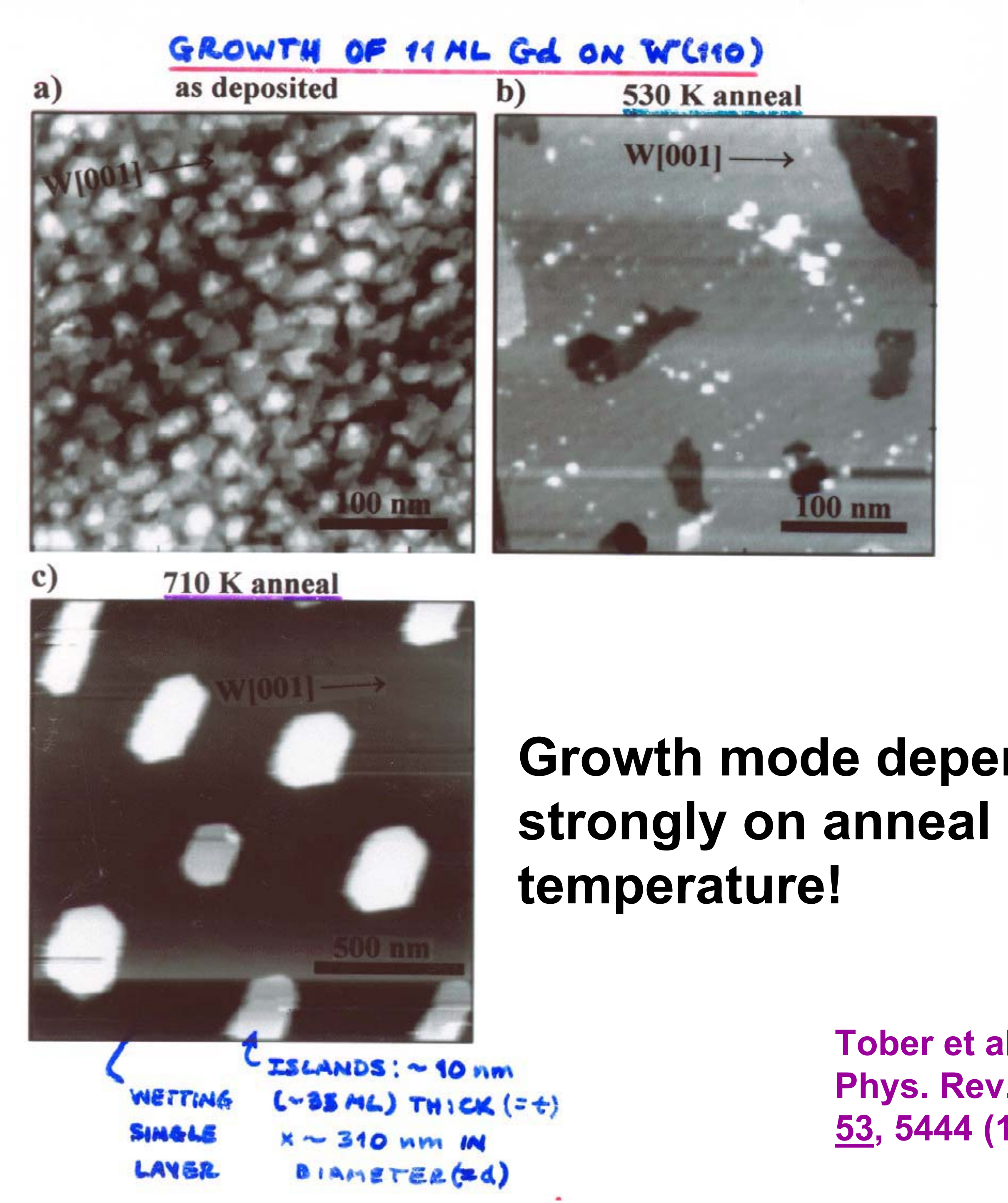


Fig. 2. Tunneling image of silicon (111) surface that shows the 7×7 atomic reconstruction on terraces separated by atomic steps.

- Some growth modes:



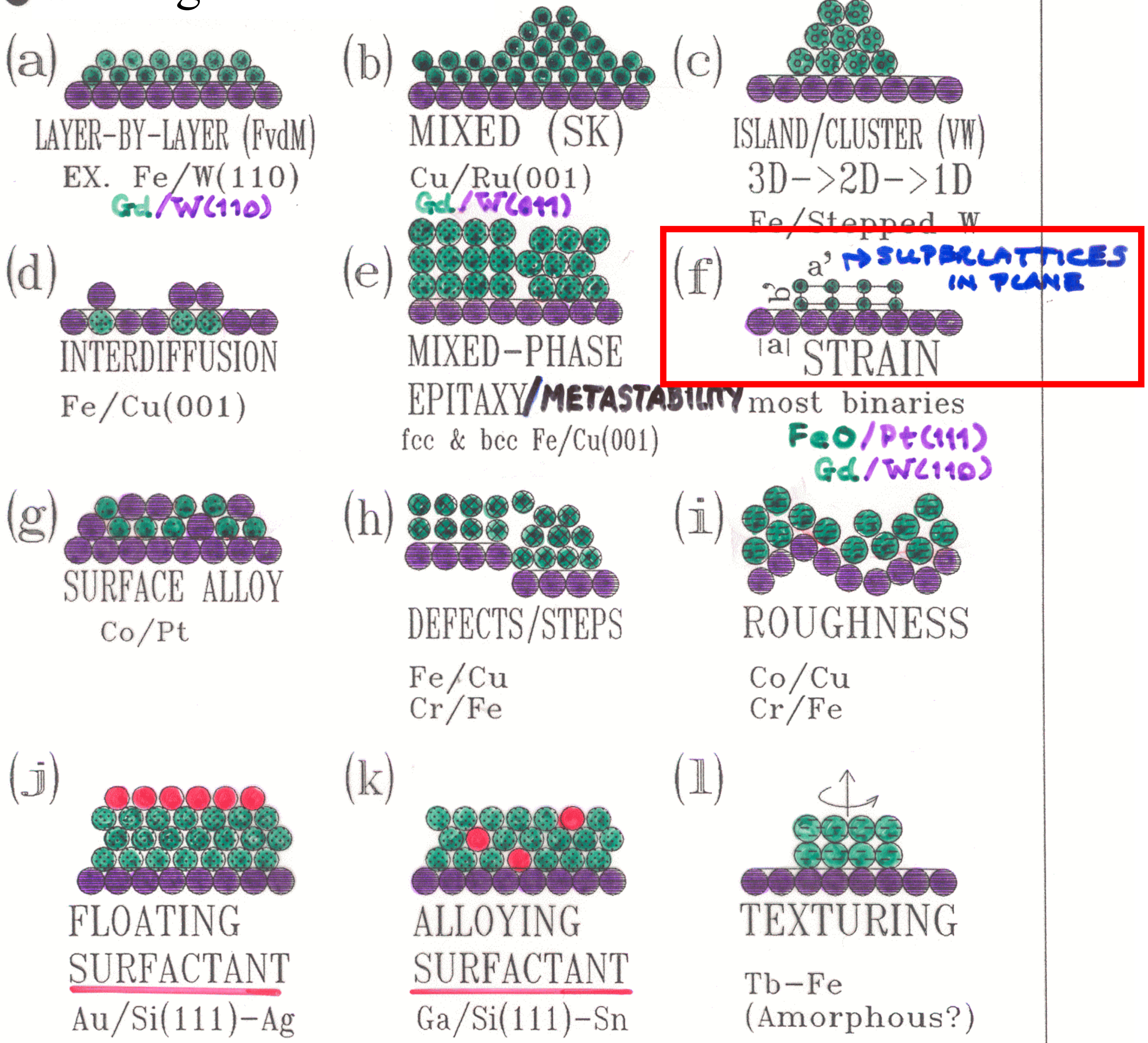
Scanning tunneling microscopy: metal-on-metal epitaxial growth



Growth mode depends strongly on anneal temperature!

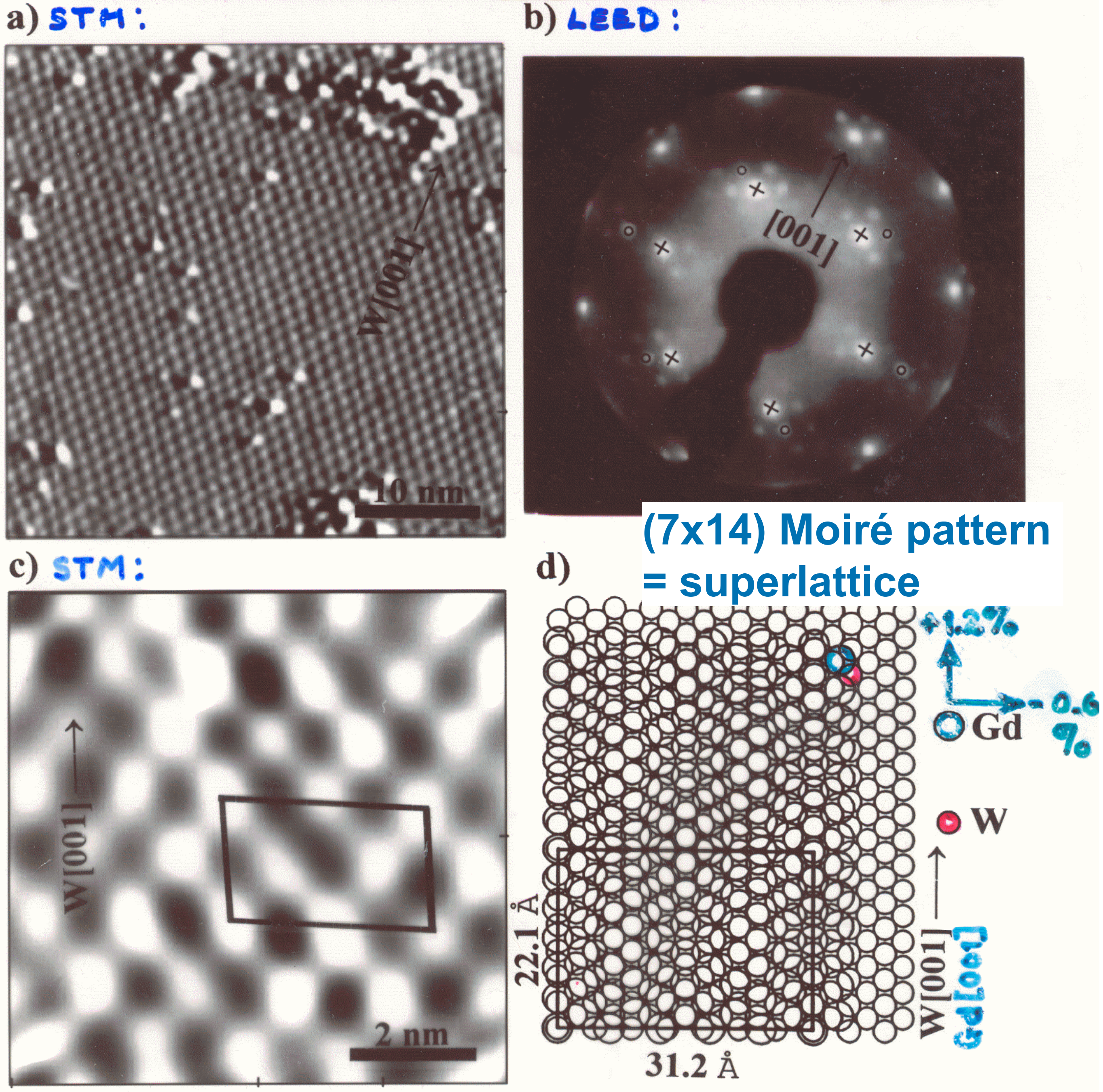
Tober et al.
Phys. Rev. B
53, 5444 (1996).

- Some growth modes:



Superlattice = Moiré structure in metal-on-metal epitaxial growth

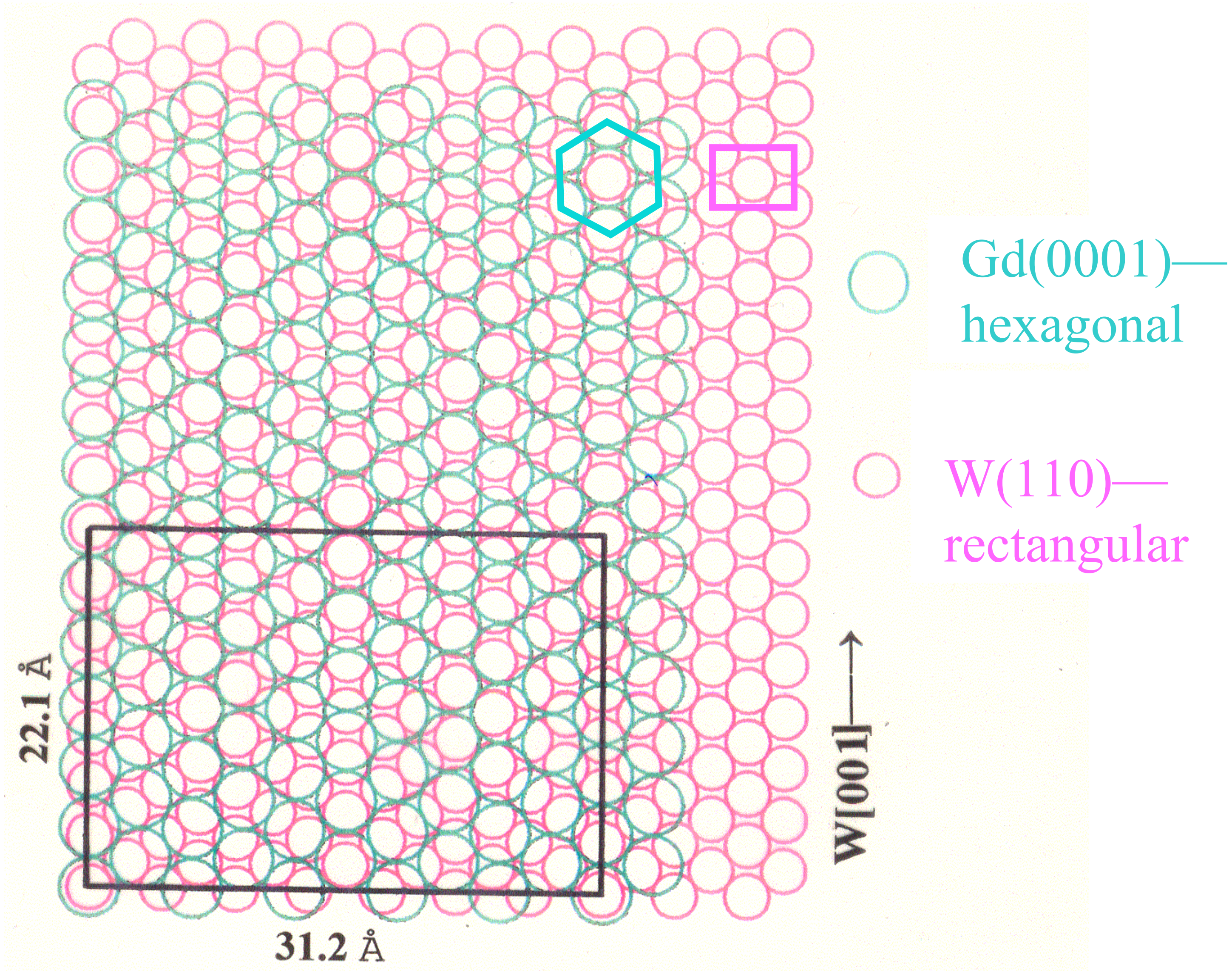
"WETTING" SINGLE MONOLAYER OF Gd ON W(110)



(7x14) Moiré pattern = superlattice

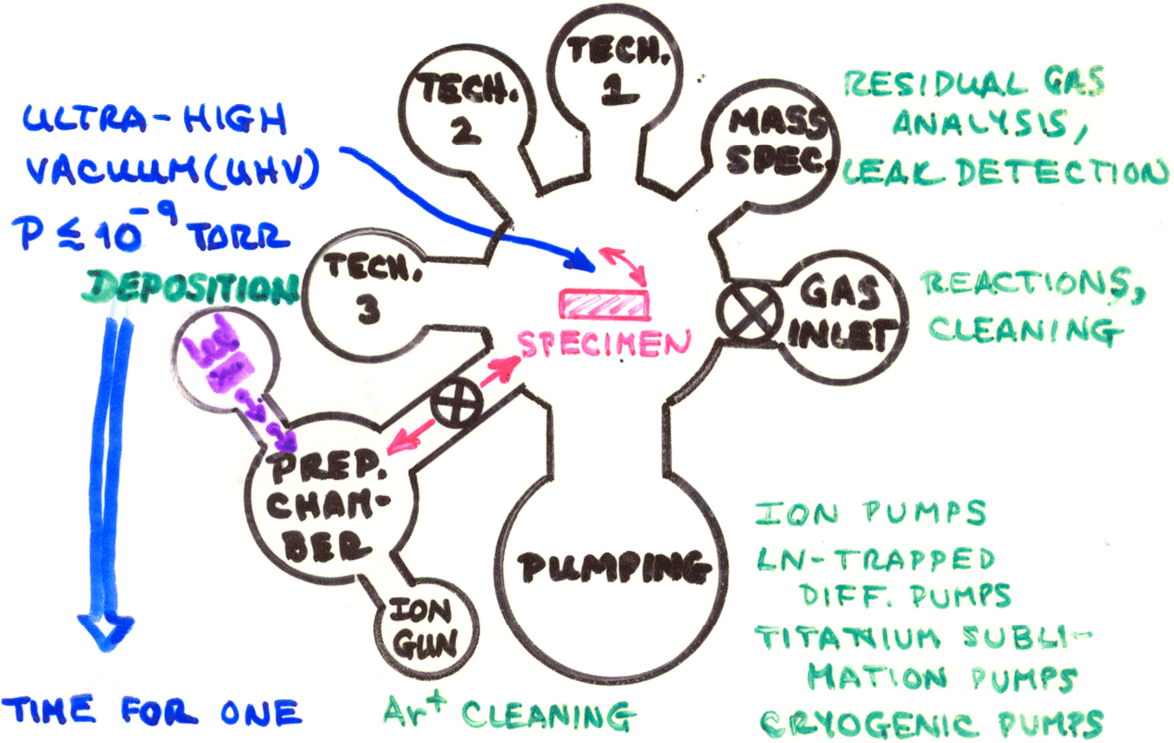
E. Tober et al.
Phys. Rev. B
53, 544 ('96)

A Moiré pattern—Monolayer Gd on W(110)



A typical surface science research system

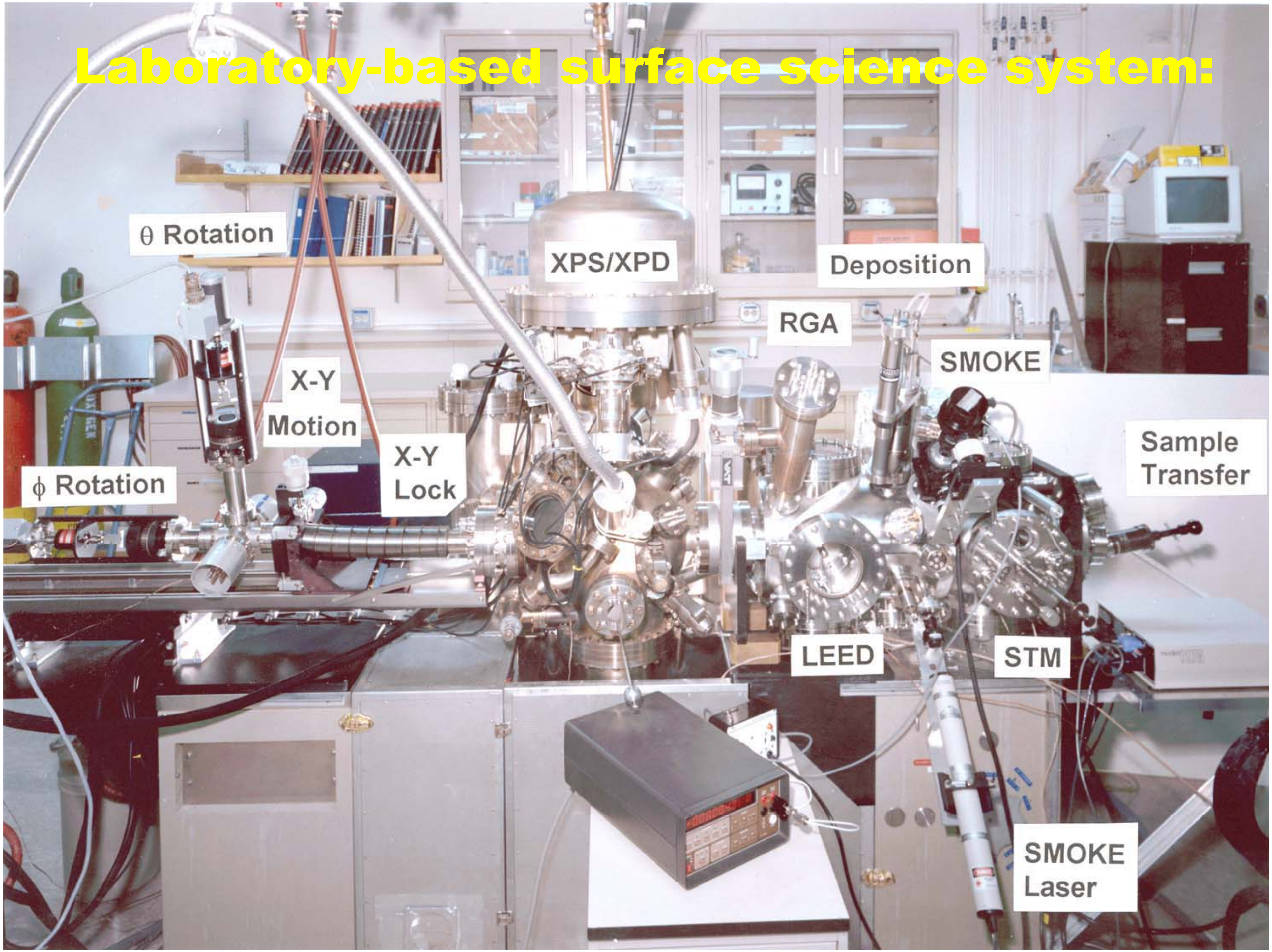
≥ 1 TECHNIQUE: SURFACE SENSITIVE (e^-, IONS, ATOMS AS PROBES)
NON-DESTRUCTIVE



~TIME FOR ONE MONOLAYER:

t	P(torr)
10^{-9} sec	1 atm = 760
25 sec	10^{-7}
40 min	10^{-9}
2.8 days	10^{-11}

Laboratory-based surface science system:



Outline

Surface, interface, and nanoscience—short introduction

Some surface concepts and techniques→photoemission

➡ Synchrotron radiation: experimental aspects

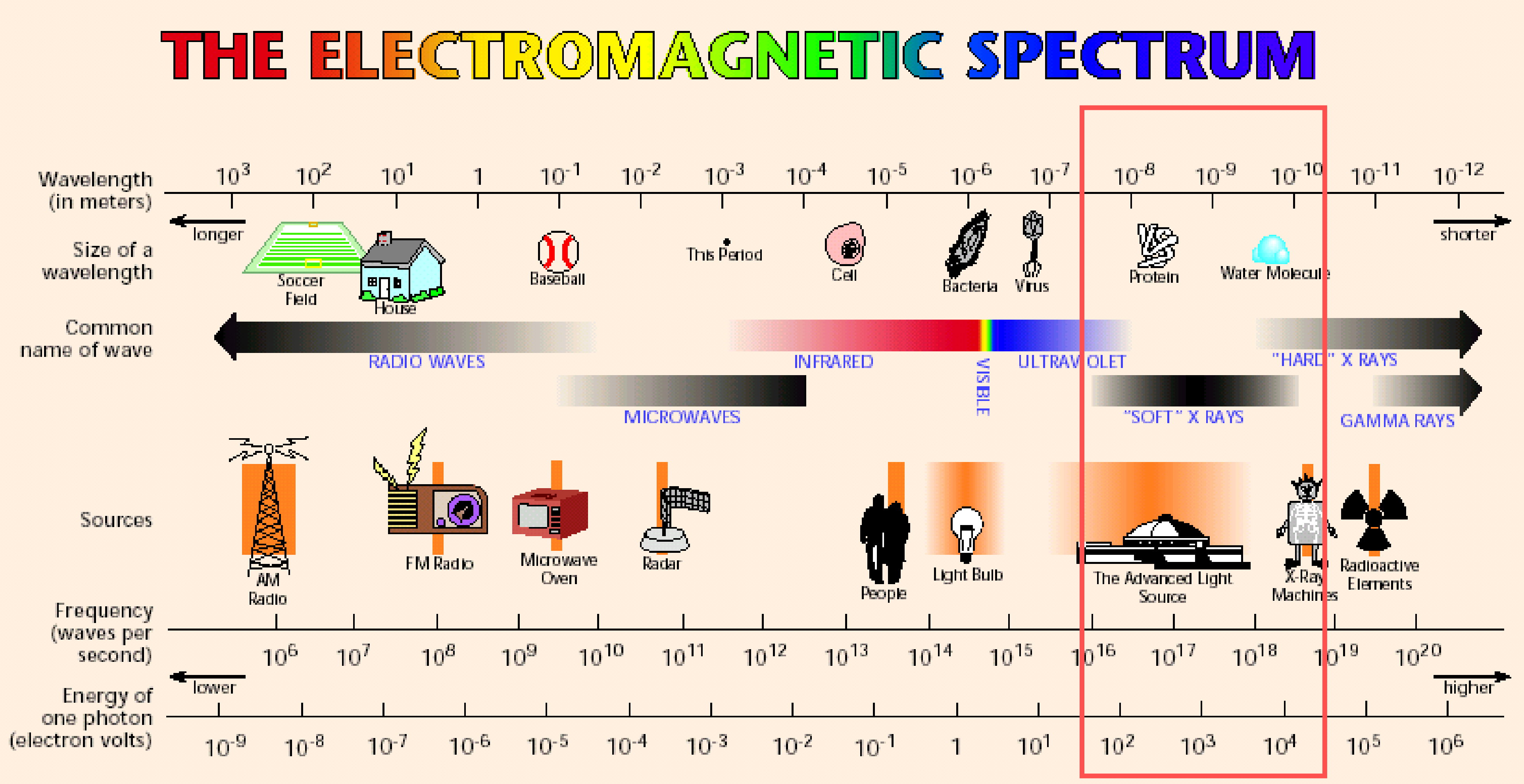
Electronic structure—a brief review

The basic synchrotron radiation techniques:
more experimental and theoretical details

Valence-level photoemission

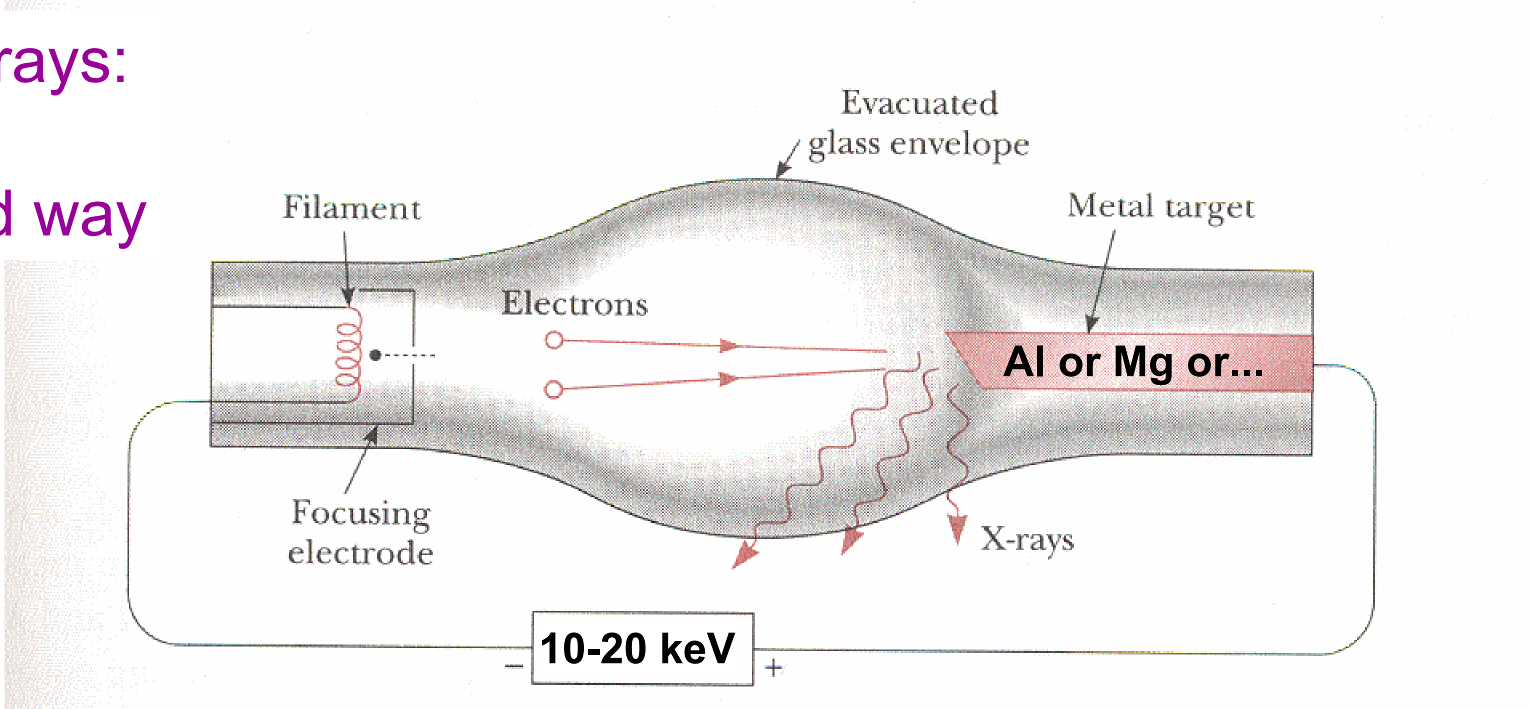
Core-level photoemission

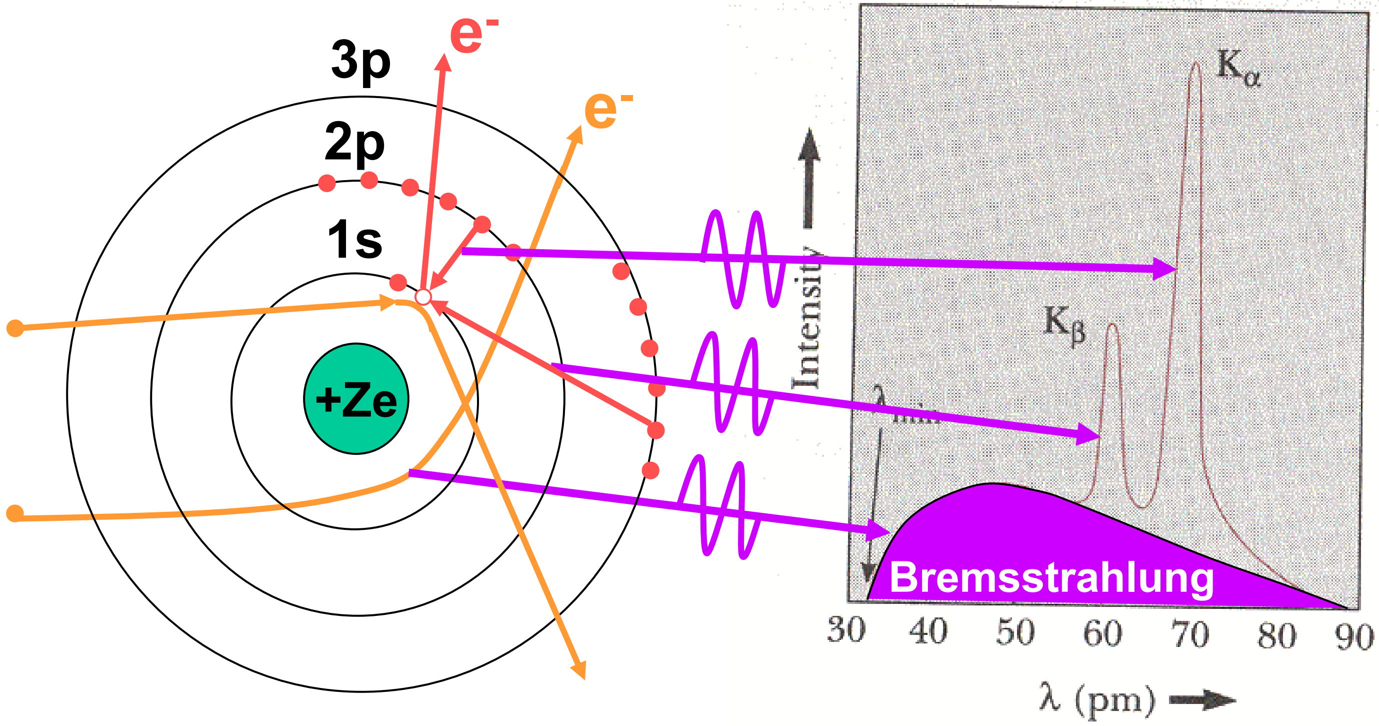
Photoemission with high ambient pressure
around the sample



Typical surface/materials science expts.

Producing x-rays: the good old-fashioned way





See Section 1.2 in "X-Ray Data Booklet"

X-Ray Nomenclature (from “X-Ray Data Booklet”)

In general:

$nl \longrightarrow \text{Spin-orbit} \begin{cases} nl_{j=l+1/2} \\ nl_{j=l-1/2} \end{cases}$

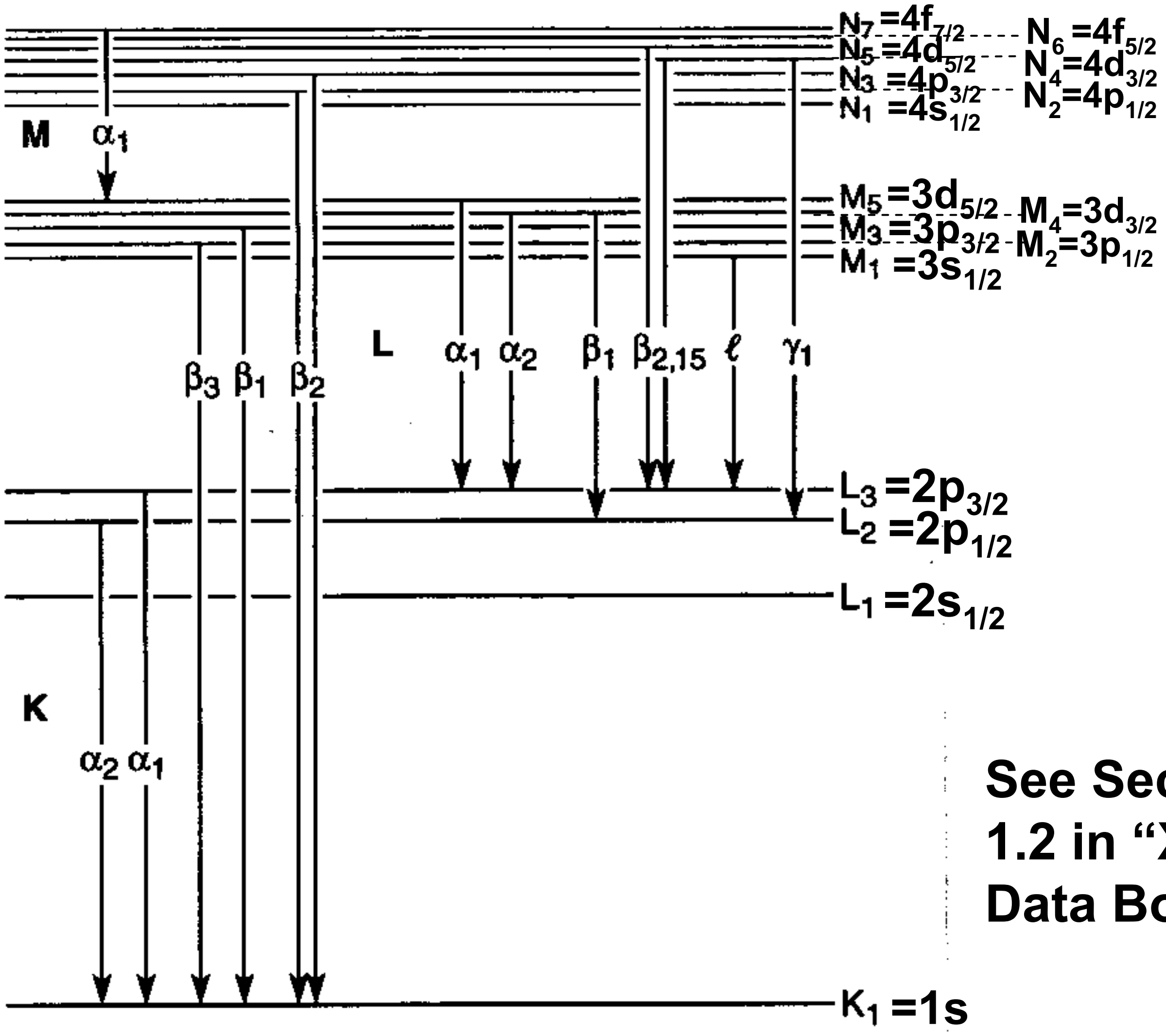


Fig. 1-1. *Transitions that give rise to the emission lines in Table 1-3.*

See Section 1.2 in “X-Ray Data Booklet”

X-Ray energies from the "X-Ray Data Booklet"

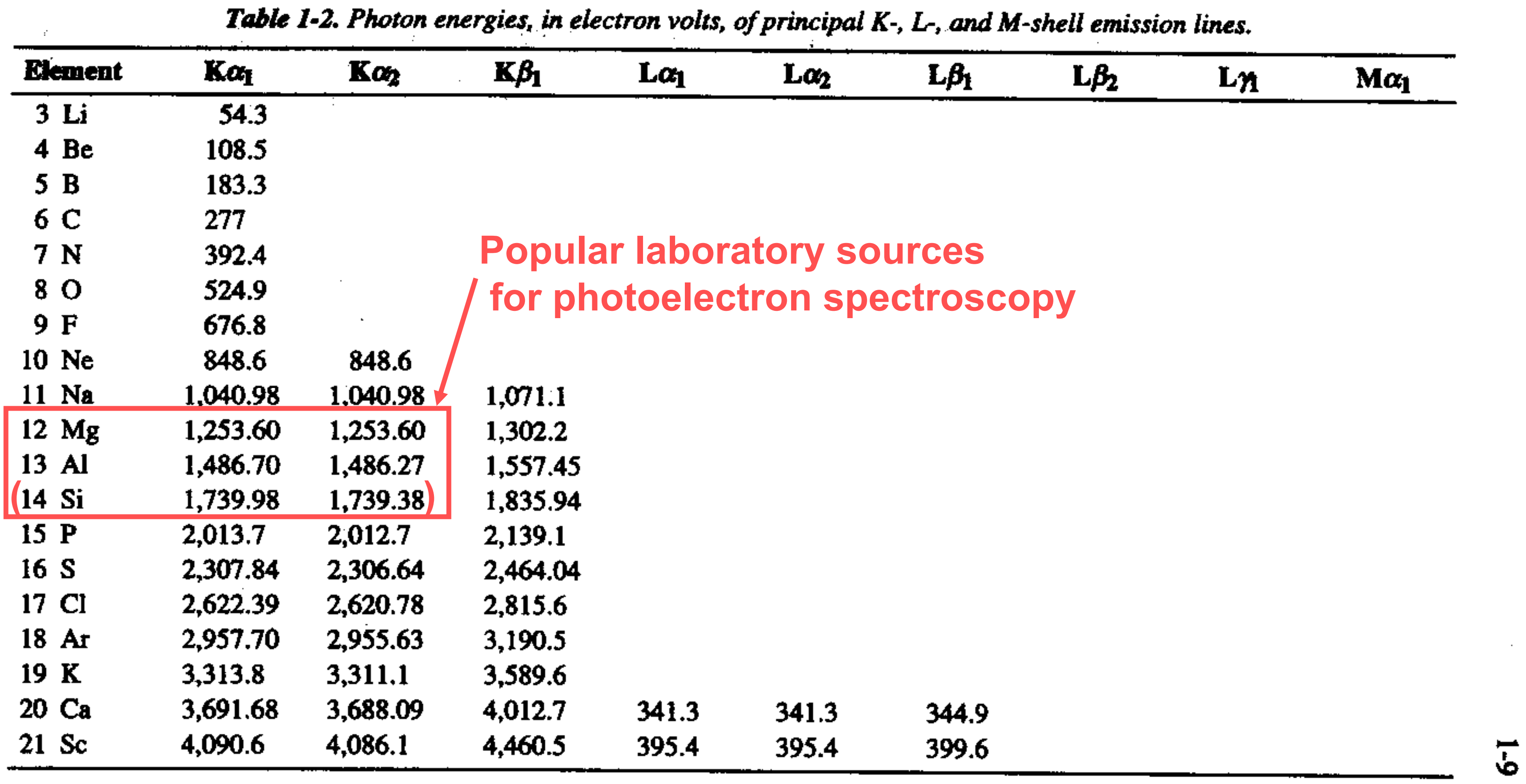
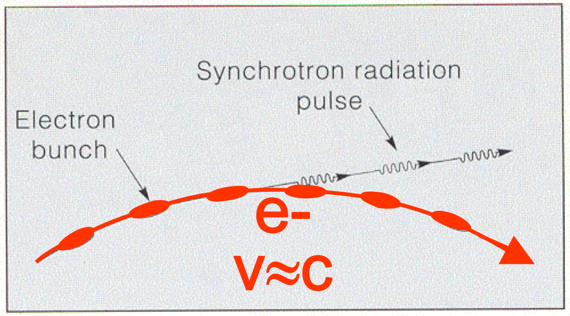


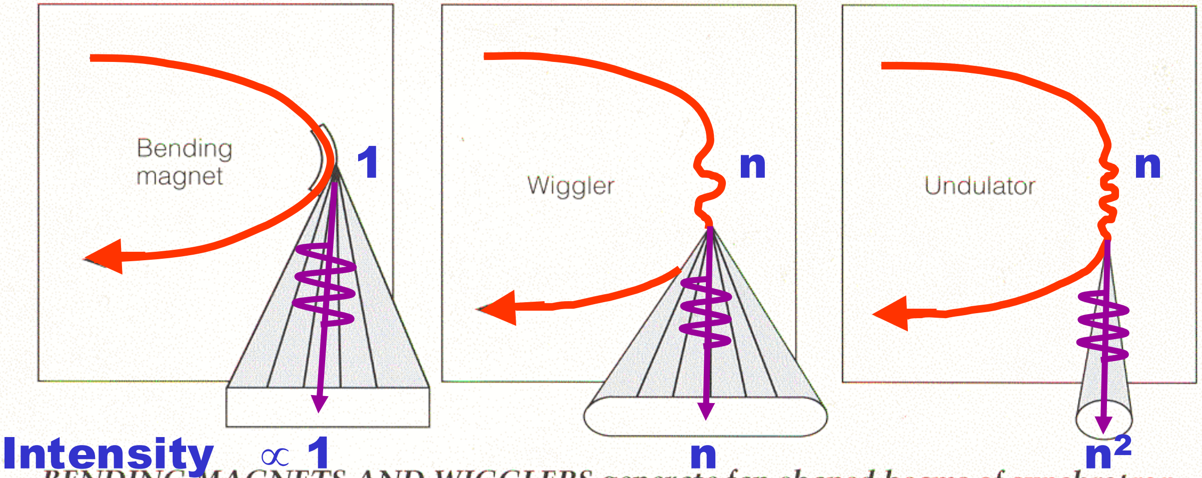
Table 1-2. Photon energies, in electron volts, of principal K-, L-, and M-shell emission lines.

Element	$K\alpha_1$	$K\alpha_2$	$K\beta_1$	$L\alpha_1$	$L\alpha_2$	$L\beta_1$	$L\beta_2$	$L\gamma_1$	$M\alpha_1$
3 Li	54.3								
4 Be	108.5								
5 B	183.3								
6 C	277								
7 N	392.4								
8 O	524.9								
9 F	676.8								
10 Ne	848.6	848.6							
11 Na	1,040.98	1,040.98	1,071.1						
12 Mg	1,253.60	1,253.60	1,302.2						
13 Al	1,486.70	1,486.27	1,557.45						
14 Si	1,739.98	1,739.38	1,835.94						
15 P	2,013.7	2,012.7	2,139.1						
16 S	2,307.84	2,306.64	2,464.04						
17 Cl	2,622.39	2,620.78	2,815.6						
18 Ar	2,957.70	2,955.63	3,190.5						
19 K	3,313.8	3,311.1	3,589.6						
20 Ca	3,691.68	3,688.09	4,012.7	341.3	341.3	344.9			
21 Sc	4,090.6	4,086.1	4,460.5	395.4	395.4	399.6			

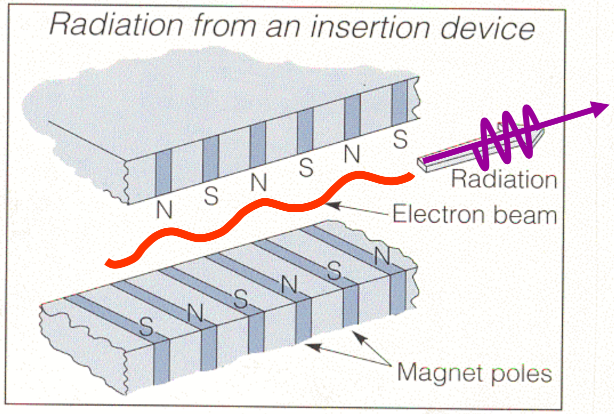
Popular laboratory sources for photoelectron spectroscopy

Synchrotron Radiation Sources:



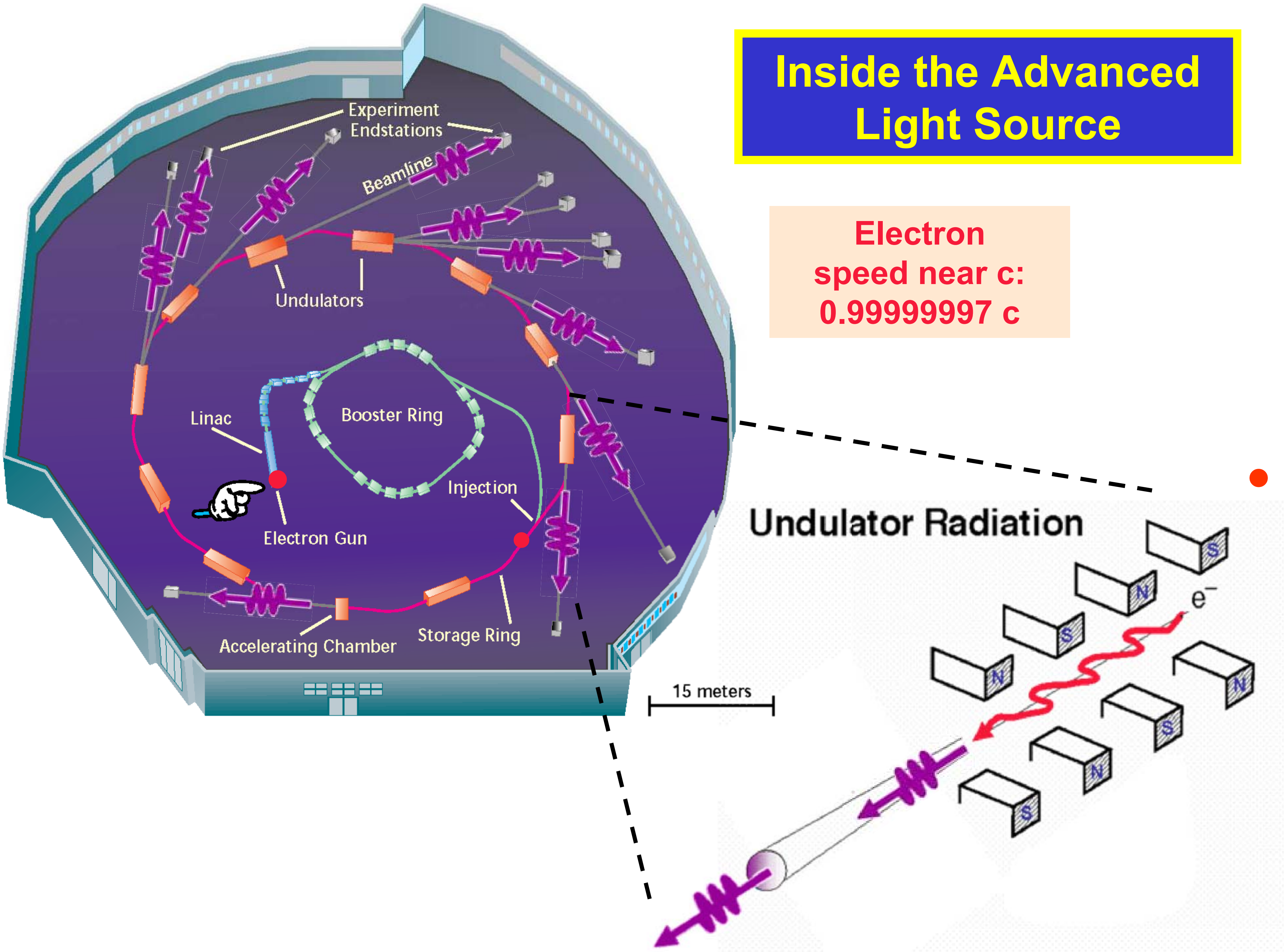


BENDING MAGNETS AND WIGGLERS generate fan-shaped beams of synchrotron radiation, whereas undulators emit pencil-thin beams.



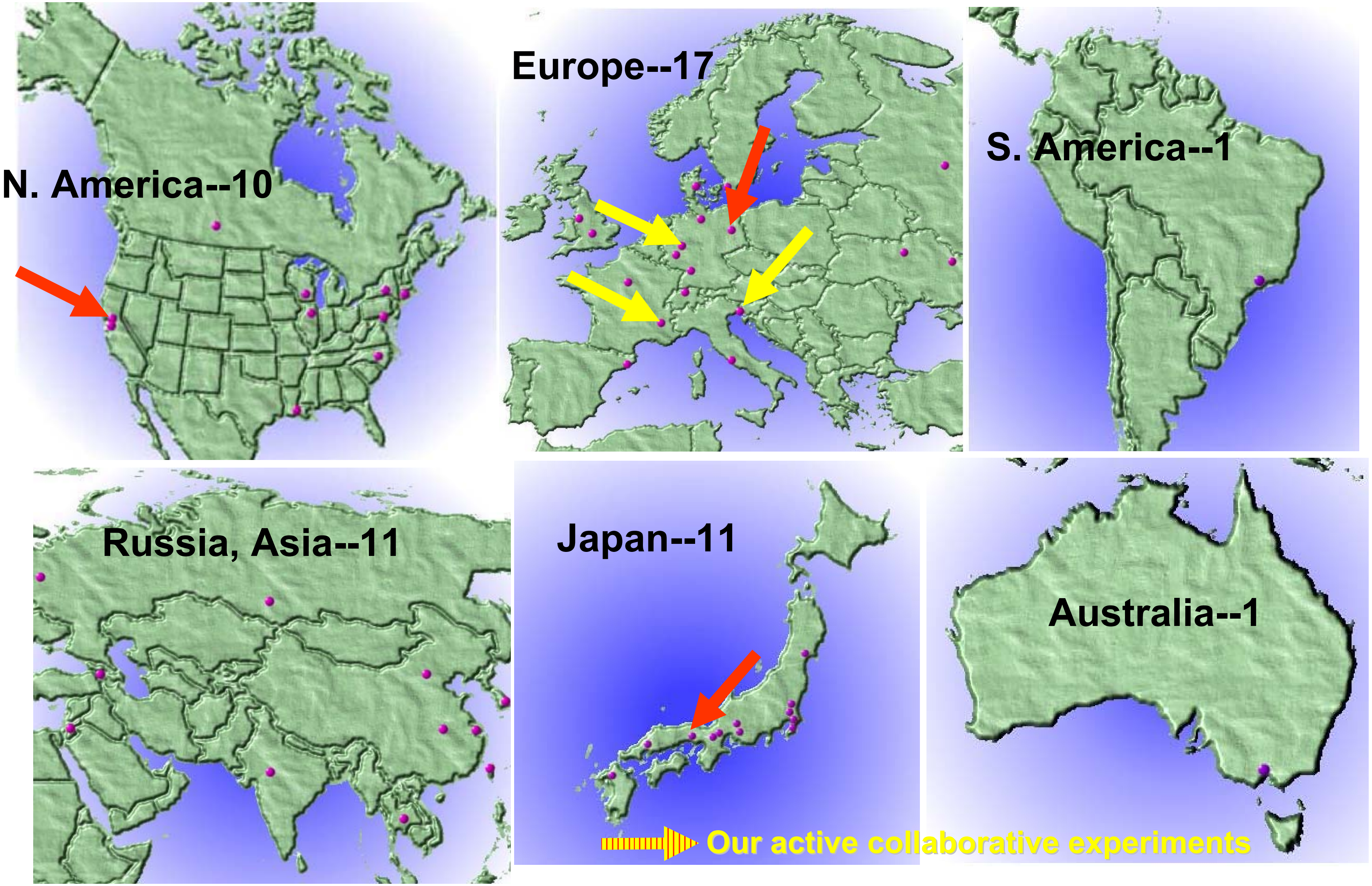
Inside the Advanced Light Source

Electron speed near c: 0.99999997 c



Our primary experimental activity

Synchtron Radiation Sources of the World: ~ 40 operating, 10 planned

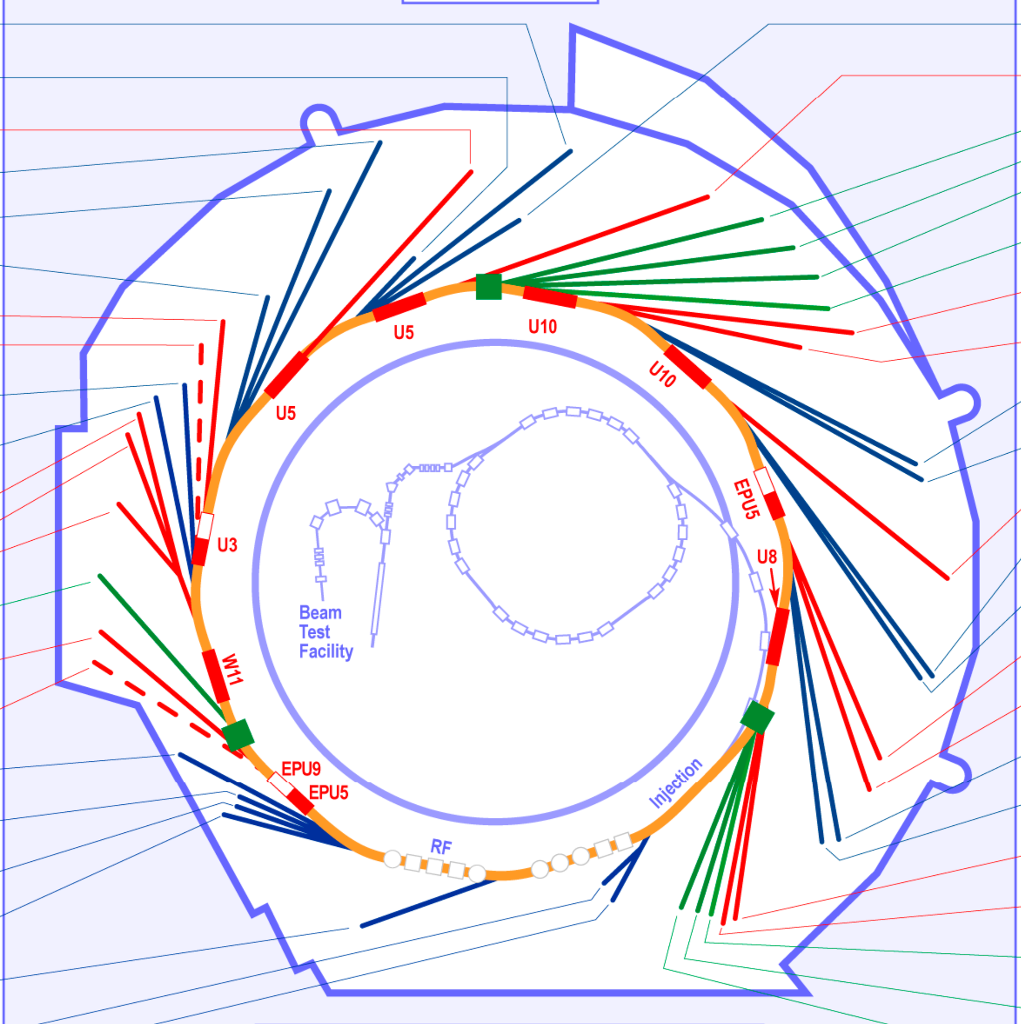


http://www.srs.ac.uk/srs/SRworldwide/

Beamlines at the ALS 2007

BERKELEY LAB

December 2007

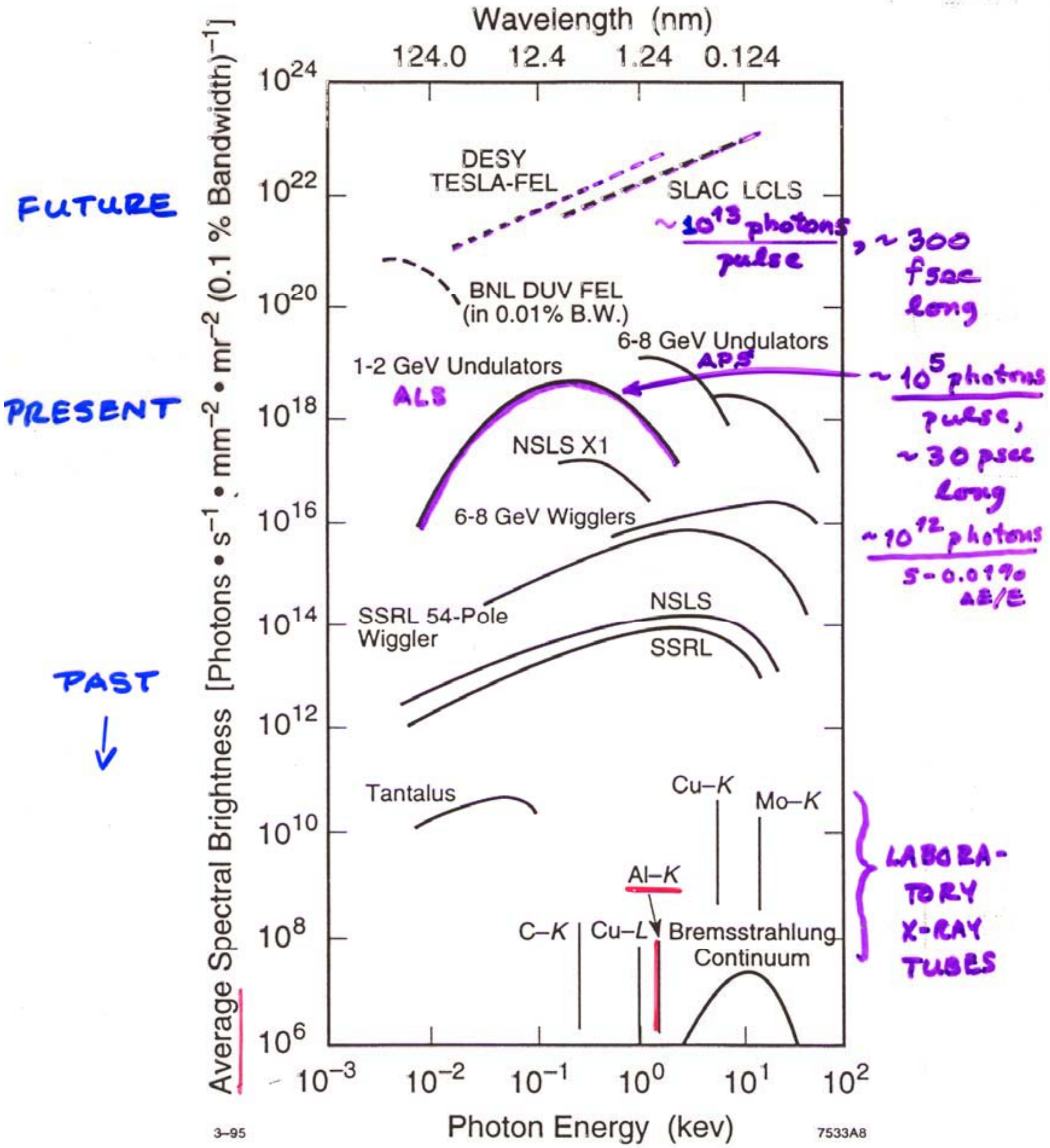


PEEM2, MicroXPS	7.3.1
Diagnostic Beamline	7.2
Surface, Materials Science	7.0.1
Magnetic Spectroscopy, Materials Science	6.3.1
Calibration, Optics Testing, Spectroscopy	6.3.2
X-Ray Microscopy	6.1.2
Femtosecond Phenomena	6.0.2 6.0.1
Polymer STXM	5.3.2
Femtosecond Phenomena	5.3.1
Protein Crystallography	5.0.3 5.0.2 5.0.1
Protein Crystallography	4.2.2
Magnetic Spectroscopy	4.0.2
MERLIN	4.0.3
LIGA	3.3.2
LIGA	3.3.1
Commercial LIGA	3.2.1
Diagnostic Beamline	3.1
National Center for X-Ray Tomography	2.1
IR Spectromicroscopy	1.4.4 1.4.3

7.3.3	SAXS/WAXS
8.0.1	Surface, Materials Science
8.2.1 8.2.2 8.3.1	Protein Crystallography
8.3.2	Tomography
9.0.2	Chemical Dynamics
9.0.1	Coherent Optics/Scattering Experiments
9.3.1	AMO, Materials Science
9.3.2	Chemical, Materials Science
10.0.1	Correlated Materials, AMO
10.3.1	X-Ray Fluorescence Microprobe
10.3.2	MicroXAS
11.0.1	PEEM3
11.0.2	Molecular Environmental Science
11.3.1	Small-Molecule Crystallography
11.3.2	EUV Lithography Mask Inspection
12.0.1	EUV Interferometry, Photoemission
12.0.2	Coherent Soft X-Ray Science
12.2.2	High Pressure
12.3.1	Protein Crystallography
12.3.2	X-Ray Microdiffraction

KEY —— Operational - - - - Under Construction

🟥 Insertion Device Beamlines
🟦 Bend Magnet Beamlines
🟩 Superbend Beamlines



FUTURE

PRESENT

PAST
↓

~10^{13} photons / pulse, ~300 fsec long

APS

ALS

~10^5 photons / pulse, ~30 psec long

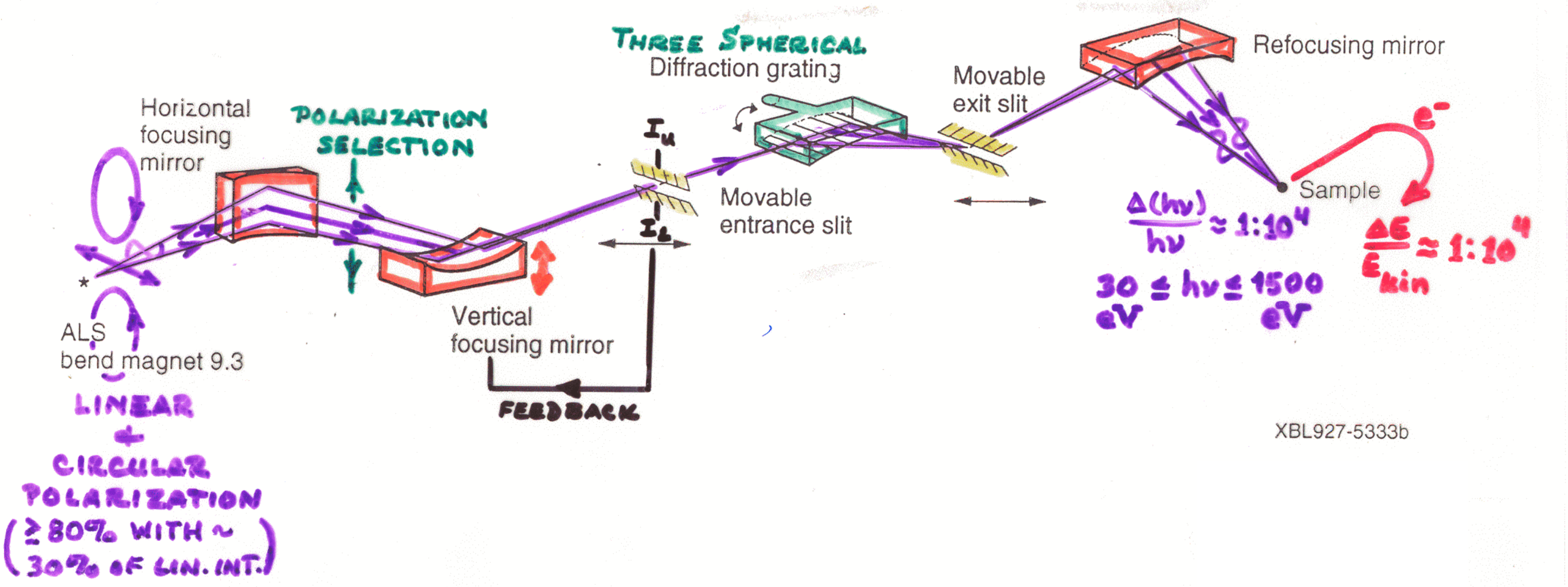
~10^{12} photons / 5-0.01% ΔE/E

LABORATORY X-RAY TUBES

Fig. 2. Average brightness comparisons of the LCLS and other light sources, including proposed FELs at Brookhaven [14] and DESY [15].

"X-Ray Data Booklet"
See Fig. 2.9

Advanced Light Source--
Typical Spectroscopy Beamline Layout



The five ways in which x-rays Interact with Matter:

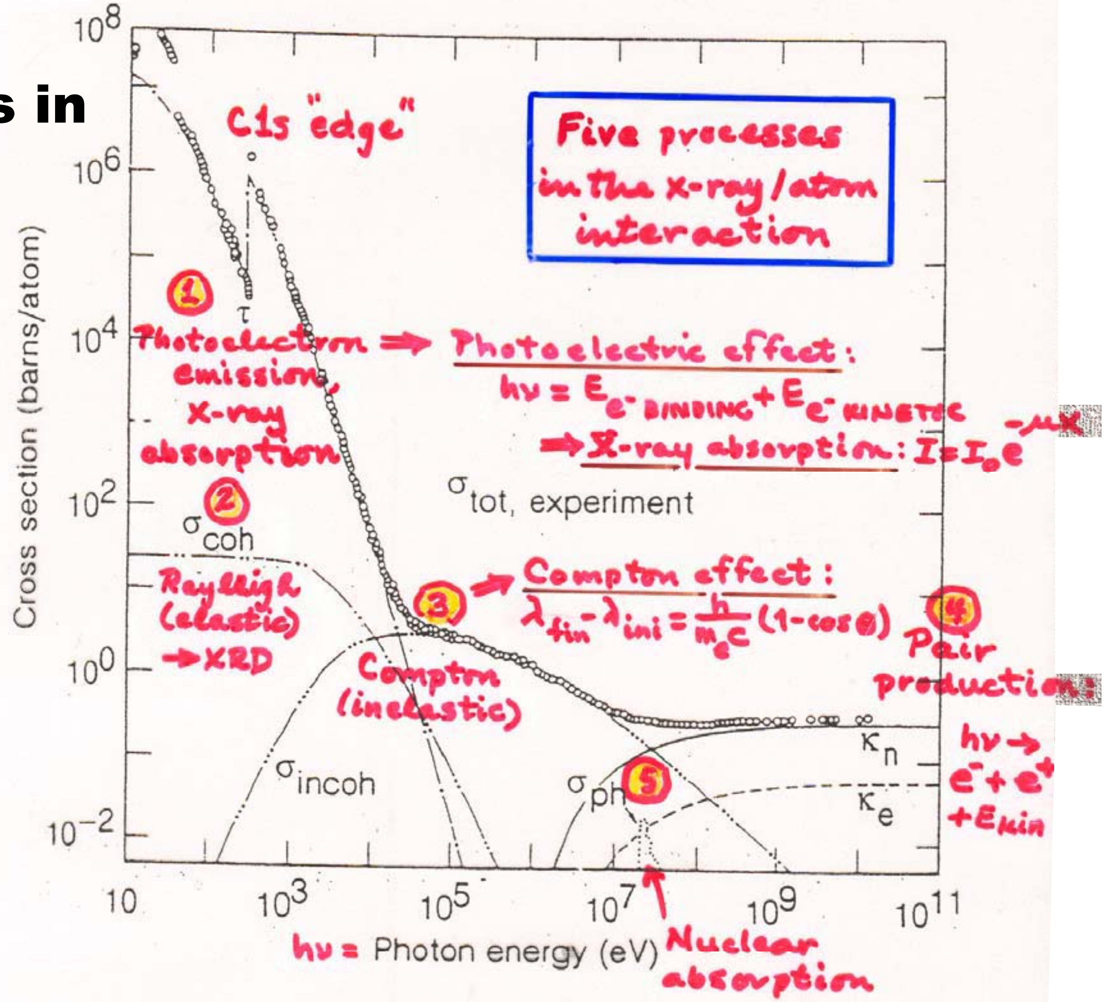
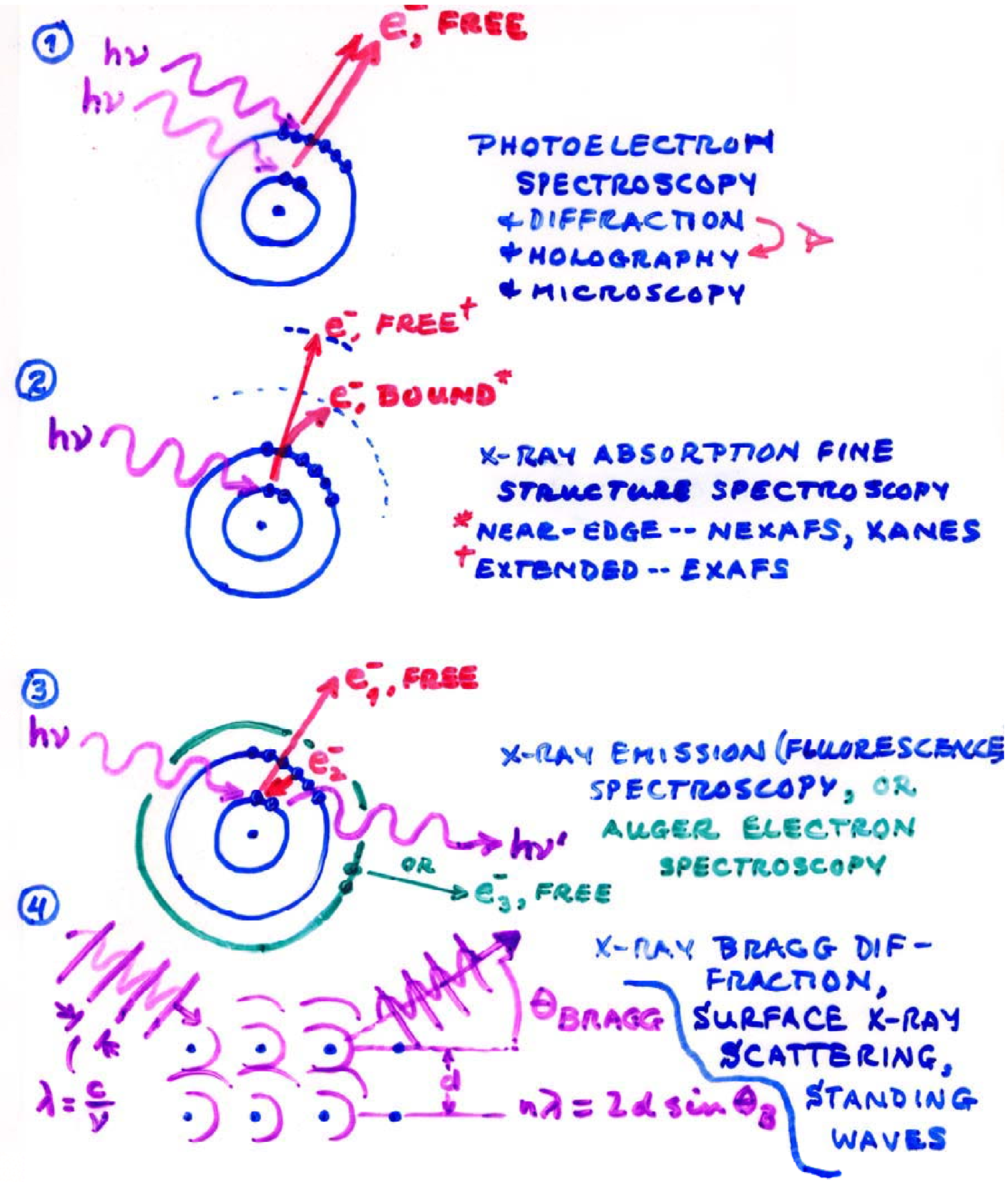


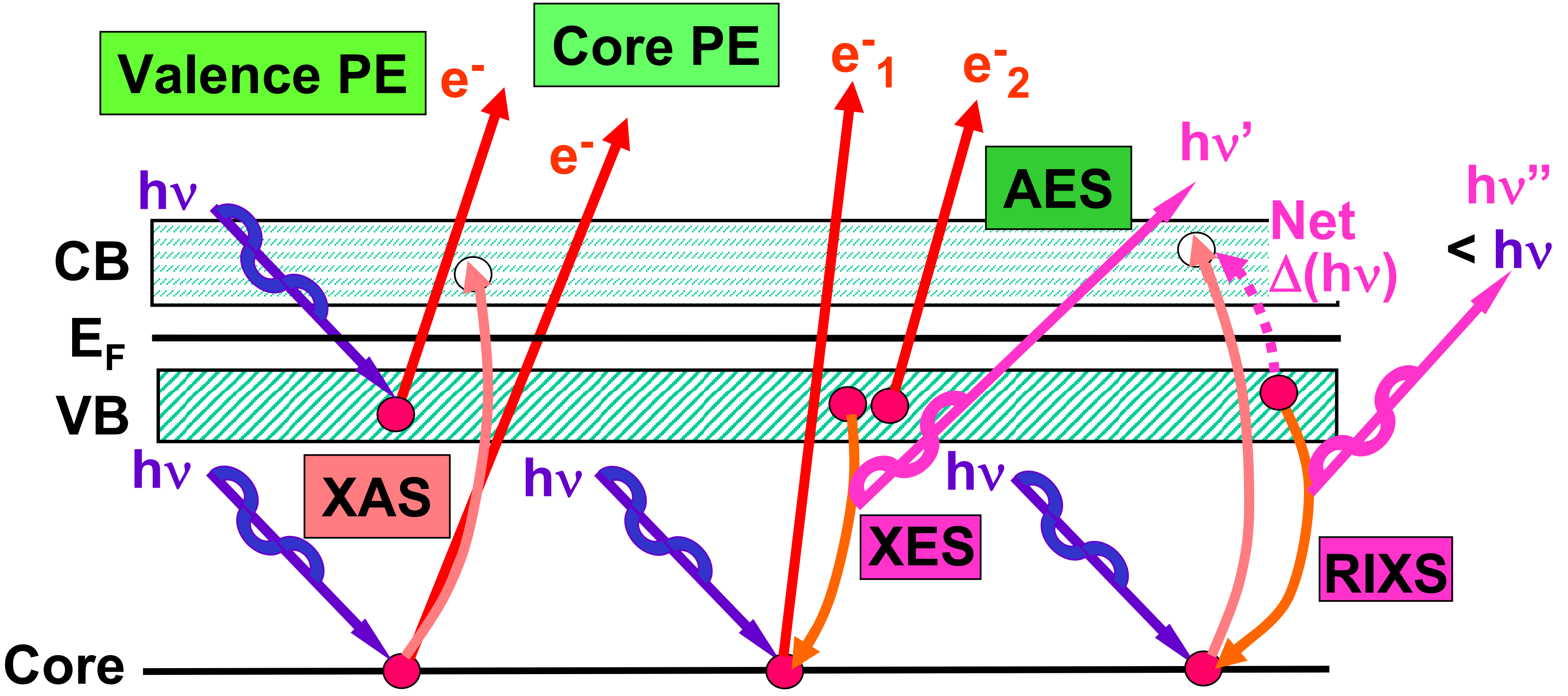
Fig. 3-1. *Total photon cross section σ_{tot} in carbon, as a function of energy, showing the contributions of different processes: τ, atomic photo-effect (electron ejection, photon absorption); σ_{coh}, coherent scattering (Rayleigh scattering—atom neither ionized nor excited); σ_{incoh}, incoherent scattering (Compton scattering off an electron); κ_n, pair production, nuclear field; κ_e, pair production, electron field; σ_{ph}, photonuclear absorption (nuclear absorption, usually followed by emission of a neutron or other particle). (From Ref. 3; figure courtesy of J. H. Hubbell.)*

“X-Ray Data Booklet”
Section 3.1

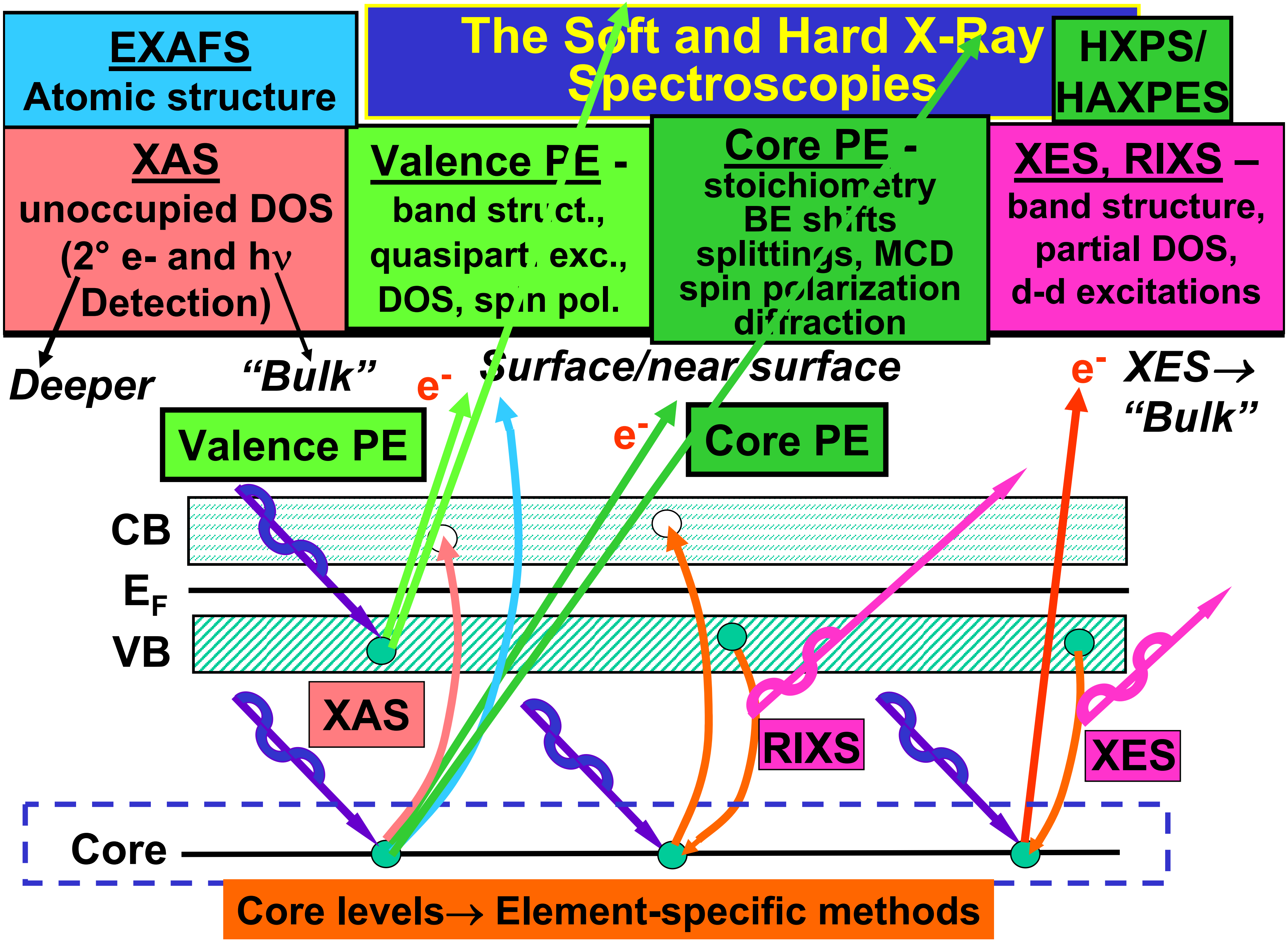
The ultraviolet, soft x-ray, hard x-ray measurements:



The Soft X-Ray Spectroscopies



PE = photoemission = photoelectron spectroscopy
XAS = x-ray absorption spectroscopy
AES = Auger electron spectroscopy
XES = x-ray emission spectroscopy
RIXS = resonant inelastic x-ray scattering / x-ray Raman scatt.



The Soft and Hard X-Ray Spectroscopies

EXAFS
Atomic structure

HXPS/ HAXPES

XAS
unoccupied DOS
(2° e- and hν Detection)

Valence PE -
band struct.,
quasipart. exc.,
DOS, spin pol.

Core PE -
stoichiometry
BE shifts
splittings, MCD
spin polarization
diffraction

XES, RIXS –
band structure,
partial DOS,
d-d excitations

Deeper

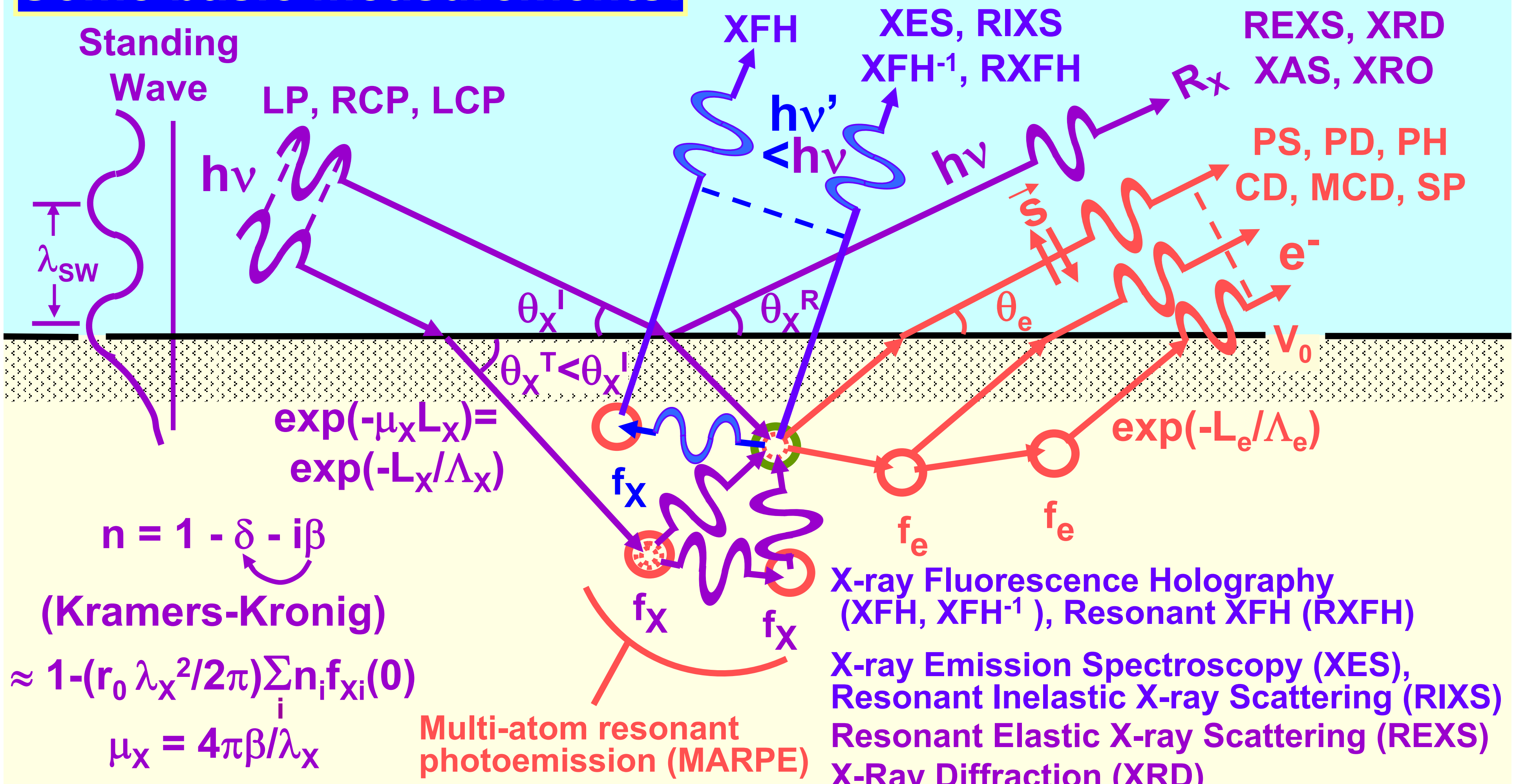
"Bulk"

Surface/near surface

XES→ "Bulk"

Core levels→ Element-specific methods

Some basic measurements:



$$n = 1 - \delta - i\beta$$

(Kramers-Kronig)

$$\approx 1-(r_0\, \lambda_X^2/2\pi)\sum_i n_i f_{Xi}(0)$$

$$\mu_X = 4\pi\beta/\lambda_X$$

$$\theta_X^R = \theta_X^I$$

$$\lambda_{SW} = \lambda_X/(2\sin\theta_X^I)$$

$$\theta_{CRIT}^I = (2\delta)^{1/2}$$

X-ray Fluorescence Holography
(XFH, XFH^{-1}), Resonant XFH (RXFH)

X-ray Emission Spectroscopy (XES),
Resonant Inelastic X-ray Scattering (RIXS)

Resonant Elastic X-ray Scattering (REXS)

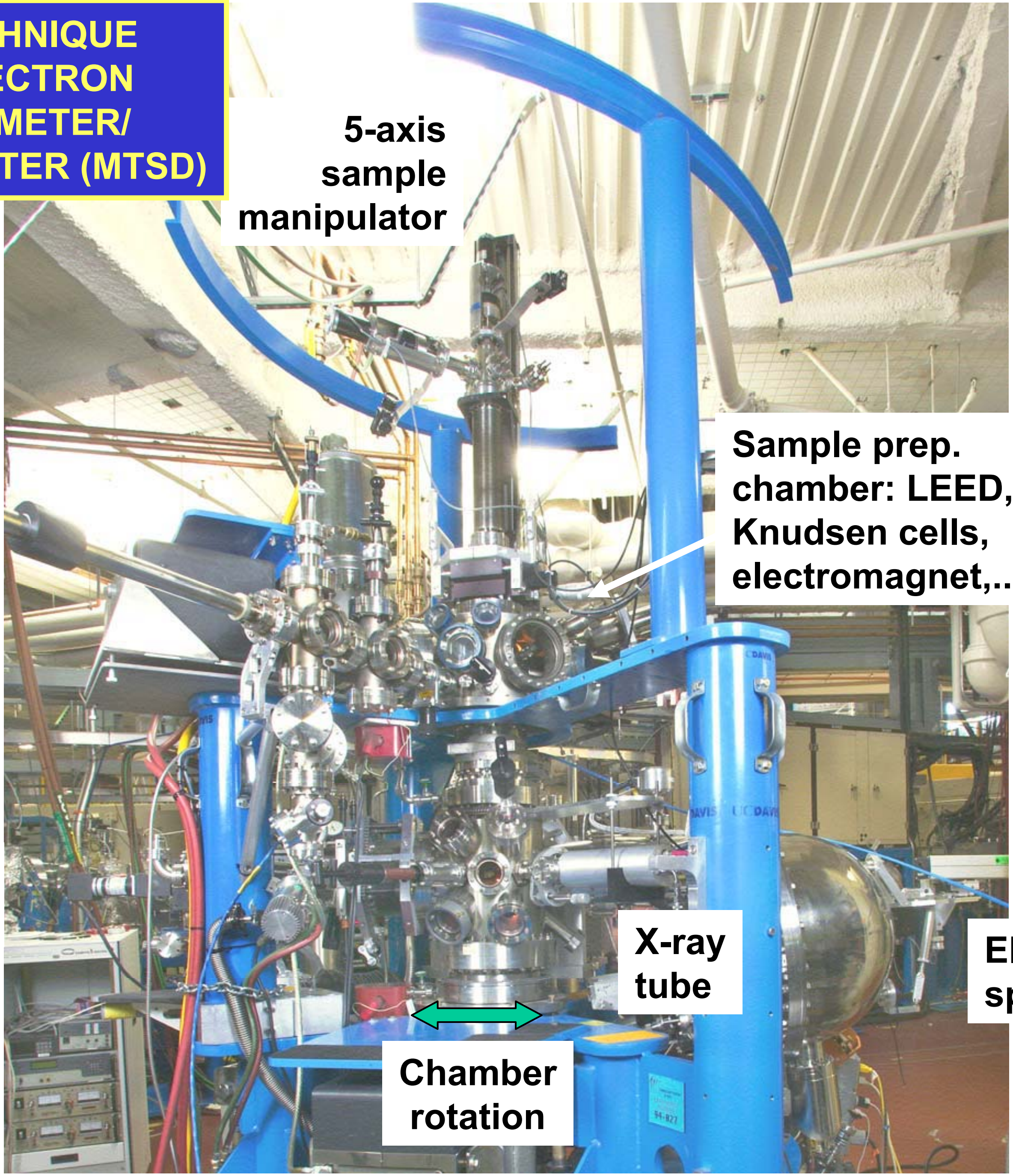
X-Ray Diffraction (XRD)

X-ray Absorption Spectroscopy (XAS)

X-Ray Optical measurements (XRO)

Photoelectron Spectroscopy (PS),
Diffraction (PD), Holography (PH)
+ Circular Dichroism (CD),
Magnetic CD (MCD),
Spin Polarization (SP)

MULTI-TECHNIQUE PHOTOELECTRON SPECTROMETER/ DIFFRACTOMETER (MTSD)



5-axis sample manipulator

Sample prep. chamber: LEED, Knudsen cells, electromagnet,...

Loadlock for sample introduction

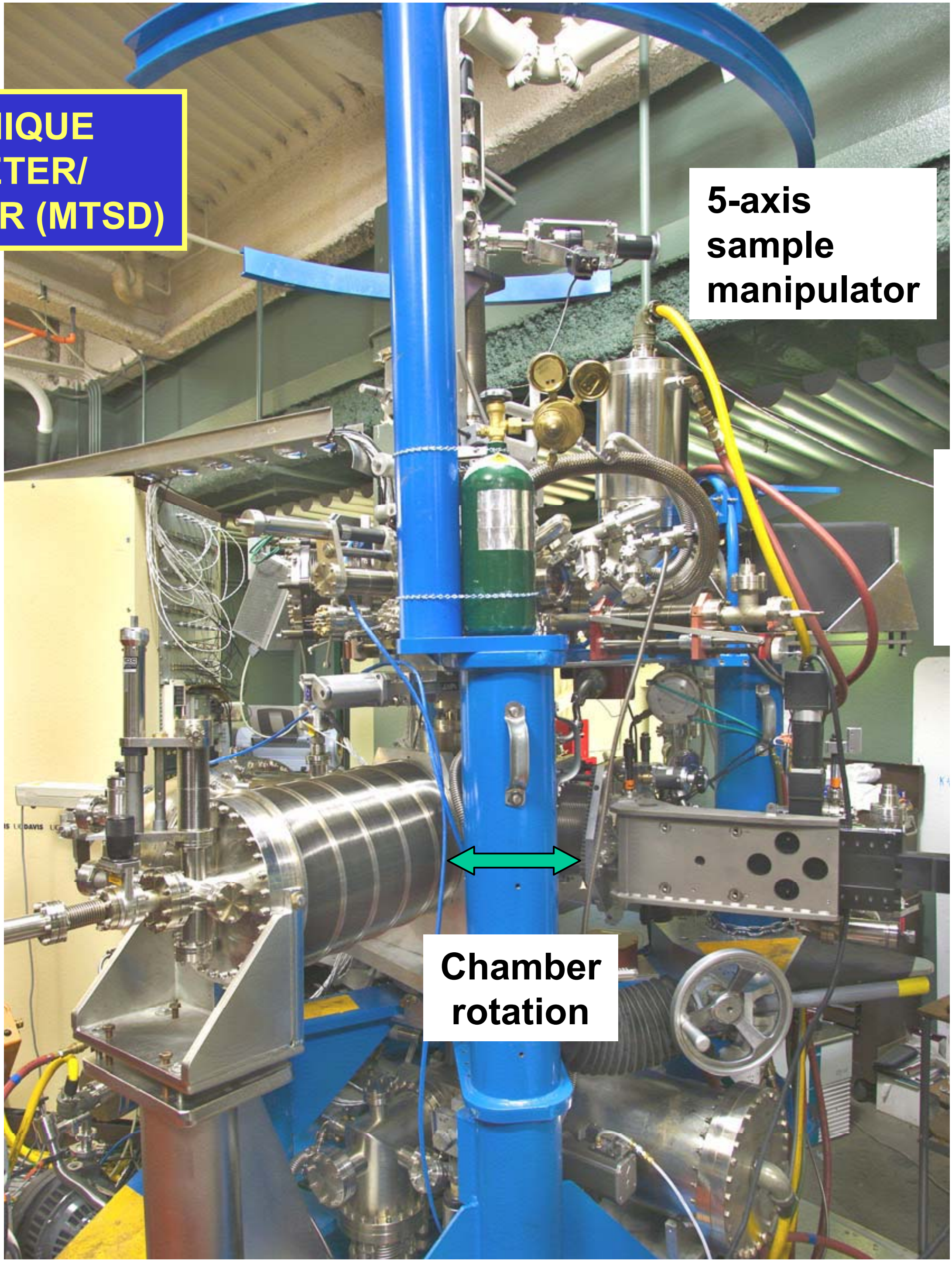
Soft x-ray spectrometer

X-ray tube

Electron spectrometer

Chamber rotation

MULTI-TECHNIQUE SPECTROMETER/ DIFFRACTOMETER (MTSD)



5-axis sample manipulator

Sample prep. chamber: LEED, Knudsen cells, electromagnet,...

Soft x-ray spectrometer

Chamber rotation

ALS

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